

MCX A345/346/355/356/365/366

Mixed-signal Arm Cortex-M33 MCU with 180/240 MHz, up to 1024 KB Flash

Rev. 5 — 10 February 2026

Product data sheet

Features

- Arm® Cortex®-M33 180MHz with 738 CoreMark® (4.10 CoreMark®/MHz) for MCXA345/346
- Arm® Cortex®-M33 240MHz with 984 CoreMark® (4.10 CoreMark®/MHz) for MCXA355/356/365/366
- Up to 1MB Flash, 256KB SRAM, up to 8 KB RAM with ECC
- All RAM can be retained down to Deep Power Down mode
- Internal free running oscillator (FRO180M) with $\pm 1\%$ precision across the full temperature range
- Temperature range: -40 °C to 125 °C
- Down to 78 μ A/MHz Active current, 96 μ A Deep Sleep current, 32 μ A Power Down current, 473 nA Deep Power Down current

Cores

- Arm 32-bit Cortex-M33 CPU, with FPU and DSP extension instruction set and MPU, no Trust Zone

Processing Accelerators

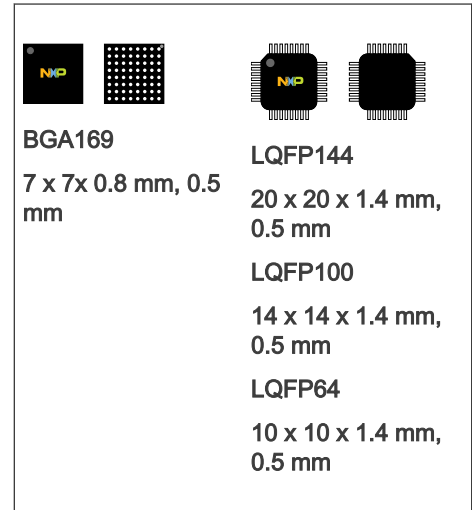
- MAU (Math Accelerate Unit), supports trigonometric, reciprocal, square, square root, sine, cosine and arctan algorithms
- SmartDMA, co-processor for applications such as parallel camera interface and keypad scanning

Memories

- Single-bank Flash: Up to 1024 KB Flash with ECC (support one bit correction and two bits detection)
- Cache Engine with 8 KB RAM
- Up to 256 KB RAM of which 8 KB is shared with cache, configurable as up to 8 KB RAM with ECC (support one bit correction and two bits detection)
- All RAM can be retained down to Deep Power Down mode
- ROM

Security

- EdgeLock Accelerator
 - TRNG
 - PKC (Public Key Cryptography), supports ECC and RSA encryption and decryption
 - SGI (Secure Generic Interface), provides AES256, SHA-2 and key generation/derivation
 - Secure key store with key usage policies (protection of platform integrity, manufacturing and applications keys)
- 128-bit Universal Unique Identifier (UUID) per device in accordance with IETF's RFC4122 version5 specification
- Device lifecycle management
- Flash read/write/execute permission protect by MBC and lockable



- Implicit-protected Flash Region (IFR)
- Security Monitoring
 - Code Watchdog for code flow integrity checking
 - 6x Passive anti tamper detect
 - GLIKEY enforces security checks before allowing a write to security-sensitive register
- Secure Installer for secure manufacturing and IP theft protection in untrusted factory

Low-Power Performance

- **Active**
 - 78 μ A/MHz, in Active Mode (executing while(1) from flash, 3.3 V at 25 °C)
- **Deep Sleep**
 - 96 μ A, 9.01 μ s wake-up (3.3 V at 25 °C)
- **Power Down**
 - 32 μ A, 18.84 μ s wake-up (full SRAM retention, 3.3 V at 25 °C)
- **Deep Power Down**
 - 473 nA, 1.57 ms wake-up (wake-up timer disabled, reset pin enabled, all SRAM off, 3.3 V at 25 °C)

System and Clocks

- 180 MHz free-running oscillator (FRO180M)
 - Can be configured to 240 MHz via software, applicable to MCXA35x and MCXA36x devices only
- 12 MHz free-running oscillator (FRO12M)
- 16 KHz free-running oscillator (FRO16K)
- Up to 50 MHz crystal oscillator
- One PLL
- Hardware and Software Watchdogs
- Asynchronous DMA modules (8-channels)

Communication Interfaces for Connectivity

- 2x LPSPI, 4x LPI2C, 6x LPUART
- 1x I3C
- USB Full-speed (Device/Host) with on-chip FS PHY
- Up to 2x FlexCAN with FD
- FlexIO

HMI

- 4 x 44 segment LCD interface

Advanced Motor Control

- Up to 2x FlexPWM, each FlexPWM has 4 sub-modules, providing 16 complementary outputs for each (no Nanoedge module)
- Up to 2x Quadrature Encoder/Decoder (eQDC)
- 2x AOI (AND/OR/Invert) modules support up to 4 output trigger

Analog

- 4x 16-bit ADC
 - Up to 3.2 Msps in 16-bit mode, and 4 Msps in 12-bit mode
 - Up to 82 ADC Input channels total (depending on the package)
 - Integrated temperature sensor
- 1 x 12-bit DAC
 - Up to 1 Msps
- 3 x High-speed Comparators with 8 input pins and 8-bit DAC as internal reference
 - 1x LPCMP is functional down to Deep Power Down mode
- 4x OPAMP without PGA

Timers

- 5x 32-bit standard general-purpose asynchronous timers/counters (CTimer), each CTimer supports up to 4x capture inputs and 4x compare outputs, 3x PWM outputs. Specific timer events can be selected to generate DMA requests.
- Low power timer
- Frequency measurement timer
- Windowed watchdog timer
- Wake timer
- Micro-tick timer (UTICK)
- OS event timer
- RTC timer without external 32KHz input

General-purpose input/outputs

- Up to 114 GPIOs
- Up to eight 20 mA IO
- 50 MHz IO on P1, P3 and P4
- Up to 29-pin wake-up sources function down to deep power-down mode
- Support 1.71 V~3.6 V IO supply range

Power Management

- Integrated voltage regulator
 - Core LDO, other LDOs
- Operating voltage: 1.71 V to 3.6 V
- IOs: 1.71 V - 3.6 V full-performance

Target Applications

Industrial

- Energy Storage and Management System
- Smart Metering
- Factory Automation
- Industrial HMI
- Mobile Robotics Ecosystem
- Motion Control and Robotics

- Motor Drives
- Brushless DC Motor (BLDC) Control
- Permanent Magnet Synchronous Motor (PMSM) Control

Smart Home

- Home Control Panel
- Major Home Appliances
- Robotic Appliance
- Smart Speaker
- Soundbar
- Gaming Accessories
- Smart Lighting
- Smart Power Socket and Light Switch

Table 1. Ordering Information

Part Number ^{[1][2]}	Marking	Core Speed (MHz)	Flash (KB)	SRAM (KB)	GPIO	Pin Count	Package
MCXA345VPN	MCXA345VPN	180	512	128	114	169	WFBGA
MCXA345VLQ	MCXA345VLQ	180	512	128	114	144	LQFP
MCXA345VLL	MCXA345VLL	180	512	128	86	100	LQFP
MCXA345VLH	MCXA345VLH	180	512	128	55	64	LQFP
MCXA346VPN	MCXA346VPN	180	1024	256	114	169	WFBGA
MCXA346VLQ	MCXA346VLQ	180	1024	256	114	144	LQFP
MCXA346VLL	MCXA346VLL	180	1024	256	86	100	LQFP
MCXA346VLH	MCXA346VLH	180	1024	256	55	64	LQFP
MCXA355VPN	MCXA355VPN	240	512	128	114	169	WFBGA
MCXA355VLQ	MCXA355VLQ	240	512	128	114	144	LQFP
MCXA355VLL	MCXA355VLL	240	512	128	86	100	LQFP
MCXA355VLH	MCXA355VLH	240	512	128	55	64	LQFP
MCXA356VPN	MCXA356VPN	240	1024	256	114	169	WFBGA
MCXA356VLQ	MCXA356VLQ	240	1024	256	114	144	LQFP
MCXA356VLL	MCXA356VLL	240	1024	256	86	100	LQFP
MCXA356VLH	MCXA356VLH	240	1024	256	55	64	LQFP
MCXA365VPN	MCXA365VPN	240	512	128	114	169	WFBGA
MCXA365VLQ	MCXA365VLQ	240	512	128	114	144	LQFP
MCXA365VLL	MCXA365VLL	240	512	128	83	100	LQFP
MCXA365VLH	MCXA365VLH	240	512	128	52	64	LQFP

Table continues on the next page...

Table 1. Ordering Information ...continued

Part Number [1][2]	Marking	Core Speed (MHz)	Flash (KB)	SRAM (KB)	GPIO	Pin Count	Package
MCXA366VPN	MCXA366VPN	240	1024	256	114	169	WFBGA
MCXA366VLQ	MCXA366VLQ	240	1024	256	114	144	LQFP
MCXA366VLL	MCXA366VLL	240	1024	256	83	100	LQFP
MCXA366VLH	MCXA366VLH	240	1024	256	52	64	LQFP

[1] As marked on package

[2] To confirm current availability of orderable part numbers, go to <http://www.nxp.com> and perform a part number search.

Table 2. Device Revision Number

Device Mask Set Number	JTAG ID Register[PRN]
0P89K	0x0726802B

Table 3. Related Resources

Type	Description	Resource
Fact Sheet	The Fact Sheet gives overview of the product key features and its uses.	MCXA3xxFS
Reference Manual	The Reference Manual contains a comprehensive description of the structure and function (operation) of a device.	MCXAP144M180FS60RM
Data Sheet	The Data Sheet includes electrical characteristics and signal connections.	MCXAP144M180FS60DS
Chip Errata	The chip mask set Errata provides additional or corrective information for a particular device mask set.	MCXA366VLQ_0P89K
Package drawing	Package dimensions are provided in package drawings.	- WFBGA169: 98ASA02230D - LQFP144: 98ASS23177W - LQFP100: 98ASS23308W - LQFP64: 98ASS23234W
Software development kit	MCUXpresso SDK. An open source software development kit (SDK) built specifically for your processor and evaluation board selections.	http://www.nxp.com/mcuxpresso

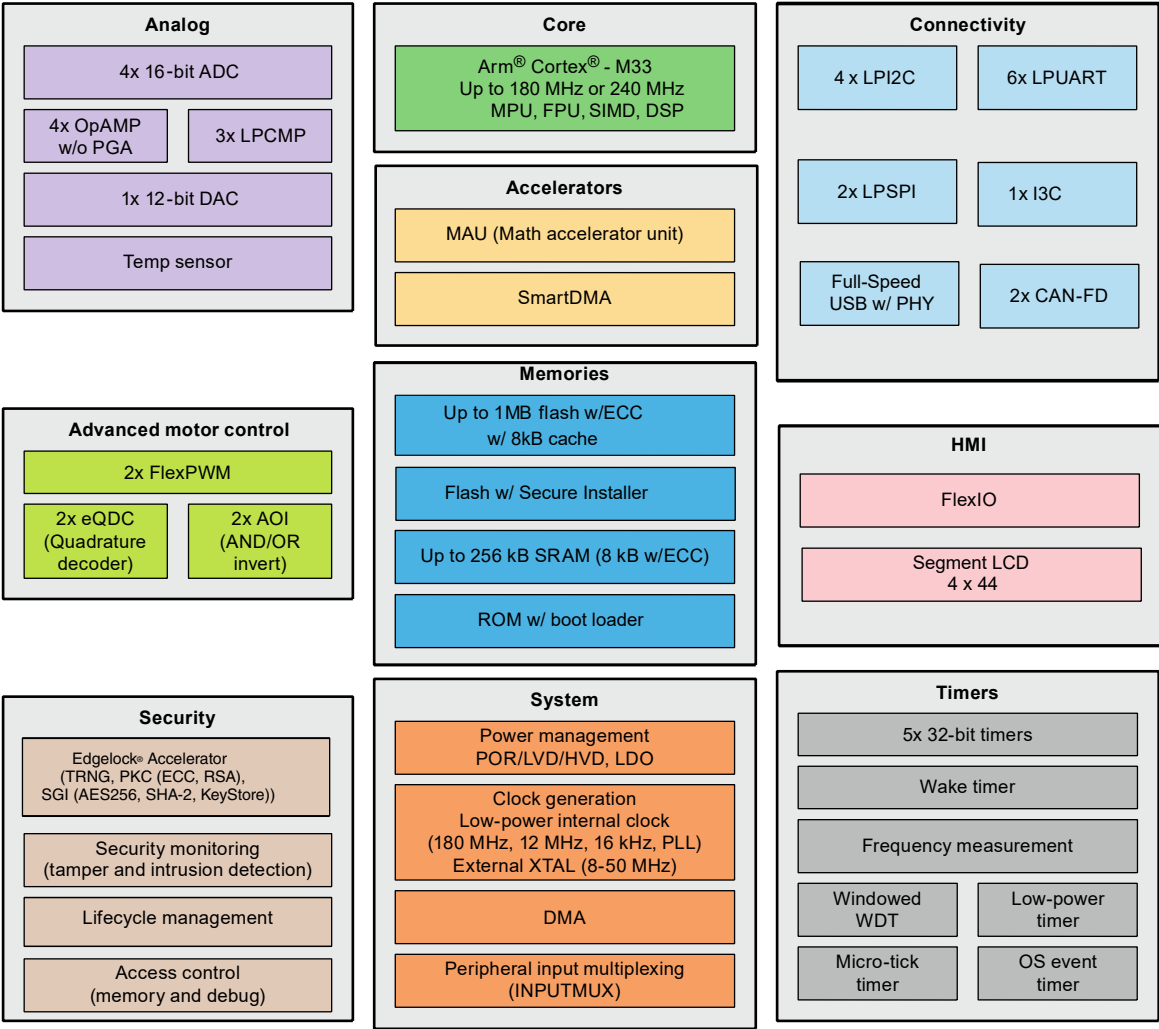


Figure 1. Block Diagram

Note: Secure Installer is protected by ROM from read, write and execute.

Note: Secure Installer cannot be reprogrammed and no secure binary file (SB3.1) will be supported after SI is erased.

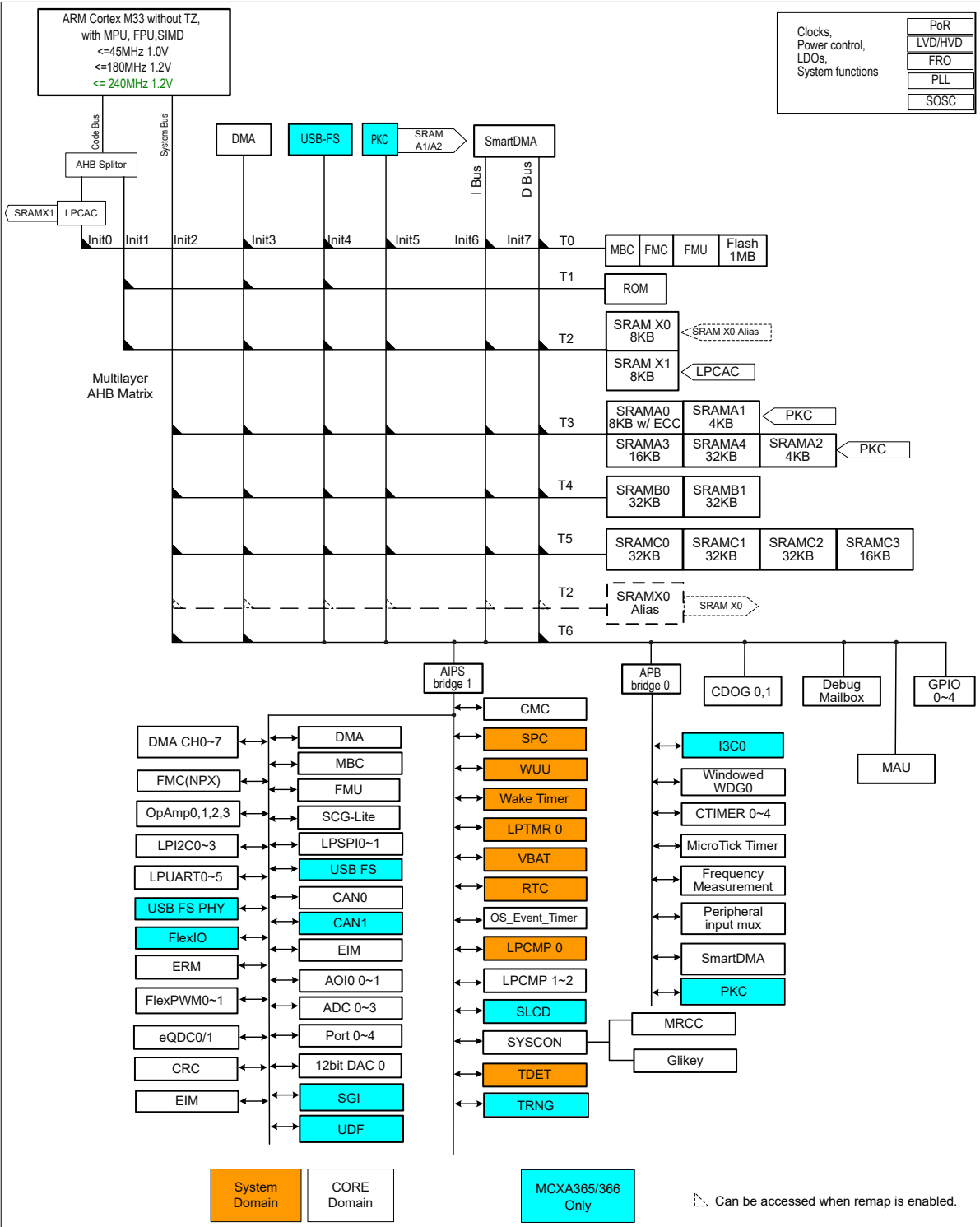


Figure 2. Bus Architecture

1 Feature Comparison

Table 4. Feature Comparison

		MCX A345	MCX A346	MCX A355	MCX A356	MCX A365	MCX A366
Core Platform	Core Cortex-M33	180 MHz		240 MHz			
	Cache	8 KB					
	DMA	8 Channels					
	Wakeup unit(WUU)	Yes					
	Pheripheral input multiplexing(INPUTMUX)	Yes					
Processing Accelerators	MAU	Yes					
	SmartDMA	Yes					
Clock	Fast internal reference clock FRO180M	180 MHz		180 MHz (or configure to 240 MHz)			
	Slow internal reference clock FRO12M	12 MHz					
	Low power internal reference clock FRO16K	16.384 kHz					
	System oscillator with external crystal(SOSC)	8 - 50 MHz					
	PLL	Yes					
Memory	Flash 512KB version include 8KB CMPA 1024KB version include 8KB CMPA MCXA36x include 56KB for Secure Installer	512 KB	1024 KB	512 KB	1024 KB	512 KB	1024 KB
	SRAM 128 KB including 8 kB with ECC 256 KB including 8 KB with ECC and include 8KB SRAM shared with Cache	128 KB	256 KB	128 KB	256 KB	128 KB	256 KB
	Error injection module (EIM)	Yes					
	Error recording module (ERM)	Yes					
Security	Lifecycle management (LC)	Yes					
	Read out protection (ROP)	Yes					
	Memory block checker (MBC)	Yes					
	GLIKEY	Yes					

Table continues on the next page...

Table 4. Feature Comparison...continued

			MCX A345	MCX A346	MCX A355	MCX A356	MCX A365	MCX A366
	UUID		128-bit					
	Code watchdog (CDOG)		2					
	Cyclic redundancy check (CRC)		1					
	Secure key management							
	AES-256 ^[1]		No				Yes	
	SHA ^[1]		No				Yes	
	PKC ^[1]		No				Yes	
	TRNG ^[1]		No				Yes	
	AGDET ^[1]		No				Yes	
	Debug control ^[1]		No				Yes	
	Secure installer ^[1]		No				Yes	
	Passive anti tamper pin	WFBGA169(PN)	6					
		LQFP144(LQ)	6					
		LQFP100(LL)	4					
LQFP64(LH)		2						
Communication Interfaces	LPUART		6					
	LPSPi		2					
	LPI2C		4					
	I3C		0				1	
	FlexCAN		1x CAN FD				2x CAN FD	
	USB		No				Host/Device	
	FlexIO		0				1	
HMI	Segment LCD		No				4x 44	
Analog	Low power comparator(LPCMP)		3					
	ADC		4					
	ADC input pin	WFBGA169(PN)	82					
		LQFP144(LQ)	82					
		LQFP100(LL)	64				62	
		LQFP64(LH)	38				35	
	DAC		1					
	OpAmp(w/o PGA)	WFBGA169(PN)	4					
		LQFP144(LQ)	4					

Table continues on the next page...

Table 4. Feature Comparison...continued

			MCX A345	MCX A346	MCX A355	MCX A356	MCX A365	MCX A366
		LQFP100(LL)	4					
		LQFP64(LH)	3				2	
Motor Control	FlexPWM ^[2]		2					
	AND/OR INVERT (AOI)		2					
	Quadrature decoder (eQDC)		2					
Timer	32-bit timer(Ctimer)		5					
	Low power timer(LPTMR)		1					
	Micro-tick timer(UTICK)		1					
	OS event timer		1					
	Windowed watchdog timer (WWDT)		1					
	Frequency measurement (FREQME)		1					
	Wake timer		1					
	RTC ^[3]		1					
IO	Independent I/O supply ^[4]		No					
	5V tolerant IO ^[5]		2					
	High drive IO (20 mA) ^[6]		Up to 8					
	50 MHz I/O ^[7]		Up to 22					
Packages ^[8]	GPIO/Wakeup Pin	WFBGA169(PN)	114/29					
		LQFP144(LQ)	114/29					
		LQFP100(LL)	86/25				83/25	
		LQFP64(LH)	55/19				52/19	
Temperature range			-40 °C to 125 °C					

[1] This feature described in Security Reference Manuel (SRM), user can request SRM document from nxp.com under NDA.

[2] There are 4 sub-modules for each FlexPWM module.

[3] RTC only support counter mode, no dedicate VBAT and not support external 32.768KHz crystal.

[4] MCX A345/A346 does not support 1.2 V IO power supply.

[5] P3_27, P3_28 are 5V tolerant I/Os

[6] P1_8,P1_9,P1_30,P1_31,P3_1,P3_0,P0_16,P0_17 are High Drive I/Os

[7] 50 MHz I/Os are located on P1, P3, P4 ports

[8] Show the package types and GPIO numbers and Wakeup pin numbers

2 Ratings

2.1 Thermal handling ratings

Table 5. Thermal handling ratings

Symbol	Description	Min	Typ	Max	Unit	Condition
TSTG	Storage temperature ^[1]	-55	—	150	°C	—
TSDR	Solder temperature, lead-free ^[2]	—	—	260	°C	—

[1] Determined according to JEDEC Standard JESD22-A103, High Temperature Storage Life.

[2] Determined according to IPC/JEDEC Standard J-STD-020, Moisture/Reflow Sensitivity Classification for Nonhermetic Solid State Surface Mount Devices.

2.2 Moisture handling ratings

Table 6. Moisture handling ratings

Symbol	Description	Min	Typ	Max	Unit	Condition
MSL	Moisture sensitivity level ^[1]	—	—	3	—	—

[1] Determined according to IPC/JEDEC Standard J-STD-020, Moisture/Reflow Sensitivity Classification for Nonhermetic Solid State Surface Mount Devices.

2.3 ESD handling ratings

Table 7. ESD handling ratings

Description	Rating	Unit	Notes
Electrostatic discharge voltage, human body model	+/-2000	V	[1]
Electrostatic discharge voltage, charged-device model	+/-500	V	[2]
Electrostatic discharge voltage, charged device model (corner pins)	+/-750	V	[2]
Latch-up immunity level (Class II at 110 °C junction temperature)	Immunity Level A	—	[3]

[1] Determined according to ANSI/ESDA/JEDEC Standard JS-001-2023, For Electrostatic Discharge Sensitivity Testing, Human Body Model (HBM) - Device Level.

[2] Determined according to ANSI/ESDA/JEDEC Standard JS-002-2022, For Electrostatic Discharge Sensitivity Testing, Charged Device Model (CDM) - Device Level.

[3] Determined according to JEDEC Standard JESD78, IC Latch-Up Test.

2.4 Voltage and current maximum ratings

The table below shows the absolute minimum and maximum rating for the device. If the values are violated, device could be damaged. See Voltage and current for operating requirements, and Terminology and guidelines for definitions of terms.

Table 8. Voltage and current maximum ratings

Symbol	Description	Min	Typ	Max	Unit	Condition
VDD	Supply voltage for Port 0, Port 1, Port 2, Port 3 and Port 4	-0.3	—	3.63	V	—
VDD_ANA	Supply voltage for ADC	-0.3	—	3.63	V	—
VDD_USB	Supply voltage for USB analog	-0.3	—	3.63	V	—

Table continues on the next page...

Table 8. Voltage and current maximum ratings...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
VUSB0_Dx	USB0_DP and USB0_DM input voltage	-0.3	—	3.63	V	—
VDIO	Digital input voltage	-0.3	—	VDD + 0.3	V	—
VDIO_5VTOL	Digital input voltage for 5V tolerant I/O pins	-0.3	—	min(VDD + 3.6V, 5.5V)	V	—
VAIO	Analog input voltage ^[1]	-0.3	—	VDD_ANA + 0.3	V	—
IDD	Digital supply current ^[2]	—	—	100	mA	—
ID	Maximum current single pin limit (digital output pins)	-25	—	25	mA	—

[1] Analog pins are defined as pins that do not have an associated general-purpose I/O port function.
[2] This limit is per supply pin. It includes all power pins, including VDD, VDD_ANA.

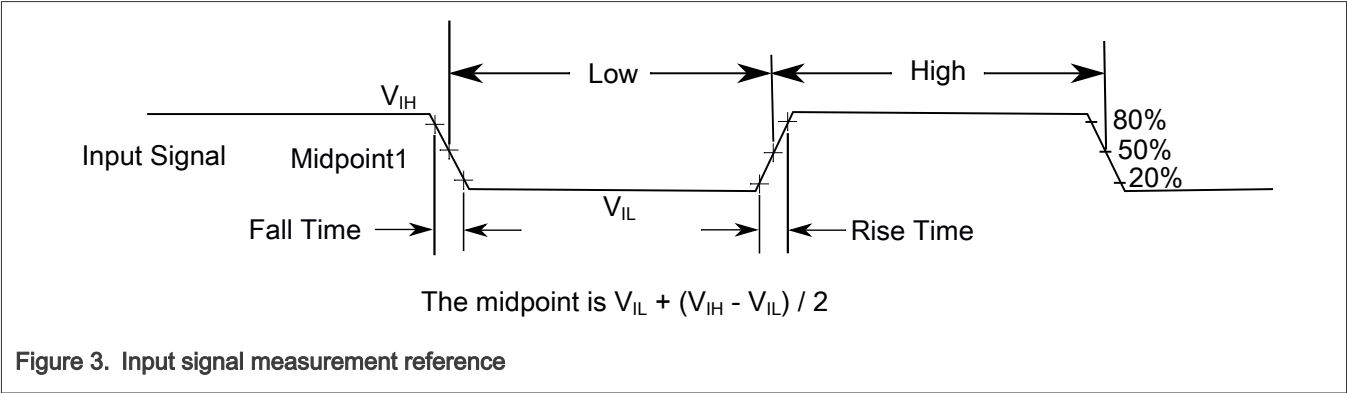
2.5 Required Power-On-Reset (POR) Sequencing

- VDD and VDD_ANA must be same voltage

3 General

3.1 AC electrical characteristics

Unless otherwise specified, propagation delays are measured from the 50% to the 50% point, and rise and fall times are measured at the 20% and 80% points, as shown in the following figure.



3.2 Nonswitching electrical specifications

3.2.1 Voltage and current operating requirement

Table 9. Voltage and current operating requirement

Symbol	Description	Min	Typ	Max	Unit	Condition
VDD	Supply Voltage for IO, LDO, Flash, and LPCMP	1.71	—	3.6	V	—
VDD_ANA	Supply voltage for ADC	VDD - 0.1	—	VDD + 0.1	V	—
VSS - VSS_ANA	VSS-to-VSS_ANA differential voltage	-0.1	—	0.1	V	—
VIH	Input high voltage	$0.7 \times VDD$	—	—	V	$1.71 \text{ V} \leq VDD \leq 3.6 \text{ V}$
VIH_5VTOL	Input high voltage of 5V tolerant IO	$0.7 \times VDD$	—	—	V	$1.71 \text{ V} \leq VDD \leq 3.6 \text{ V}$
VIL	Input low voltage	—	—	$0.3 \times VDD$	V	$1.71 \text{ V} \leq VDD \leq 3.6 \text{ V}$
VIL_5VTOL	Input low voltage of 5 V tolerant IO	—	—	$0.3 \times VDD$	V	$1.71 \text{ V} \leq VDD \leq 3.6 \text{ V}$
VHYS	Input hysteresis	$0.1 \times VDD$	—	—	V	—
VHYS_5VTOL	Input hysteresis of 5 V tolerant IO	$0.1 \times VDD$	—	—	V	—
IICIO	IO pin DC injection current — per pin ^[1]	-3	—	—	mA	$VIN < VSS - 0.3 \text{ V}$ (negative current injection)
IICIO	IO pin DC injection current — per pin ^[1]	—	—	3	mA	$VIN > VDD + 0.3 \text{ V}$ (positive current injection)
IICcont	Contiguous pin DC injection current —regional limit, includes sum of negative injection currents of 16 contiguous pins	-25	—	—	mA	Negative current injection
IICcont	Contiguous pin DC injection current —regional limit, includes sum of negative injection currents of 16 contiguous pins	—	—	25	mA	Positive current injection
VODPU	Open drain pullup voltage level ^[2]	VDD	—	VDD	V	—

[1] All I/O pins are internally clamped to VSS and VDD through an ESD protection diode. If VIN is greater than VDD_MIN(=VSS-0.3 V) or is less than VDD_MAX(=VDD+ 0.3 V), then there is no need to provide current limiting resistors at the pads. If this limit cannot be observed, then a current limiting resistor is required. The negative DC injection current limiting resistor is calculated as $R = (-0.3 - VIN)/(-IICIO_{min})$. The positive injection current limiting resistor is calculated as $R = (VIN - VDD_MAX)/IICIO_{max}$. The actual resistor should be an order of magnitude higher to tolerate transient voltages

[2] Open drain outputs must be pulled to whichever supply voltage corresponds to that IO, VDD as appropriate.

3.2.2 HVD, LVD, and POR operating requirements

The device includes low-voltage detection (LVD) and high-voltage detection (HVD) power supervisor circuits for following power supplies:

- VDD

3.2.2.1 VDD supply HVD, LVD, and POR Operating Requirements

Table 10. VDD supply HVD, LVD, and POR Operating Requirements

Symbol	Description	Min	Typ	Max	Unit	Condition
VHVDH_VDD	VDD Rising high-voltage detect threshold (HVD assertion)	3.730	3.810	3.890	V	—
VHVDH_HYS_VDD	VDD High-voltage inhibit reset/recover hysteresis	—	38	—	mV	—
VLVDH_VDD	VDD Falling low-voltage detect threshold (LVD assertion) - high range	2.567	2.619	2.673	V	—
VLVDH_HYS_VDD	VDD Low-voltage inhibit reset/recover hysteresis - high range	—	27	—	mV	—
VLVDL_VDD	VDD Falling low-voltage detect threshold (LVD assertion) - low range	1.618	1.651	1.684	V	—
VLVDL_HYS_VDD	VDD Low-voltage inhibit reset/recover hysteresis - low range	—	16	—	mV	—

3.2.3 Voltage and current operating behaviors

Table 11. Voltage and current operating behaviors

Symbol	Description	Min	Typ	Max	Unit	Condition
VOH	Output high voltage — Normal drive strength ^[1]	VDD – 0.5	—	—	V	2.7 V ≤ VDD ≤ 3.6 V, IOH = 4 mA
VOH	Output high voltage — Normal drive strength ^[1]	VDD – 0.5	—	—	V	1.71 V ≤ VDD < 2.7 V, IOH = 2.5 mA
VOH	Output high voltage — High drive strength ^{[1][2]}	VDD – 0.5	—	—	V	2.7 V ≤ VDD ≤ 3.6 V, IOH = 6 mA
VOH	Output high voltage — High drive strength ^{[1][2]}	VDD – 0.5	—	—	V	1.71 V ≤ VDD < 2.7 V, IOH = 3.75 mA
IOHT	Output high current total for all ports	—	—	100	mA	—
VOL	Output low voltage — Normal drive strength ^{[1][3]}	—	—	0.5	V	2.7 V ≤ VDD ≤ 3.6 V, IOL = 4 mA
VOL	Output low voltage — Normal drive strength ^{[1][3]}	—	—	0.5	V	1.71 V ≤ VDD < 2.7 V, IOL = 2.5 mA
VOL	Output low voltage — High drive strength ^{[1][2][3]}	—	—	0.5	V	2.7 V ≤ VDD ≤ 3.6 V, IOL = 6 mA
VOL	Output low voltage — High drive strength ^{[1][2][3]}	—	—	0.5	V	1.71 V ≤ VDD < 2.7 V, IOL = 3.75 mA

Table continues on the next page...

Table 11. Voltage and current operating behaviors...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
IOLT	Output low current total for all ports	—	—	100	mA	—
IIN	Input leakage current (per pin) for full temperature range [4]	—	0.02	1	μA	—
IIN	Input leakage current (per pin) at 25 °C [4]	—	0.001	0.025	μA	—
IOZ	Hi-Z (off-state) leakage current (per pin)	—	0.02	1	μA	—
RPU	Internal pullup resistors	33	50	75	kΩ	—
RPU (I3C)	Internal pullup resistors [5]	(VDD - 0.27 V)/3 mA	1.75	—	kΩ	—
RPD	Internal pulldown resistors	33	50	75	kΩ	—
RHPU	High-resistance pullup option (PCR _x [PV] = 1) [6]	0.67	—	1.5	MΩ	—
RHPD	High-resistance pulldown option (PCR _x [PV] = 1) [6]	0.67	—	1.5	MΩ	—
VBG	Bandgap voltage reference voltage	0.98	1.0	1.02	V	—

[1] For the HD pads, when setting DSE1=1, the IOH/IOL are four times higher at the same VOH/VOL.

[2] RESET_B pins are always configured in high drive mode

[3] Open drain outputs must be pulled to VDD

[4] Measured at VDD = 3.6 V.

[5] Only I3C pins support this option

[6] Only tamper pins and RESET_B pins support this option.

3.2.4 On-chip regulator electrical specifications

3.2.4.1 LDO_CORE electrical specifications

Table 12. LDO_CORE electrical specifications

Symbol	Description	Min	Typ	Max	Unit	Condition
VDD	LDO_CORE input supply voltage	1.71	—	3.6	V	—
ILOAD	LDO_CORE max load current	—	—	96	mA	Over drive strength
ILOAD	LDO_CORE max load current	—	—	2	mA	Low drive strength
IDD	LDO_CORE current consumption	—	—	250	μA	Over drive strength
IDD	LDO_CORE current consumption	—	—	500	nA	Low drive strength
IINRUSH	LDO_CORE inrush current	—	—	10	mA	—

3.2.5 Power mode transition operating behaviours

All specifications in the following table assume this clock configuration:

- CPU clock = 180 MHz
- AHB clock = 180 MHz
- Clock source = FRO180M

3.2.5.1 Power mode transition operating behaviors

Table 13. Power mode transition operating behaviors

Symbol	Description	Min	Typ	Max	Unit	Condition
tPOR	After a POR event, amount of time to execution of the first instruction (measured from the point where VDD reach 1.8V) across the operating temperature range of the chip. ^{[1][2]}	—	2.94	2.98	ms	—
tSLEEP	Sleep → Active ^{[1][2][3][4]}	—	0.42	0.46	μs	—
tDSLEEP	Deep Sleep → Active ^{[1][2][3][4]}	—	9.01	10.31	μs	—
tPWDN	Power Down → Active ^{[1][2][3][5]}	—	18.84	22.15	μs	—
tDPWDN	Deep Power Down → Active ^{[1][2][3][4]}	—	1.57	1.59	ms	—

[1] Max value is mean+3 × sigma of tested values at the worst case of ambient temperature range and VDD 1.71 V to 3.6 V. Max values are based on characterization but not covered by test limits in production.

[2] Typical value is the average of values tested at Temperature=25 °C and VDD=3.3 V

[3] WFE used for low-power mode entry

[4] SPC->LPWKUP_DELAY[LPWKUP_DELAY] = 0x00 and the Core voltage level is configured as same level for Active and Low Power mode (SPC->ACTIVE_CFG[CORELDO_VDD_LVL]=SPC->LP_CFG[CORELDO_VDD_LVL] = 01b).

[5] SPC->LPWKUP_DELAY[LPWKUP_DELAY] = 0x5B and the Core voltage level is configured as different level for Active and Low Power mode (SPC->ACTIVE_CFG[CORELDO_VDD_LVL] = 01b for Active mode, SPC->LP_CFG[CORELDO_VDD_LVL] = 00b for Low Power mode)

3.2.6 Power consumption operating behaviors

The maximum values stated in the following sections represent characterized results equivalent to the mean plus three times the standard deviation (mean + 3 sigma).

3.2.6.1 Power consumption operating behaviors

When calculating the total MCU current consumption the following considerations should be made:

- Specifications below only include power for the MCU itself including VDD, VDD_ANA.
- VDD_USB current draw are not included
- On top of the device's IDD current consumption, external loads applied to pins of the device need to be considered

Table 14. Power consumption operating behaviors

Symbol	Description	Condition ^[1]	Typ	Unit
IDD_ACT_MD_1 ^[2]	1. CPU_CLK = 45 MHz from FRO180M. VDD_CORE = 1.0V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled; Flash is configured to LP mode; Cache enabled. 3. While(1) loop executing from internal flash.	25 °C	3.32	mA
		105 °C	5.78	mA
		125 °C	7.98	mA

Table continues on the next page...

Table 14. Power consumption operating behaviors...continued

Symbol	Description	Condition ^[1]	Typ	Unit
IDD_ACT_MD_2	1. CPU_CLK = 45 MHz from FRO180M. VDD_CORE = 1.0V from LDO_CORE Normal Drive. 2. All peripheral clocks enabled; Cache enabled. 3. While(1) loop executing from internal flash.	25 °C	3.68	mA
		105 °C	6.14	mA
		125 °C	8.38	mA
IDD_ACT_MD_CM_1	1. CPU_CLK = 45 MHz from FRO180M. VDD_CORE = 1.0V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled; Flash is configured to LP mode; Cache enabled. 3. Coremark executing from internal flash.	25 °C	4.09	mA
		105 °C	6.55	mA
		125 °C	8.74	mA
IDD_ACT_MD_CM_2	1. CPU_CLK = 45 MHz from FRO180M. VDD_CORE = 1.0V from LDO_CORE Normal Drive. 2. All peripheral clocks enabled; Cache enabled. 3. Coremark executing from internal flash.	25 °C	4.45	mA
		105 °C	6.93	mA
		125 °C	9.15	mA
IDD_ACT_OD_1	1. CPU_CLK = 180 MHz from FRO180M. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled; Flash is configured to LP mode; Cache enabled. 3. While(1) loop executing from internal flash.	25 °C	13.76	mA
		105 °C	17.32	mA
		125 °C	20.43	mA
IDD_ACT_OD_2	1. CPU_CLK = 180 MHz from FRO180M. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks enabled; Cache enabled. 3. While(1) loop executing from internal flash.	25 °C	15.13	mA
		105 °C	18.89	mA
		125 °C	21.99	mA
IDD_ACT_OD_CM_1	1. CPU_CLK = 180 MHz from FRO180M. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled; Flash is configured to LP mode; Cache enabled. 3. Coremark executing from internal flash.	25 °C	17.79	mA
		105 °C	21.45	mA
		125 °C	24.61	mA
IDD_ACT_OD_CM_2	1. CPU_CLK = 180 MHz from FRO180M. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks enabled; Cache enabled. 3. Coremark executing from internal flash.	25 °C	18.88	mA
		105 °C	22.79	mA
		125 °C	25.94	mA
IDD_ACT_OD_3	1. CPU_CLK = 240 MHz from System PLL. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled; Cache enabled. 3. While(1) loop executing from internal flash.	25 °C	18.82	mA
		105 °C	22.66	mA
		125 °C	26.06	mA
IDD_ACT_OD_4	1. CPU_CLK = 240 MHz from System PLL. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks enabled; Cache enabled. 3. While(1) loop executing from internal flash.	25 °C	20.1	mA
		105 °C	24.02	mA
		125 °C	27.46	mA

Table continues on the next page...

Table 14. Power consumption operating behaviors...continued

Symbol	Description	Condition ^[1]	Typ	Unit
IDD_ACT_OD_CM_3	1. CPU_CLK = 240 MHz from System PLL. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled; Cache enabled. 3. Coremark executing from internal flash.	25 °C	24.08	mA
		105 °C	28.11	mA
		125 °C	31.58	mA
IDD_ACT_OD_CM_4	1. CPU_CLK = 240 MHz from System PLL. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks enabled; Cache enabled. 3. Coremark executing from internal flash.	25 °C	25.37	mA
		105 °C	29.45	mA
		125 °C	32.97	mA
IDD_ACT_OD_5	1. CPU_CLK = 240 MHz from FRO180M in 240 MHz mode. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled; Cache enabled. 3. While(1) loop executing from internal flash.	25 °C	17.58	mA
		105 °C	21.87	mA
		125 °C	25.55	mA
IDD_ACT_OD_6	1. CPU_CLK = 240 MHz from FRO180M in 240 MHz mode. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled; Cache enabled. 3. While(1) loop executing from internal flash.	25 °C	23.31	mA
		105 °C	27.79	mA
		125 °C	31.61	mA
IDD_ACT_OD_CM_5	1. CPU_CLK = 240 MHz from FRO180M in 240 MHz mode. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled; Cache enabled. 3. While(1) loop executing from internal flash.	25 °C	18.94	mA
		105 °C	23.31	mA
		125 °C	27.03	mA
IDD_ACT_OD_CM_6	1. CPU_CLK = 240 MHz from FRO180M in 240 MHz mode. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled; Cache enabled. 3. While(1) loop executing from internal flash.	25 °C	24.69	mA
		105 °C	29.21	mA
		125 °C	33.02	mA
IDD_SLEEP_OD_1	1. CPU_CLK = OFF; SYSTEM_CLK = 180 MHz from FRO180M. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled. 3. Core in WFI.	25 °C	8.08	mA
		105 °C	11.68	mA
		125 °C	14.75	mA
IDD_SLEEP_OD_2	1. CPU_CLK = OFF; SYSTEM_CLK = 180 MHz from FRO180M. VDD_CORE = 1.2 V from LDO_CORE Normal Drive. 2. All peripheral clocks enabled. 3. Core in WFI.	25 °C	9.16	mA
		105 °C	12.69	mA
		125 °C	15.78	mA
IDD_SLEEP_MD_1	1. CPU_CLK = OFF; SYSTEM_CLK = 45 MHz from FRO180M. VDD_CORE = 1.0V from LDO_CORE Normal Drive. 2. All peripheral clocks disabled. 3. Core in WFI.	25 °C	2.16	mA
		105 °C	4.59	mA
		125 °C	6.81	mA
IDD_SLEEP_MD_2	1. CPU_CLK = OFF; SYSTEM_CLK = 45 MHz from FRO180M. VDD_CORE = 1.0V from	25 °C	2.41	mA
		105 °C	4.85	mA

Table continues on the next page...

Table 14. Power consumption operating behaviors...continued

Symbol	Description	Condition ^[1]	Typ	Unit
	LDO_CORE Normal Drive. 2. All peripheral clocks enabled. 3. Core in WFI.	125 °C	7.07	mA
IDD_SLEEP_MD_3	1. CPU_CLK = OFF; SYSTEM_CLK = 12 MHz from FRO12M. VDD_CORE = 1.0 V from LDO_CORE Low Drive. 2. All peripheral clocks disabled. 3. Core in WFI.	25 °C	0.579	mA
		105 °C	3.04	mA
		125 °C	5.32	mA
IDD_DEEP_SLEEP_OD_1	1. CPU_CLK = OFF; SYSTEM_CLK = OFF; SLOW_CLK = OFF; VDD_CORE = 1.2 V from LDO_CORE Normal Drive; FRO12M disabled. 2. All peripheral clocks disabled; all on-chip SRAM in deep sleep. 3. Core in WFI.	25 °C	542.27	μA
		105 °C	3000	μA
		125 °C	5130	μA
IDD_DEEP_SLEEP_MD_1	1. CPU_CLK = OFF; SYSTEM_CLK = OFF; SLOW_CLK = OFF; VDD_CORE = 1.0 V from LDO_CORE Low Drive; FRO12M disabled. 2. All peripheral clocks disabled; all on-chip SRAM in deep sleep. 3. Core in WFI.	25 °C	96.02	μA
		105 °C	1850	μA
		125 °C	3470	μA
IDD_DEEP_SLEEP_MD_2	1. CPU_CLK = OFF; SYSTEM_CLK = OFF; SLOW_CLK = OFF; VDD_CORE = 1.0 V from LDO_CORE Low Drive; FRO12M enabled. 2. All peripheral clocks disabled; all on-chip SRAM in deep sleep. 3. Core in WFI.	25 °C	155.29	μA
		105 °C	1910	μA
		125 °C	3530	μA
IDD_POWER_DOWN_1	1. CPU_CLK = SYSTEM_CLK = OFF; VDD_CORE = 0.6V retention voltage from LDO_CORE Low Drive 2. All RAM retained; FRO16K disabled. 3. Core in WFI.	25 °C	31.95	μA
		105 °C	915.38	μA
		125 °C	1810	μA
IDD_DEEP_POWER_DOWN_1	1. CPU_CLK = SYSTEM_CLK = OFF; All VDD_CORE domains power off. 2. All RAM OFF; Wake timer disabled, FRO16K disabled. 3. Core in WFI.	25 °C	0.473	μA
		105 °C	7.95	μA
		125 °C	18.62	μA
IDD_DEEP_POWER_DOWN_2	1. CPU_CLK = SYSTEM_CLK = OFF; All VDD_CORE domains power off. 2. All RAM OFF; Wake timer enabled, FRO16K enabled. 3. Core in WFI.	25 °C	0.646	μA
		105 °C	8.15	μA
		125 °C	18.76	μA
IDD_DEEP_POWER_DOWN_3	1. CPU_CLK = SYSTEM_CLK = OFF; All VDD_CORE domains power off. 2. All RAM retained; Wake timer enabled, FRO16K enabled. 3. Core in WFI.	25 °C	3.4	μA
		105 °C	83.13	μA
		125 °C	183.28	μA
IDD_DEEP_POWER_DOWN_4	1. CPU_CLK = SYSTEM_CLK = OFF; All VDD_CORE domains power off. 2. RAM X0/X1/B0/B1, A0~A4 retained; Wake timer enabled, FRO16K enabled. 3. Core in WFI.	25 °C	2.29	μA
		105 °C	50.43	μA
		125 °C	110.66	μA
IDD_DEEP_POWER_DOWN_5	1. CPU_CLK = SYSTEM_CLK = OFF; All VDD_CORE domains power off. 2. RAM	25 °C	1.66	μA
		105 °C	33.49	μA

Table continues on the next page...

Table 14. Power consumption operating behaviors...continued

Symbol	Description	Condition ^[1]	Typ	Unit
	X0/X1/B0/B1/A0 retained; Wake timer enabled, FRO16K enabled. 3. Core in WFI.	125 °C	74.02	μA
IDD_DEEP_POWER_DOWN_6	1. CPU_CLK = SYSTEM_CLK = OFF; All VDD_CORE domains power off. 2. RAM A0 retained; Wake timer enabled, FRO16K enabled. 3. Core in WFI.	25 °C	0.849	μA
		105 °C	11.41	μA
		125 °C	25.7	μA
IDD_DEEP_POWER_DOWN_7	1. CPU_CLK = SYSTEM_CLK = OFF; All VDD_CORE domains power off. 2. RAM X0/X1/B0/B1 retained; Wake timer enabled, FRO16K enabled. 3. Core in WFI.	25 °C	1.55	μA
		105 °C	30.39	μA
		125 °C	67.28	μA
IDD_DEEP_POWER_DOWN_8	1. CPU_CLK = SYSTEM_CLK = OFF; All VDD_CORE domains power off. 2. RAM A0 retained; RTC enabled, Wake timer disabled, FRO16K enabled. 3. Core in WFI.	25 °C	0.842	μA
		105 °C	11.44	μA
		125 °C	25.76	μA
IDD_DEEP_POWER_DOWN_9	1. CPU_CLK = SYSTEM_CLK = OFF; All VDD_CORE domains power off. 2. RAM A0 retained; RTC enabled, Wake timer enabled, FRO16K enabled. 3. Core in WFI.	25 °C	0.855	μA
		105 °C	11.43	μA
		125 °C	25.73	μA
IDD_DEEP_POWER_DOWN_10	1. CPU_CLK = SYSTEM_CLK = OFF; All VDD_CORE domains power off. 2. All RAM OFF; RTC enabled, Wake timer disabled, FRO16K enabled. 3. Core in WFI.	25 °C	0.651	μA
		105 °C	8.11	μA
		125 °C	18.77	μA
IDD_DEEP_POWER_DOWN_11	1. CPU_CLK = SYSTEM_CLK = OFF; All VDD_CORE domains power off. 2. All RAM OFF; RTC enabled, Wake timer disabled, FRO16K enabled, Digital Tamper (TDET) enabled. 3. Core in WFI.	25 °C	0.727	μA
		105 °C	8.21	μA
		125 °C	18.83	μA

[1] Ambient temperature

[2] MD middle drive, core voltage is 1.0V. OD over drive, core voltage is 1.2V

3.2.7 EMC radiated emissions operating behaviors

EMC measurements to IC-level IEC standards are available from NXP on request.

3.2.8 Designing with radiated emissions in mind

To find application notes that provide guidance on designing your system to minimize interference from radiated emissions:

1. Go to nxp.com.
2. Perform a keyword search for “EMC design”.

3.2.9 Capacitance attributes

Table 15. Capacitance attributes

Symbol	Description	Min	Typ	Max	Unit	Condition
CIN_A	Input capacitance: analog pins	—	—	7	pF	—
CIN_D	Input capacitance: digital pins	—	—	7	pF	—

3.3 Switching specifications

3.3.1 Device clock specs

Table 16. Device clock specs

Symbol	Description	Min	Typ	Max	Unit	Condition
fCPU	CPU clock (CPU_CLK)For MCXA355/356/365/366	—	—	240	MHz	Over drive (OD) mode, VDD_CORE = 1.2 V
fSYSTEM	System clock (SYSTEM_CLK)For MCXA355/356/365/366	—	—	240	MHz	Over drive (OD) mode, VDD_CORE = 1.2 V
fSLOW	Slow clock (SLOW_CLK)For MCXA355/356/365/366	—	—	40	MHz	Over drive (OD) mode, VDD_CORE = 1.2 V
fCPU	CPU clock (CPU_CLK)For MCXA345/346	—	—	180	MHz	Over drive (OD) mode, VDD_CORE = 1.2 V
fSYSTEM	System clock (SYSTEM_CLK)For MCXA345/346	—	—	180	MHz	Over drive (OD) mode, VDD_CORE = 1.2 V
fSLOW	Slow clock (SLOW_CLK)For MCXA345/346	—	—	30	MHz	Over drive (OD) mode, VDD_CORE = 1.2 V
fCPU	CPU clock (CPU_CLK)	—	—	45	MHz	Middle drive (MD) mode VDD_CORE = 1.0 V
fSYSTEM	SYSTEM clock (SYSTEM_CLK)	—	—	45	MHz	Middle drive (MD) mode VDD_CORE = 1.0 V
fSLOW	Slow clock (SLOW_CLK)	—	—	7.5	MHz	Middle drive (MD) mode VDD_CORE = 1.0 V

3.3.2 General switching specifications

These general-purpose specifications apply to all signals configured for GPIO, LPUART, LPI2C, LPI3C, LPSP1 functions.

3.3.2.1 General switching specifications

Note: Refer to attached pinout spreadsheet.

Table 17. General switching specifications

Symbol	Description	Min	Typ	Max	Unit	Condition
—	GPIO pin interrupt pulse width — Synchronous path ^[1]	1.5	—	—	SYSTEM clock cycles	The synchronous and asynchronous timing must be met.
—	GPIO pin interrupt pulse width — Asynchronous path	150	—	—	ns	—
—	GPIO pin interrupt pulse width — Asynchronous path	50	—	—	ns	—
—	External RST pin interrupt pulse width — Asynchronous path ^[2]	330	—	—	ns	This is the shortest pulse that is guaranteed to be recognized.
—	GPIO pin interrupt pulse width — Asynchronous path ^[2]	16	—	—	ns	—
—	Port rise/fall time for slow I/O pins ^{[3][4]}	1	—	7	ns	$2.7 \leq VDD \leq 3.6$ V, Fast slew rate (SRE = 0; DSE = 0)
—	Port rise/fall time for slow I/O pins ^{[3][4]}	3.5	—	15	ns	$2.7 \leq VDD \leq 3.6$ V, Slow slew rate (SRE = 1; DSE = 0)
—	Port rise/fall time for slow I/O pins ^{[3][4]}	1	—	7	ns	$1.71 \leq VDD < 2.7$ V, Fast slew rate (SRE = 0; DSE = 1)
—	Port rise/fall time for slow I/O pins ^{[3][4]}	3.5	—	25	ns	$1.71 \leq VDD < 2.7$ V, Slow slew rate (SRE = 1; DSE = 1)
—	Port rise/fall time for slow I/O pins, 5V Tolerant ^{[3][4]}	1	—	7	ns	$2.7 \leq VDD \leq 3.6$ V, Fast slew rate (SRE = 0; DSE = 0)
—	Port rise/fall time for slow I/O pins, 5V Tolerant ^{[3][4]}	3.5	—	15	ns	$2.7 \leq VDD \leq 3.6$ V, Slow slew rate (SRE = 1; DSE = 0)
—	Port rise/fall time for slow I/O pins, 5V Tolerant ^{[3][4]}	1	—	7	ns	$1.71 \leq VDD < 2.7$ V, Fast slew rate (SRE = 0; DSE = 1)
—	Port rise/fall time for slow I/O pins, 5V Tolerant ^{[3][4]}	3.5	—	25	ns	$1.71 \leq VDD < 2.7$ V, Fast slew rate (SRE = 1; DSE = 1)
—	Port rise/fall time for medium I/O pins ^{[5][6]}	0.8	—	4	ns	$2.7 \leq VDD \leq 3.6$ V, Fast slew rate (SRE = 0; DSE = 0)

Table continues on the next page...

Table 17. General switching specifications...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
—	Port rise/fall time for medium I/O pins ^{[5][6]}	1	—	7	ns	$2.7 \leq VDD \leq 3.6$ V, Slow slew rate (SRE = 1; DSE = 0)
—	Port rise/fall time for medium I/O pins ^{[5][6]}	0.8	—	4	ns	$1.71 \leq VDD < 2.7$ V, Fast slew rate (SRE = 0; DSE = 1)
—	Port rise/fall time for medium I/O pins ^{[5][6]}	1	—	7	ns	$1.71 \leq VDD < 2.7$ V, Slow slew rate (SRE = 1; DSE = 1)
—	HD pins ^[7]	2.2	—	7	ns	$2.7 \leq VDD \leq 3.6$ V, Normal drive, fast slew rate (SRE = 0; DSE = 0)
—	Port rise/fall time for HD pins ^[7]	1	—	7	ns	$2.7 \leq VDD \leq 3.6$ V, Normal drive (DSE = 0), fast slew rate (SRE = 0)
—	Port rise/fall time for HD pins ^[7]	3.5	—	15	ns	$2.7 \leq VDD \leq 3.6$ V, Normal drive (DSE = 0), slow slew rate (SRE = 1)
—	Port rise/fall time for HD pins ^[7]	1	—	7	ns	$1.71 \leq VDD < 2.7$ V, High drive (DSE = 1), Fast slew rate (SRE = 0)
—	Port rise/fall time for HD pins ^[7]	3.5	—	25	ns	$1.71 \leq VDD < 2.7$ V, High drive (DSE = 1), Slow slew rate (SRE = 1)
—	RST pins ^[4]	3	—	8	ns	$2.7 \leq VDD \leq 3.6$ V
—	RST pins ^[4]	3.6	—	20	ns	$1.71 \leq VDD < 2.7$ V

[1] The synchronous and asynchronous timing must be met.

[2] This is the shortest pulse that is guaranteed to be recognized

[3] For the HD I/O pins, setting DSE1 = 1 will support the same rise/fall time at 4x the load capacitance. For the 5VTOL I/O pins, setting DSE1=1 will support the same fall time at 2x the load capacitance, but the rise time will increase due to the increased loading

[4] Load is 25 pF.

[5] Assumes default values in CALIB1 and CALIB0 in PORTS

[6] 25 pF lumped load

[7] Load is 25 pF for DSE=0. Load is 100 pF for DSE=2 or DSE=3. Drive strength and slew rate are configured using PORTx_PCRn[DSE1], PORTx_PCRn[DSE], and PORTx_PCRn[SRE].

3.4 Thermal specifications

3.4.1 Thermal operating requirements

Table 18. Thermal operating requirements

Symbol	Description	Min	Typ	Max	Unit	Condition
TA	Ambient temperature ^[1]	-40	25	125	°C	—
TJ	Die junction temperature ^{[2][3][4]}	—	—	125	°C	—

[1] The device may operate at maximum TA rating as long as TJ maximum of 125 °C is not exceeded. The simplest method to determine TJ is: $TJ = TA + R_{\theta JA} \times \text{chip power dissipation}$.

[2] The device operating specification is not guaranteed beyond 125 °C TJ.

[3] The maximum operating requirement applies to all chapters unless otherwise specifically stated.

[4] Operating at maximum conditions for extended periods may affect device reliability. Refer to Product Lifetime Usage Estimates application note (AN14194)

3.4.2 Thermal attributes

Table 19. Thermal attributes

Rating	Board Type ^[1]	Symbol	LQFP64	LQFP100	LQFP144	WFBGA169	Unit
Junction to Ambient Thermal Resistance ^[2]	2s2p	$R_{\theta JA}$	34.5	45.3	41.9	48.2	°C/W
Junction-to-Top of Package Thermal Characterization Parameter ^[2]	2s2p	Ψ_{JT}	2.2	0.7	1.3	1.6	°C/W
Junction to Case Top Thermal Resistance ^[3]	1s	$R_{\theta JC}$	18.9	15.4	14.5	19.2	°C/W

[1] Thermal test board meets JEDEC specification for this package (JESD51-9 for non-leaded package(BGA) while JESD 51-7 is for leaded package(QFN,QFP,SOIC))

[2] Determined in accordance to JEDEC JESD51-2A natural convection environment. Thermal resistance data in this report is solely for a thermal performance comparison of one package to another in a standardized specified environment. It is not meant to predict the performance of a package in an application-specific environment

[3] Junction-to-Case thermal resistance determined using an isothermal cold plate. For QFN package, case temperature refers to the exposed pad surface temperature at the package bottom side dead centre. For QFP/BGA packages, case temperature refers to the mold surface temperature at the package top side dead centre..

4 Peripheral operating requirements and behaviors

4.1 Core modules

4.1.1 JTAG Debug Interface Timing

The following table gives the JTAG specifications in debug interface mode.

Table 20. JTAG Debug Interface Timing

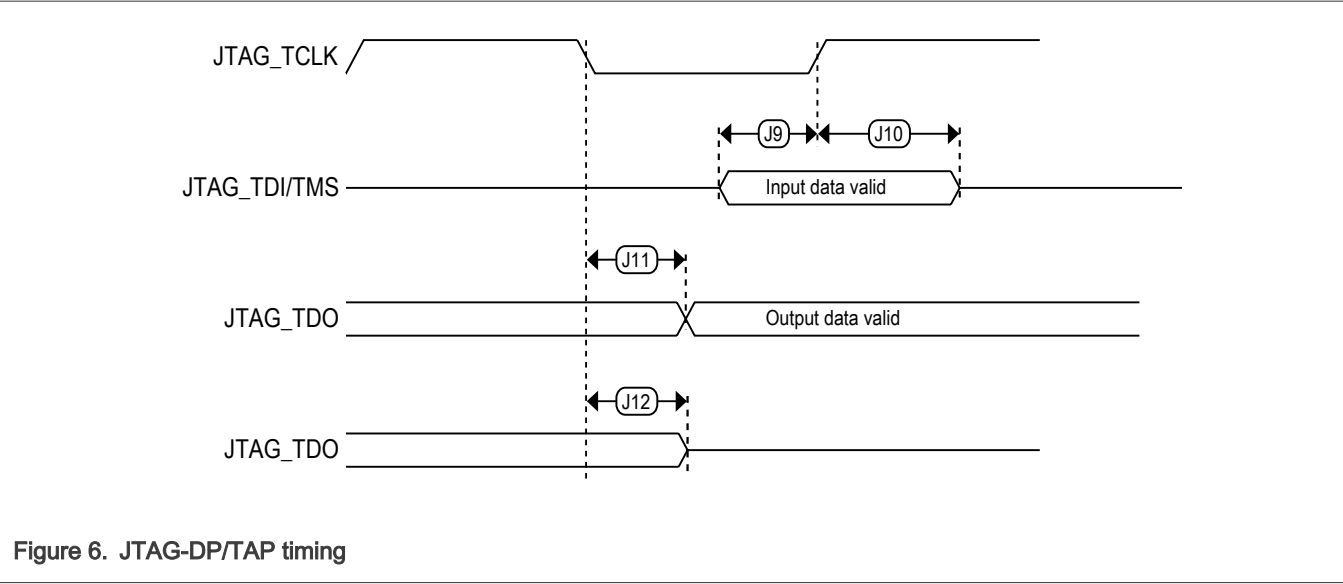
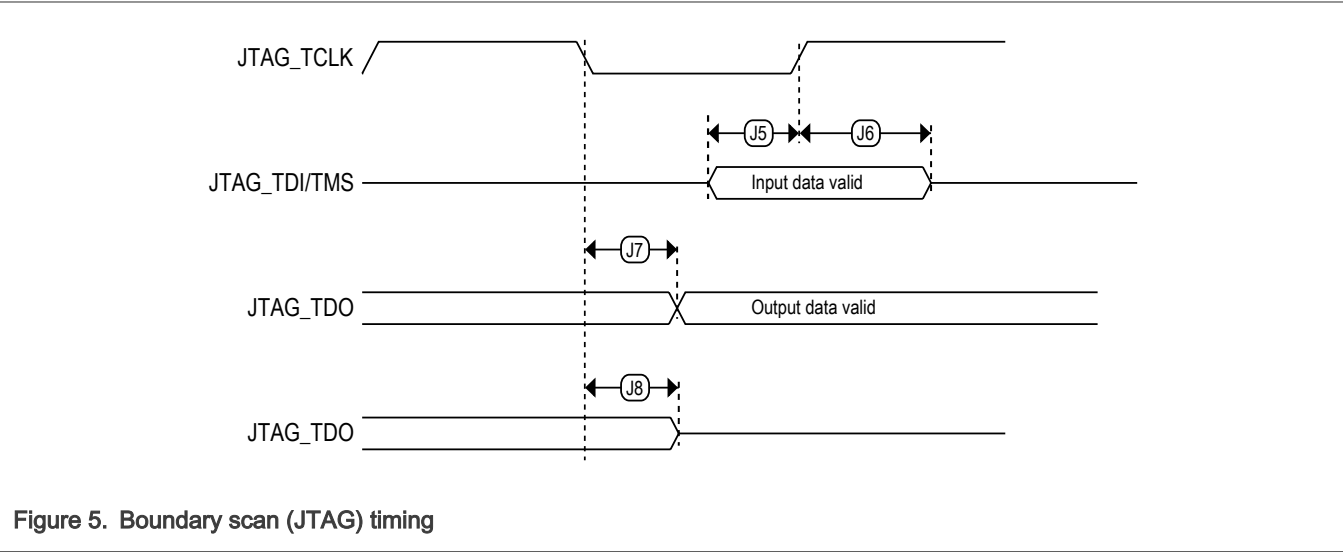
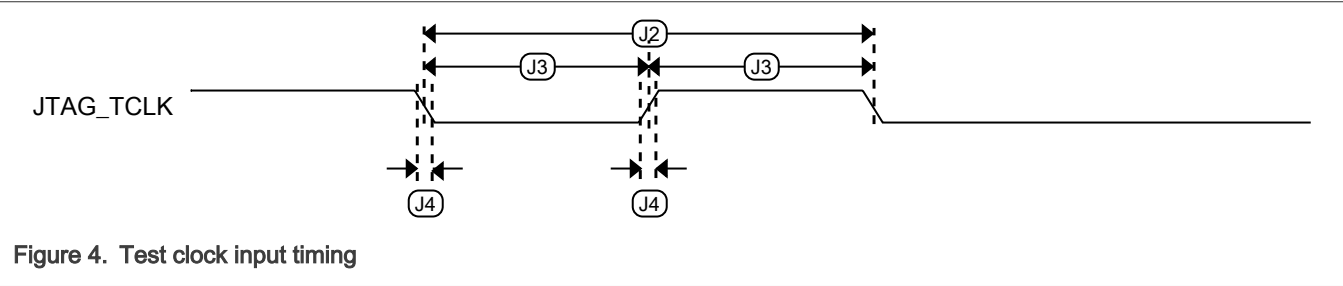
Symbol	Description	Min	Typ	Max	Unit	Condition
—	Operating voltage	1.71	—	3.6	V	—
J1	TCLK frequency of operation	—	—	25	MHz	Boundary Scan (OD mode)
J1	TCLK frequency of operation	—	—	12.5	MHz	Boundary Scan (MD mode)

Table continues on the next page...

Table 20. JTAG Debug Interface Timing...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
J1	TCLK frequency of operation	—	—	25	MHz	JTAG-DP/TAP (OD mode)
J1	TCLK frequency of operation	—	—	12.5	MHz	JTAG-DP/TAP (MD mode)
J2	TCLK cycle period	1000/J1	—	—	ns	—
J3	TCLK clock pulse width	J2/2	—	—	ns	—
J4	TCLK rise and fall times	—	—	3	ns	—
J5	Boundary scan input data setup time to TCLK rise	—	—	8	ns	OD mode
J5	Boundary scan input data setup time to TCLK rise	—	—	16	ns	MD mode
J6	Boundary scan input data hold time after TCLK rise	1	—	—	ns	OD mode
J6	Boundary scan input data hold time after TCLK rise	1	—	—	ns	MD mode
J7	TCLK low to boundary scan output data valid	—	—	18	ns	OD mode
J7	TCLK low to boundary scan output data valid	—	—	38	ns	MD mode
J8	TCLK low to boundary scan output high-Z	—	—	18	ns	OD mode
J8	TCLK low to boundary scan output high-Z	—	—	38	ns	MD mode
J9	JTAG-DP/TAP TMS, TDI input data setup time to TCLK rise	—	—	8	ns	OD mode
J9	JTAG-DP/TAP TMS, TDI input data setup time to TCLK rise	—	—	16	ns	MD mode
J10	JTAG-DP/TAP TMS, TDI input data hold time after TCLK rise	1	—	—	ns	OD mode
J10	JTAG-DP/TAP TMS, TDI input data hold time after TCLK rise	1	—	—	ns	MD mode
J11	TCLK low to JTAG-DP/TAP TDO data valid	—	—	18	ns	OD mode
J11	TCLK low to JTAG-DP/TAP TDO data valid	—	—	38	ns	MD mode
J12	TCLK low to JTAG-DP/TAP TDO high-Z	—	—	18	ns	OD mode
J12	TCLK low to JTAG-DP/TAP TDO high-Z	—	—	38	ns	MD mode

TDOC represents the TDO bit frame of the scan packet in compact JTAG 2-wire mode.

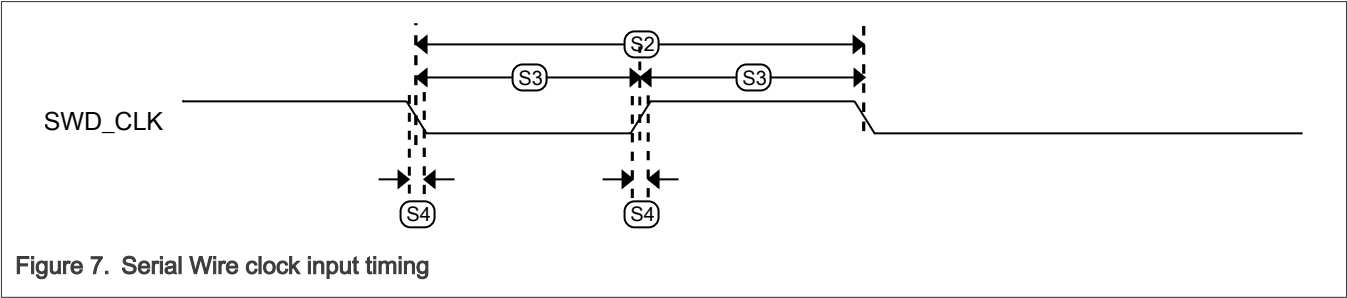


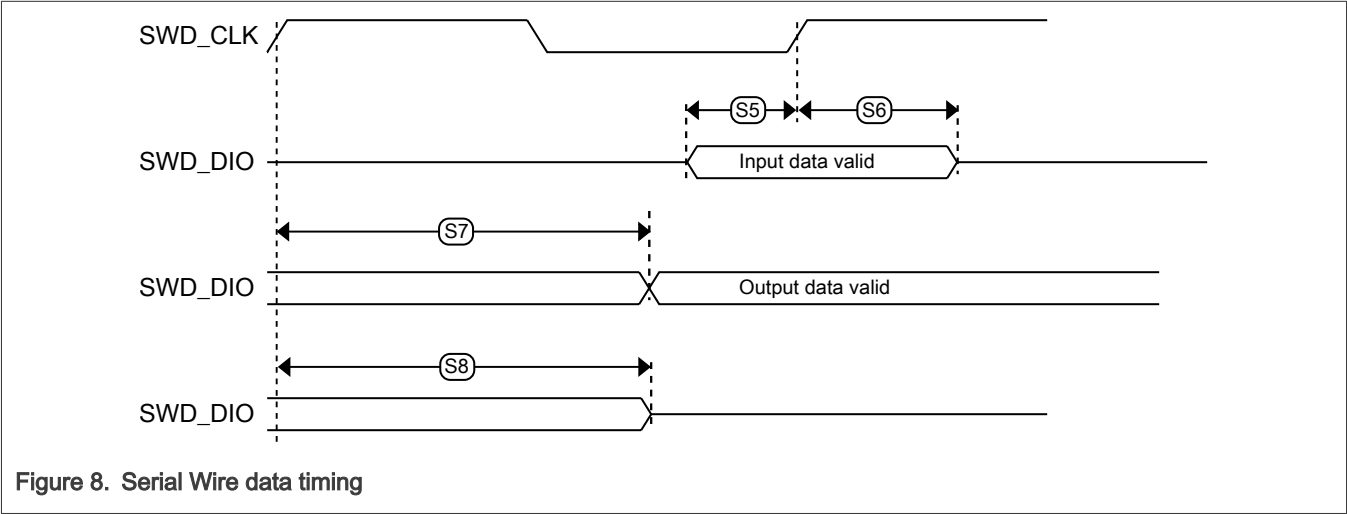
4.1.2 Serial Wire Debug (SWD) Timing

The following table gives the Serial Wire Debug specifications for the device.

Table 21. Serial Wire Debug (SWD) Timing

Symbol	Description	Min	Typ	Max	Unit	Condition
—	Operating voltage	1.71	—	3.6	V	—
S1	SWD_CLK frequency of operation	—	—	25	MHz	OD mode
S1	SWD_CLK frequency of operation	—	—	20	MHz	MD mode
S2	SWD_CLK cycle period	1000/S1	—	—	ns	OD mode
S2	SWD_CLK cycle period	1000/S1	—	—	ns	MD mode
S3	SWD_CLK clock pulse width	20	—	—	ns	OD mode
S3	SWD_CLK clock pulse width	25	—	—	ns	MD mode
S4	SWD_CLK rise and fall times	—	—	3	ns	—
S5	SWD_DIO input data setup time to SWD_CLK rise	—	—	10	ns	OD mode
S5	SWD_DIO input data setup time to SWD_CLK rise	—	—	12.5	ns	MD mode
S6	SWD_DIO input data hold time after SWD_CLK rise	0	—	—	ns	OD mode
S6	SWD_DIO input data hold time after SWD_CLK rise	0	—	—	ns	MD mode
S7	SWD_CLK high to SWD_DIO data valid	—	—	25	ns	OD mode
S7	SWD_CLK high to SWD_DIO data valid	—	—	30	ns	MD mode
S8	SWD_CLK high to SWD_DIO high-Z	—	—	25	ns	OD mode
S8	SWD_CLK high to SWD_DIO high-Z	—	—	30	ns	MD mode





4.2 Clock modules

4.2.1 Reference Oscillator Specification

This chip is designed to meet targeted specifications with a ± 40 ppm frequency error over the life of the part, which includes the temperature, mechanical, and aging excursions.

The table below shows typical specifications for the Crystal Oscillator.

4.2.1.1 System Crystal Oscillator Specification

Table 22. System Crystal Oscillator Specification

Symbol	Description	Min	Typ	Max	Unit	Condition
fosc	Crystal Frequency	8	—	50	MHz	—
Tol	Frequency tolerance	—	± 10	± 40	ppm	—
Jitosc	Jitter	—	70	—	—	Period jitter (RMS)
Vpp	Peak-to-peak amplitude of oscillation ^[1]	—	0.6	—	V	—
fec	Externally provided input clock frequency ^[2]	0	—	50	MHz	—
tDC_EXTAL	External clock duty cycle	45	50	55	%	—
Vec	Externally provided input clock amplitude ^[2]	Refer to VIH and VIL specification	—	—	—	—

[1] When a crystal is being used with the oscillator, the EXTAL and XTAL pins should only be connected to required oscillator components and must not be connected to any other devices.

[2] This specification is for an externally supplied clock driven to EXTAL and does not apply to any other clock input.

4.2.1.2 System Oscillator Crystal Specifications.

Table 23. System Oscillator Crystal Specifications.

Symbol	Description	Min	Typ	Max	Unit	Condition
Cin	Parasitic capacitance of EXTAL	—	2	8	pF	—
Cout	Parasitic capacitance of XTAL	—	2	10	pF	—
Tstart	Crystal start-up time ^[1]	—	186	—	μs	Normal mode fcrystal=16 MHz, Rm=200 Ω, Cp=1 pF, Cload=8 pF, Cm=0.008 pF, Lm=12.37 mH
IOSC	Current consumption	—	200	—	μA	Normal mode fcrystal=16 MHz, Rm=200 Ω, Cp=1 pF, Cload=8 pF, Cm=0.008 pF, Lm=12.37 mH
IOSC	Current consumption	—	—	3	μA	Disable mode

[1] Dependent on crystal specifications, proper PC board layout procedures must be followed to achieve specifications

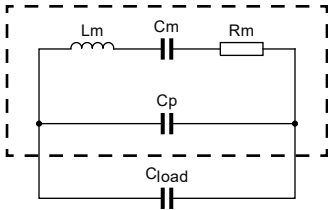


Figure 9. Crystal Electrical Block Diagram

4.2.1.3 System Oscillator Crystal Specifications

Table 24. System Oscillator Crystal Specifications.

Freq Crystal (MHz)	R _m (ohms)	C _p (pF)	C _{load} (pF)	C _m (pF)	L _m (mH)	Typical startup (μs) ^[1]	Typical Current consumption (μA) ^[1]	Drive level (μW)	
								min	max
8	100	5.00	18.0	0.008	49.47	1240	168	24	34
16	80	2.00	8.00	0.008	12.37	215	168.3	16	22
16	200	1.00	8.00	0.008	12.37	186	200.4	31	46
25	60	3.00	11.0	0.008	5.07	224	245.6	70	93
25	60	2.00	10.0	0.008	5.07	128	232.5	61	80
25	100	1.00	8.00	0.008	5.07	73.6	232.7	62	82
32	60	3.00	9.00	0.008	3.09	233	269.6	71	95
32	60	2.00	8.00	0.008	3.09	116	253.2	59	80

Table continues on the next page...

Table 24. System Oscillator Crystal Specifications. ...continued

32	100	1.00	8.00	0.008	3.09	52.4	289.3	91	123
40	50	2.00	8.00	0.008	1.98	80.4	296.9	73	99
40	60	3.00	9.00	0.008	1.98	162	333.2	99	135
48	50	2.00	8.00	0.008	1.37	73.1	359.6	104	140
48	60	3.00	9.00	0.008	1.37	155	407.9	138	188

[1] This is based on simulation

4.2.2 FRO180M specifications

Table 25. FRO180M specifications

Symbol	Description	Min	Typ	Max	Unit	Condition
jitper	Period jitter RMS ^[1]	—	70	—	ps	—
jitper	Accumulated jitter over 10K cycles ^[1]	—	800	—	ps	—
TJ	Operation temperature	-40	27	125	°C	—
Vvdda	Analog supply voltage	1.71	3.3	3.63	V	—
Vvdd	Digital supply voltage	0.9	1.1	1.21	V	—
Ivdda	3.3v analog supply current	—	50	—	μA	—
Ivdd	1.1v analog supply current	—	58	—	μA	—
Ivdda_dis	3.3v leakage current	—	5	—	nA	—
Ivdd_dis	1.1v leakage current	—	40	—	nA	—
Fclkout	Clock frequency ^{[2][3]}	—	45/45	—	MHz	freq_sel[2:0]=3'b001, set the FRO180M trim to 180 MHz
Fclkout	Clock frequency ^{[2][3]}	—	60/45	—	MHz	freq_sel[2:0]=3'b011, set the FRO180M trim to 180 MHz
Fclkout	Clock frequency ^{[2][3]}	—	90/45	—	MHz	freq_sel[2:0]=3'b101, set the FRO180M trim to 180 MHz
Fclkout	Clock frequency ^{[2][3]}	—	180/45	—	MHz	freq_sel[2:0]=3'b111, set the FRO180M trim to 180 MHz
Fclkout	Clock frequency ^{[2][3]}	—	60/60	—	MHz	freq_sel[2:0]=3'b001, set the FRO180M trim to 240 MHz
Fclkout	Clock frequency ^{[2][3]}	—	80/60	—	MHz	freq_sel[2:0]=3'b011, set the FRO180M trim to 240 MHz

Table continues on the next page...

Table 25. FRO180M specifications...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
Fclkout	Clock frequency ^{[2][3]}	—	120/60	—	MHz	freq_sel[2:0]=3'b101, set the FRO180M trim to 240 MHz
Fclkout	Clock frequency ^{[2][3]}	—	240/60	—	MHz	freq_sel[2:0]=3'b111, set the FRO180M trim to 240 MHz
Δfclkout	Frequency variation for packages other than WFBGA169 ^[4]	-1	—	1	%	-40 °C ≤ T _J ≤ 125 °C
Δfclkout	Frequency variation for WFBGA169 package ^[4]	-1.5	—	1	%	0 °C ≤ T _J ≤ 85 °C
Δfclkout	Frequency variation for WFBGA169 package ^[4]	-2	—	1	%	-40 °C ≤ T _J ≤ 85 °C
Δfclkout	Frequency variation for WFBGA169 package ^[4]	-5	—	1	%	-40 °C ≤ T _J ≤ 125 °C
Fclkout_closetloop	Close loop accuracy with autotrim from an accurate clock source	-0.25	—	0.25	%	—
Tstartup	Start-up time from disable to 20% accuracy	—	2	—	μs	—
Tsettle	Settling time from disable to 1% accuracy	—	—	50	μs	—
Fovershoot	frequency overshoot during start-up and settling	—	—	2	%	—
DC	Duty cycle of the clock	45	—	55	%	—

[1] Tested at 80 MHz

[2] Frequency in left of slash is fro_hf, and frequency in right of slash is clk_45m in reference manual clocking chapter

[3] Guaranteed by design

[4] Characterization on a production tester

4.2.3 FRO12M specifications

Table 26. FRO12M specifications

Symbol	Description	Min	Typ	Max	Unit	Condition
ffro12m	FRO12M frequency (nominal)	—	12	—	MHz	—
Δffro12m	Frequency deviation	—	—	±3	%	open loop
Δffro12m	Frequency deviation	—	—	±0.6	%	closed loop (using accurate clock source as reference)
tstartup	Start-up time	—	5	—	μs	—
fos	Frequency overshoot during startup	—	10	20	%	—

Table continues on the next page...

Table 26. FRO12M specifications...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
Ifro12m	Current consumption	—	7	—	μA	—

4.2.4 FRO16K specifications

Table 27. FRO16K specifications

Symbol	Description	Min	Typ	Max	Unit	Condition
ffro16k	FRO16K frequency (nominal) ^[1]	—	16.384	—	kHz	—
Δffro16k	Frequency variation for package other than WFBGA169	-6	—	6	%	open loop, -40 °C ≤ T _J ≤ 125 °C
Δffro16k	Frequency variation for WFBGA169 package ^[2]	-9	—	6	%	open loop, -40 °C ≤ T _J ≤ 125 °C
TRIMstep	Trimming step	—	1.5	—	%	—
tstartup	Start-up time	—	310	—	μs	—
Ifro16k	Current consumption	—	50	—	nA	—

[1] Guaranteed by design

[2] Characterization on a production tester

4.3 Memories and memory interfaces

4.3.1 Flash electrical specifications

This section describes the electrical characteristics of the flash memory module.

4.3.1.1 Timing specifications

The following command times assume a flash bus clock frequency of 24 MHz. Command times will be increased by up to 10 μs at 24 MHz if the module is exiting sleep mode when the command is launched. The time to abort a command is not included in the following table.

4.3.1.1.1 Flash command time specifications

Table 28. Flash command time specifications

Symbol	Description	Min	Typ	Max	Unit	Condition
trd1all256k	Read 1s All execution time (256 KB)	—	—	1700	μs	—
trd1all512k	Read 1s All execution time (512 KB)	—	—	3200	μs	—
trd1all1MB	Read 1s All execution time (1 MB)	—	—	6200	μs	—
trd1blk256k	Read 1s Block execution time (256 KB)	—	—	1500	μs	—
trd1blk512k	Read 1s Block execution time (512KB)	—	—	3050	μs	—

Table continues on the next page...

Table 28. Flash command time specifications...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
trd1blk1MB	Read 1s Block execution time (1MB)	—	—	6000	µs	—
trd1scr	Read 1s Sector execution time (8 KB) ^[1]	—	—	50	µs	—
trd1pg	Read 1s Page execution time (128 B) ^[1]	—	—	4.4	µs	—
trd1pglv	Read 1s Page at low voltage execution time (128 B)	—	—	5.8	µs	—
trd1phr	Read 1s Phrase execution time (16B) ^[1]	—	—	3.8	µs	—
trd1phrlv	Read 1s Phrase at low voltage execution time (16 B)	—	—	4.8	µs	—
trdmisr8k	Read into MISR (8 KB) ^[1]	—	—	50	µs	—
trdmisr256k	Read into MISR (256 KB)	—	—	1500	µs	—
trdmisr512k	Read into MISR (512 KB)	—	—	3050	µs	—
trdmisr1M	Read into MISR (1 MB) ^[1]	—	—	6000	µs	—
trd1ipg	Read 1s IFR Page execution time (128 B) ^[1]	—	—	4.4	µs	—
trd1ipglv	Read 1s IFR Page at low voltage execution time (128 B)	—	—	5.8	µs	—
trd1iphr	Read 1s IFR Phrase execution time (16 B) ^[1]	—	—	3.8	µs	—
trd1iphrlv	Read 1s IFR Phrase at low voltage execution time (16 B)	—	—	4.8	µs	—
trdimisr8k	Read IFR into MISR (8 KB) ^[1]	—	—	50	µs	—
trdimisrk32k	Read IFR into MISR (32 KB) ^[1]	—	—	190	µs	—
tpgmpg_initial	Program Page execution time at < 1k cycles (128 B) ^[2]	—	450	600	µs	—
tpgmpg_lifetime	Program Page execution time at > 1k cycles (128 B)	—	450	750	µs	—
tpgmphr_initial	Program Phrase execution time at < 1k cycles (16 B) ^[2]	—	135	180	µs	—
tpgmphr_lifetime	Program Phrase execution time at > 1k cycles (16 B)	—	135	225	µs	—
tersall256k	Erase All execution time (256 KB)	—	—	800	ms	—
tersall512k	Erase All execution time (512 KB)	—	—	1500	ms	—

Table continues on the next page...

Table 28. Flash command time specifications...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
tersall1M	Erase All execution time (1 MB)	—	—	2800	ms	—
tmasers256k	Mass Erase execution time (via sideband) (256 KB)	—	—	800	ms	—
tmasers512k	Mass Erase execution time (via sideband) (512 KB)	—	—	1500	ms	—
tmasers1M	Mass Erase execution time (via sideband) (1 MB)	—	—	2800	ms	—
terrscr	Erase Sector execution time (8 KB) ^[2]	—	2	22	ms	—

[1] Time to abort the command may significantly impact the time to execute the command.

[2] Measured from the time FSTAT[PERDY] is cleared.

4.3.1.2 Flash high voltage current behavior

Table 29. Flash high voltage current behavior

Symbol	Description	Min	Typ	Max	Unit	Condition
IDD_IO_PGM	Average current adder to VDD during flash programming operation ^[1]	—	—	6	mA	—
IDD_IO_ERS	Average current adder to VDD during flash erase operation ^[1]	—	—	4	mA	—

[1] See the Power Management chapter in the reference manual for the specific VDD voltage supply powering the flash array.

4.3.1.3 Flash reliability specifications.

Table 30. Flash reliability specifications.

Symbol	Description	Min	Typ	Max	Unit	Condition
Tnvmretp10k	tnvmretp10k	10	50	—	years	Program Flash
Nnvmcycscr	Sector cycling endurance ^[1]	10 K	500 K	—	cycles	Program Flash
Tnvmretp1k	Data retention after up to 1 K cycles	20	100	—	years	Program Flash
Tnvmretp100k	Data retention after up to 100 K cycles	5	50	—	years	Program Flash
Nnvmcyc256k	Sector cycling endurance for 256 KB ^[2]	100 K	500 K	—	cycles	Program Flash

[1] Sector cycling endurance represents the number of Program/Erase cycles on a single sector at $-40^{\circ}\text{C} \leq T_j \leq 125^{\circ}\text{C}$.

[2] For devices with a single flash block, sectors must be located within the last 256 KB of the flash main memory. For devices with two flash blocks, sectors must be located within the last 256 KB of each flash main memory but must not total more than 256 KB per device.

Note: Typical data retention values are based on measured response accelerated at high temperature and derated to a constant 25°C use profile.

4.4 Analog

4.4.1 ADC electrical specifications

4.4.1.1 ADC operating conditions

Table 31. ADC operating conditions

Symbol	Description	Min	Typ	Max	Unit	Condition
VDDAD	Supply voltage	1.71	—	3.6	V	—
VSSAD	Ground voltage	-0.1	0	0.1	V	—
ΔVDD	— [1]	-0.1	0	0.1	V	—
ΔVSS	— [1]	-0.1	0	0.1	V	—
VREFH	Reference Voltage High [2]	0.99	VDDAD	VDDAD	V	—
VREFL	Reference Voltage Low [3]	VSSAD	VSSAD	VSSAD	V	—
VADIN	Input Voltage [3][4][5]	VREFL	—	VREFH	V	—
FADCK	ADC conversion clock frequency	6	—	24	MHz	Low-power mode, PWRSEL=0
FADCK	ADC conversion clock frequency	6	—	64	MHz	Normal Mode, 16b, PWRSEL=1
FADCK	ADC conversion clock frequency	6	—	64	MHz	Normal Mode, 12b, PWRSEL=1
RAS	Analog source resistance (external) [6]	—	—	5	k Ω	—
RADIN	Input Resistance ADC channels 7:0 [7][8]	—	—	1.65	k Ω	VDDAD $\geq$ 1.71 V
RADIN	Input Resistance ADC channels 7:0 [7][8]	—	—	1.525	k Ω	VDDAD $\geq$ 2.1 V
RADIN	Input Resistance ADC channels 7:0 [7][8]	—	0.925	1.35	k Ω	VDDAD $\geq$ 2.5 V
CADIN	Input Capacitance	—	1.92	2.4	pF	—

[1] DC potential difference

[2] Minimum VDDAD/VREFH is 2.4 V in high-speed mode (when HS =1)

[3] For devices that do not have a dedicated VREFL and VSS_ANA pins, VREFL and VSS_ANA are tied to VSS internally.

[4] If VREFH is less than VDD_ANA, then voltage inputs greater than VREFH but less than VDD_ANA are allowed but result in a full-scale conversion result

[5] ADC selected inputs and unselected dedicated inputs must not exceed VDD_ANA during an ADC conversion. Unselected muxed inputs may exceed VDD_ANA but must not exceed the IO supply associated with the inputs (VDD) when a conversion is in progress. If an ADC input may exceed these levels, then a minimum of 1 K series resistance must be used between the source and the ADC input pin.

[6] This resistance is external to MCU. To achieve the best results, the analog source resistance must be kept as low as possible.

[7] There are several types of ADC inputs. To see which channels correspond to which type of ADC inputs, see channel index map in reference manual

[8] If the input come through a mux in the IO pad, add the IO Mux Resistance Adder value to the resistance for the channel type

4.4.1.2 I/O mux resistance table

Table 32. I/O mux resistance table

Symbol	Description	Min	Typ	Max	Unit	Condition
RIOMUX	I/O MUX Resistance	—	—	5.35	k Ω	VDD $\geq$ 1.71v
RIOMUX	I/O MUX Resistance	—	—	1	k Ω	VDD $\geq$ 2.1v
RIOMUX	I/O MUX Resistance	—	0.35	0.66	k Ω	VDD $\geq$ 2.5 v

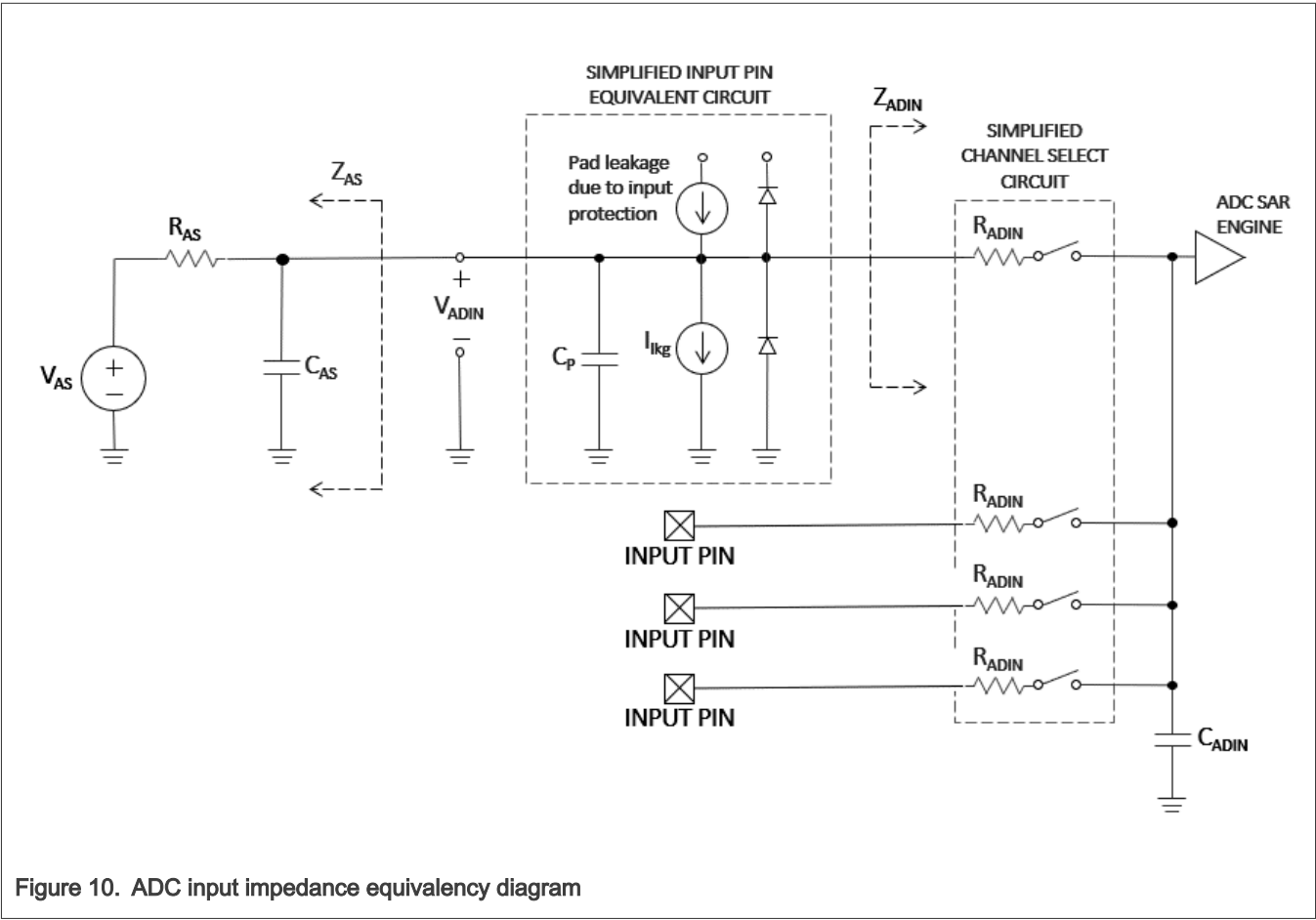


Figure 10. ADC input impedance equivalency diagram

4.4.1.3 ADC electrical characteristics

Note: Typical values are for reference only and are not tested in production

Table 33. ADC electrical characteristics

Symbol	Description	Min	Typ	Max	Unit	Condition
—	Supply current ^[1]	—	7	—	—	PWREN=0, Conversions triggered at 10 kS/s
IDDAD	Supply current ^[1]	—	60	—	μA	PWREN=1, No Conversions
IDDAD	Supply current ^[1]	—	194	—	μA	Low-power mode, 6 MHz Clock, PWRSEL=0, 16b mode
IDDAD	Supply current ^[1]	—	251	—	μA	Low-power mode, 24 MHz clock, PWRSEL=0, 16b mode
IDDAD	Supply current ^[1]	—	658	—	μA	Normal Mode, 64 MHz, PWRSEL=1, 12b mode

Table continues on the next page...

Table 33. ADC electrical characteristics...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
IDDAD	Supply current ^[1]	—	757	—	µA	High Speed Mode, 64 MHz Clock, PWRSEL=1, HS=1, 12b mode
IDDTS	Temp Sensor Supply Current	—	50	—	µA	Temperature Sensor Adder
CSMP	ADC Sample cycles ^[2]	3.5	—	131.5	cycles	Low-power mode and High speed mode
Fconv	ADC conversion rate ^[3]	—	—	4.0	MS/s	12b mode, (HS=1)
Fconv	ADC conversion rate ^[3]	—	—	3.2	MS/s	16b mode, (HS=1)
TSMP_REQ	Required Sample Time ^[4]	—	—	—	ns	Use equation based on RAS, RIOMUX, RADIN, CADIN, RAS, CAS, CP and desired accuracy (B)
TSMP	Sample Time ^[5]	145.8	TSMP_R EQ	—	ns	Low-power mode
TSMP	Sample Time ^[6]	54.7	TSMP_R EQ	—	ns	High-speed 16b mode
TSMP	Sample Time ^[6]	54.7	TSMP_R EQ	—	ns	High-speed 12b mode
TSMPINT	Internal channel sample time inputs ^[7]	2.0	—	—	µs	—
DNL	Differential non-linearity ^{[8][9][10]}	—	±0.7	±0.9	LSB	12b mode, N = 12 bits
INL	Integral non-linearity ^{[8][9][10]}	—	±0.5	±0.8	LSB	12b mode, N = 12 bits
DNL	Differential non-linearity ^{[8][9][10]}	—	±0.5	±0.7	LSB	N = 14 bits, for 16-bit specification, multiply by 4.
INL	Integral non-linearity ^{[8][9][10]}	—	±0.5	±0.8	LSB	N = 14 bits, for 16-bit specification, multiply by 4.
ZSE	Zero-scale error (V_ADIN = V_REFL) ^{[8][9]}	—	±1	—	LSB	12b mode
FSE	Full-scale error (V_ADIN = V_REFH) ^{[8][9]}	—	±2	—	LSB	12b mode
TUE	Total Unadjusted Error ^{[8][9]}	—	±3	—	LSB	12b mode
ENOB16	Effective number of bits, 16b Mode, 1 kHz input ^{[9][11]}	—	15.0	—	bits	25.2 kS/s (FADCK = 64 MHz, HS =1, AVGS=0111)

Table continues on the next page...

Table 33. ADC electrical characteristics...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
ENOB16	Effective number of bits, 16b Mode, 1 kHz input ^{[9][11]}	—	13.6	—	bits	200 kS/s (FADCK = 64 MHz, HS=1, AVGS =0100)
ENOB16	Effective number of bits, 16b Mode, 1 kHz input	—	12.7	—	bits	800 kS/s (FADCK = 64 MHz, HS=1, AVGS =0010)
ENOB16	Effective number of bits, 16b Mode, 1 kHz input	—	11.7	—	bits	3.2 MS/s (FADCK = 64 MHz, HS=1, AVGS =0000)
ENOB12	Effective number of bits, 12b Mode, 1 kHz input ^{[9][11]}	—	11.5	—	bits	1.0 MS/s (FADCK = 64 MHz, HS =1, AVGS=0010)
ENOB12	Effective number of bits, 12b Mode, 1 kHz input ^{[9][11]}	—	11.0	—	bits	4.0 MS/s (FADCK = 64 MHz, HS =1, AVGS=0000)
SNDR16	Signal-to-noise plus distortion, 16b Mode, 1 kHz input ^{[9][11]}	—	92.4	—	dB	25.2 kS/s (FADCK=64 MHz, HS=1, AVGS=0111)
SNDR16	Signal-to-noise plus distortion, 16b Mode, 1 kHz input ^{[9][11]}	—	84.1	—	dB	200 kS/s (FADCK=64 MHz, HS=1, AVGS=0100)
SNDR16	Signal-to-noise plus distortion, 16b Mode, 1 kHz input ^{[9][11]}	—	78.3	—	dB	800 kS/s (FADCK=64MHz, HS=1, AVGS=0010)
SNDR16	Signal-to-noise plus distortion, 16b Mode, 1 kHz input	—	72	—	dB	3.2 MS/s (FADCK=64 MHz, HS=1, AVGS=0000)
SNDR12	Signal-to-noise plus distortion, 12b Mode, 1 kHz input ^{[9][11]}	—	71.0	—	dB	1.0 MS/s (FADCK=64 MHz, HS=1, AVGS=0010)
SNDR12	Signal-to-noise plus distortion, 12b Mode, 1 kHz input ^{[9][11]}	—	68.0	—	dB	4.0 MS/s (FADCK=64 MHz, HS=1, AVGS=0000)
SFDR	Spurious free dynamic range ^{[9][11]}	—	88.0	—	dB	12b/16b Mode, 1kHz input, AVGS =0010
SFDR	Spurious free dynamic range ^{[9][11]}	—	82.0	—	dB	12b/16b Mode, 1kHz input, AVGS =0000
tADCSTUP	Start-up time ^{[10][12]}	5	—	—	μs	—
E_TS	Temperature sensor error ^[13]	—	±1	±3	°C	T _j =−40 to 105 °C
E_TS	Temperature sensor error ^[13]	—	±2	±4	°C	T _j =−40 to 125 °C

Table continues on the next page...

Table 33. ADC electrical characteristics...continued

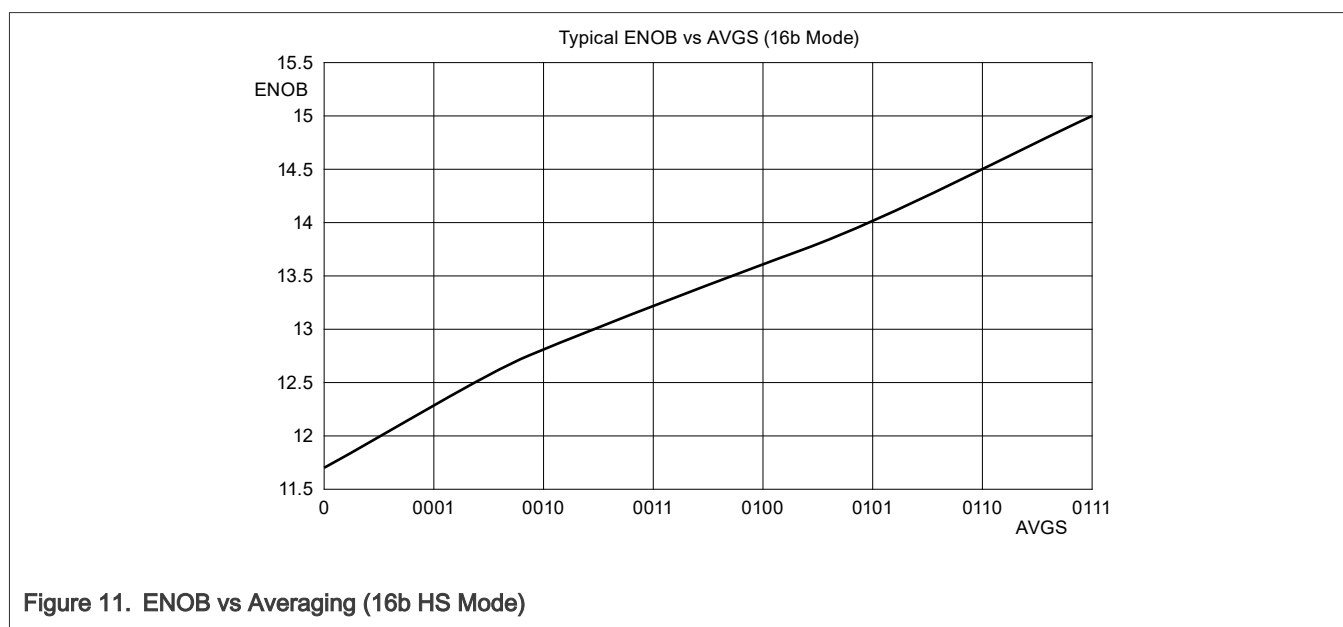
Symbol	Description	Min	Typ	Max	Unit	Condition
A	Temp Sensor Slope Constant ^[1 4]	—	738	—	°C	—
B	Temp Sensor Offset Constant ^[14]	—	287.5	—	°C	—
α	Temp Sensor Bandgap Constant ^[14]	—	10.06	—	°C	—

- [1] The ADC supply current depends on the ADC conversion clock speed, conversion rate, and power mode. Typical value show is at 6 MHz, 24 MHz, and 64 MHz. For lowest power operation, PWRSEL should be set to 0.
- [2] Must meet minimum TSMP requirement
- [3] fADCK=64 MHz (HS Mode)
- [4] Required sample time is dictated by external components RAS, CAS, internal components RADIN, CADIN, CP, and desired sample accuracy in bits (B). Calculate it with formula: $TSMP_REQ = B * \ln(2) * [RAS * (CAS + CP + CADIN) + (RAS + RIOMUX + RADIN) * CADIN(typ)]$. RIOMUX=0 unless the ADC input channel goes through an analog mux in the IO"
- [5] Min based on 3.5 cycles
- [6] Min based on 3.5 cycles @ 64 MHz
- [7] Internal channel inputs are those that do not come from external source (temperature sensor, bandgap).
- [8] $1 \text{ LSB} = (VREFH - VREFL) / 2^N$
- [9] All accuracy numbers assume that the ADC is calibrated with VREFH=VDD_ANA and using a high- speed- dedicated input channel. Typical values assume VDD_ANA = 3.0 V, Temp = 25 °C, fADCK = 24 MHz, sample time of 3.5 ADCK cycles (CMDHn[STS]=0h) unless otherwise stated. Typical values are for reference only, and are not tested in production.
- [10] Guaranteed by characterization
- [11] Dynamic results assume Fin=1 kHz sinewave, no averaging unless otherwise specified
- [12] Delay required if PWREN=0. Set the power-up delay (PUDLY) according to the ADC start-up time if PWREN=0.
- [13] The temperature sensor can be calibrated to a +/- 1 % precision after board assembly by using a 3-temperature calibration flow with accurate $\pm 0.15 \%$ temperature chamber
- [14] $T(^{\circ}\text{C}) = A * [\alpha(Vbe8 - Vbe1) / (Vbe8 + \alpha(Vbe8 - Vbe1))] - B$ where Vbe1 is the first value stored to FIFO as a result of the temperature sensor channel conversion, Vbe8 is the second value stored to FIFO as a result of the temperature sensor channel conversion, A is the slope factor, B is the offset factor, α is the bandgap coefficient

Typical values are for reference only and are not tested in production

fADCK=60 MHz (HS Mode)

Min based on 3.5 cycles @ 60 MHz



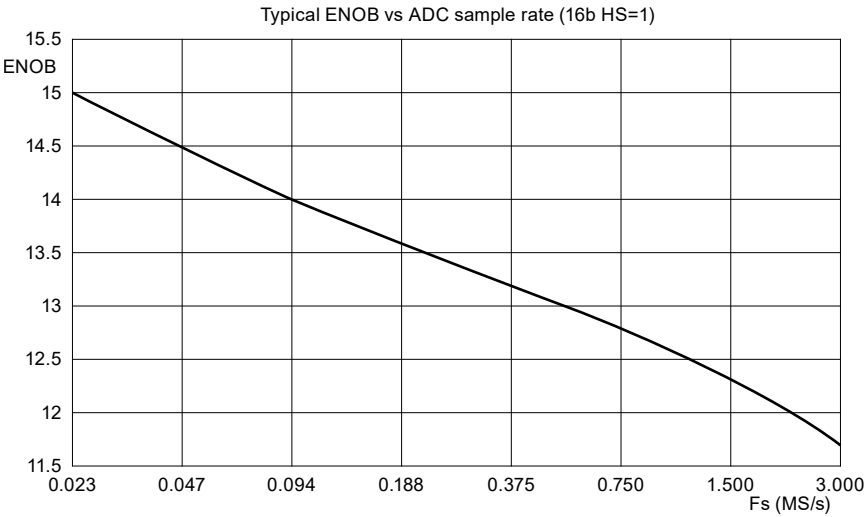


Figure 12. ENOB vs ADC sample rate

4.4.2 12-bit DAC electrical characteristics

4.4.2.1 12-bit DAC operating requirements

Table 34. 12-bit DAC operating requirements

Symbol	Description	Min	Typ	Max	Unit	Condition
VDD_ANA	Supply voltage	1.71	—	3.6	V	—
VDACR	Reference Voltage	0.97	—	VDD_ANA	V	—
CL	Output load capacitance ^[1]	—	50	100	pF	—
IL	Output load current ^[2]	-1	—	1	mA	—
DAC_c_rate	DAC conversion rate	—	—	1	MSPS	—

[1] A small load capacitance (50 pF) can improve the bandwidth performance of the DAC.

[2] Sink or source current availability

The DAC reference can be selected to be VDD_ANA or VREFH, keep VDD_ANA be the highest voltage.

4.4.2.2 12-bit DAC operating behaviors

Table 35. 12-bit DAC operating behaviors

Symbol	Description	Min	Typ	Max	Unit	Condition
IDD_DAC	Supply Current	—	300	500	μA	Normal mode
IDD_DAC	Supply Current	—	100	150	μA	Low-power mode
IDD_DAC	Supply Current	—	10	—	nA	Disabled
tDAC	Full-scale settling time (0x100 to 0xF00) ^[1]	—	2.5	3	μs	Normal mode

Table continues on the next page...

Table 35. 12-bit DAC operating behaviors...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
tDAC	Full-scale settling time (0x100 to 0xF00) ^[1]	—	5	6	μs	Low-power mode
tccDAC	Code-to-code settling time (0xBF8 to 0xC08) ^[1]	—	0.7	1	μs	—
Vdacoutl	DAC output voltage range low — high-speed mode, no load, DAC set to 0x000	—	—	100	mV	—
Vdacouth	DAC output voltage range high — high-speed mode, no load, DAC set to 0xFFFF	VDACR-100	—	VDACR	mV	—
INL	Integral non-linearity error ^[2]	—	—	±3	LSB	—
DNL	Differential non-linearity error ^[3]	—	—	±1	LSB	—
EOFFSET	Offset error ^[4]	—	± 0.4	± 0.8	%FSR	—
EG	Gain error ^[4]	—	± 0.3	± 0.6	%FSR	VDACR < 2.1 V
EG	Gain error ^[4]	—	± 0.1	± 0.3	%FSR	VDACR > 2.1 V
PSRR	Power supply rejection ratio, VDD_ANA ≥ 2.4 V	—	70	—	dB	—
TCO	Temperature coefficient offset voltage at middle scale ^[5]	—	—	—	μV/C	—
TEO	Temperature coefficient offset error	—	30	—	μV/C	—
TGE	Temperature coefficient gain error	—	10	—	PPM/C	—
ROP	Output resistance (load = 10 kΩ)	—	200	—	Ω	—
SR	Slew rate 100 h -> F00 h or F00 h -> 100 h	—	3.6	—	V/μs	—
SR	Slew rate 100 h -> F00 h or F00 h -> 100 h	—	0.5	—	V/μs	—
TPU	Power-up time	—	2.5	—	μs	—

[1] Settling within ±1 LSB measured with a 47 pF load.

[2] The INL is measured for 0 + 100 mV to VDACR -100 mV

[3] The DNL is measured for 0 + 100 mV to VDACR -100 mV

[4] Calculated by a best fit curve from VSS_ANA + 100 mV to VDACR - 100 mV

[5] VDD_ANA = 3.0 V, reference select set for VDD_ANA (DACx_CO:DACRFS = 1), high- power mode (DACx_C0:LPEN = 0), DAC set to 0x800, temperature range is across the full range of the device.

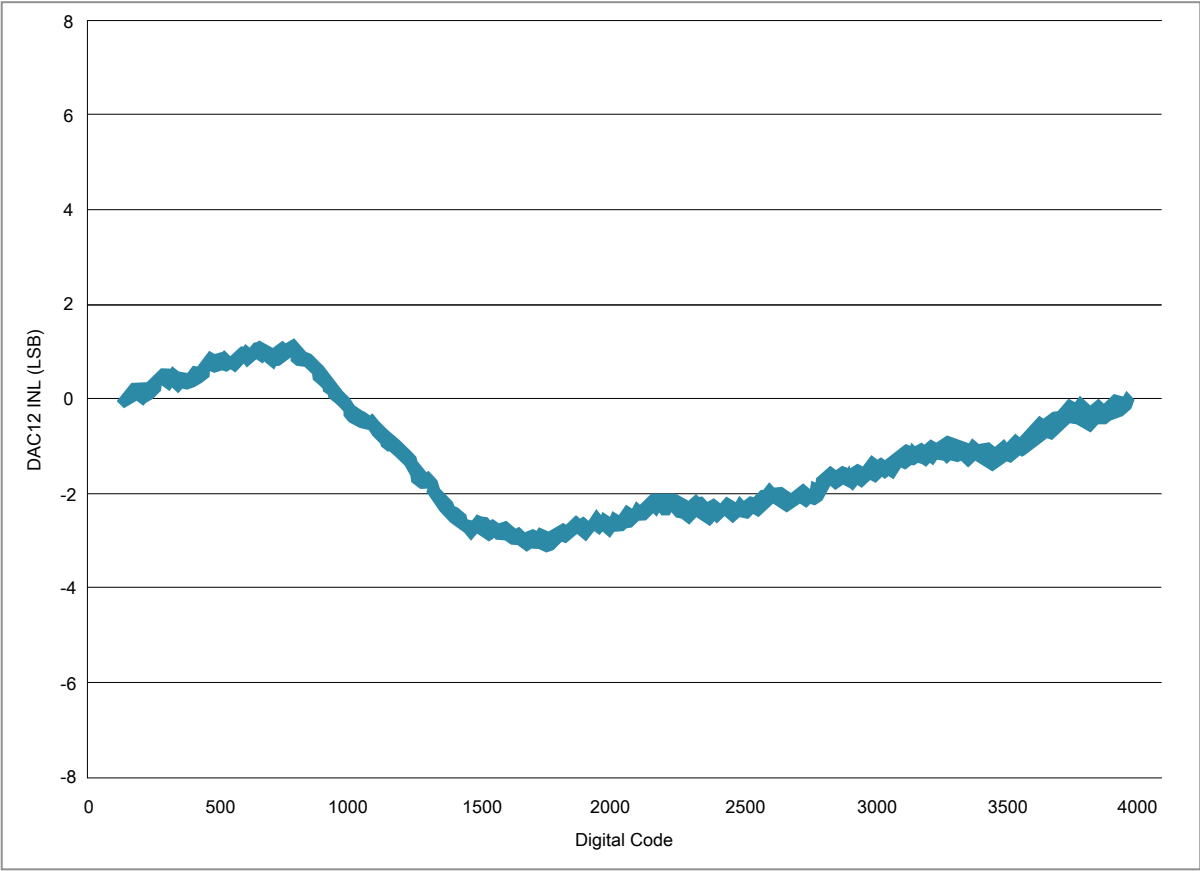


Figure 13. Typical INL error vs. digital code

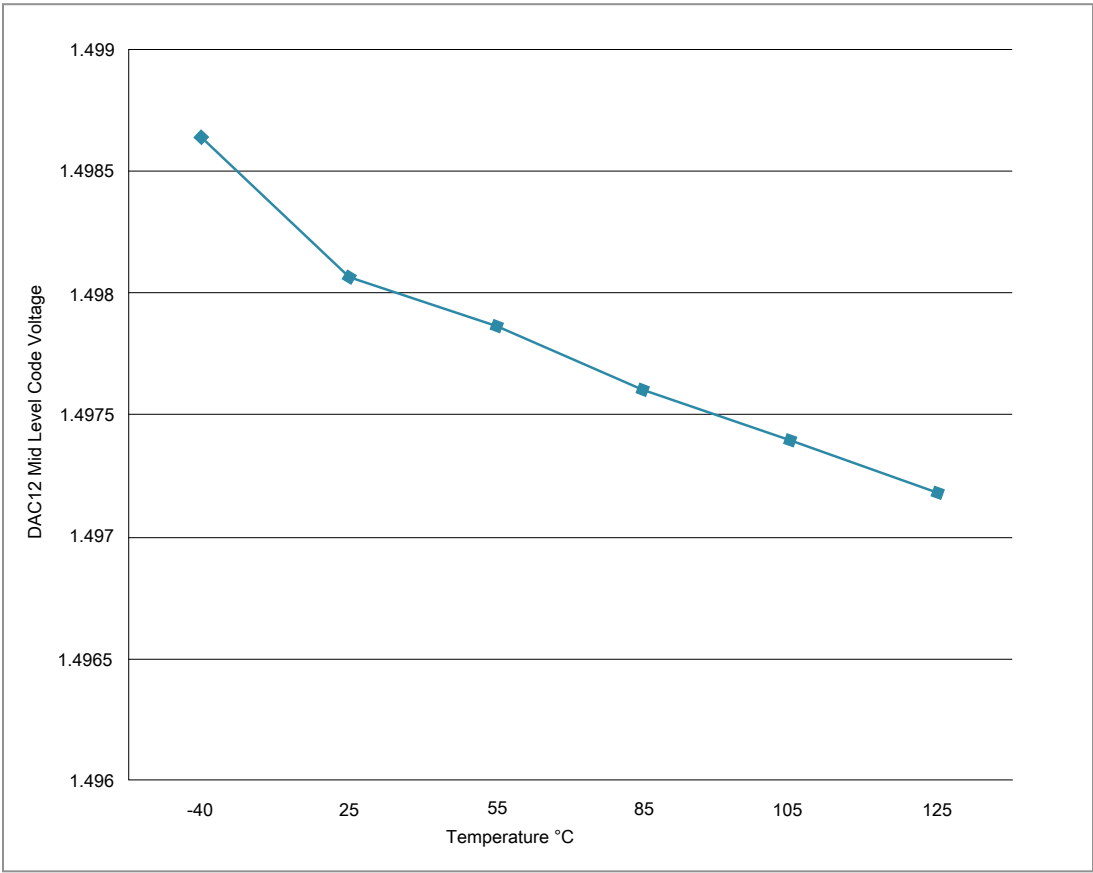


Figure 14. Offset at half scale vs. temperature

4.4.3 Comparator and 8-bit DAC electrical specifications

Table 36. Comparator and 8-bit DAC electrical specifications

Symbol	Description	Min	Typ	Max	Unit	Condition
VDD	Supply voltage	1.71	—	3.6	V	—
VREFH	8-bit DAC reference voltage high	0.97	—	VDD	V	—
IDD_CMP	Supply current	—	200	—	μA	High speed mode (EN=1, HPMD=1)
IDD_CMP	Supply current	—	10	—	μA	Normal mode (EN=1, HPMD=0, NPMD=0)
IDD_CMP	Supply current	—	400	—	nA	Low-power mode (EN=1, HPMD=0, NPMD=1)
VAIN	Analog input voltage	VSS	—	VDD	V	—
VAIO	Analog input offset voltage	—	—	20	mV	High speed mode

Table continues on the next page...

Table 36. Comparator and 8-bit DAC electrical specifications...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
VAIO	Analog input offset voltage	—	—	20	mV	Normal mode
VAIO	Analog input offset voltage	—	—	40	mV	Low-power mode
VH	Analog comparator hysteresis ^[1]	—	0	—	mV	CR0[HYSTCTR] = 00
VH	Analog comparator hysteresis ^[1]	—	10	—	mV	CR0[HYSTCTR] = 01
VH	Analog comparator hysteresis ^[1]	—	20	—	mV	CR0[HYSTCTR] = 10
VH	Analog comparator hysteresis ^[1]	—	30	—	mV	CR0[HYSTCTR] = 11
VCMPOh	Output high	VDD - 0.2	—	—	V	—
VCMPOI	Output low	—	—	0.2	V	—
tD	Propagation delay ^[2]	—	—	25	ns	High speed mode, 100 mV overdrive, power > 1.71V
tD	Propagation delay ^[2]	—	—	50	ns	High speed mode, 30 mV overdrive, power > 1.71V
tD	Propagation delay ^[2]	—	—	600	ns	Normal mode, 30 mV overdrive, power > 1.71V
tD	Propagation delay ^[2]	—	—	5	μs	Low-power mode, 30 mV overdrive, power > 1.71V
tinit	Analog comparator initialization delay ^[3]	—	—	40	μs	—
IDAC8b	8-bit DAC current adder (enabled)	—	10	—	μA	High power mode (EN=1, PMODE=1)
IDAC8b	8-bit DAC current consumption	—	1	—	μA	Low power mode (EN=1, PMODE=0)
INL	8-bit DAC integral non-linearity ^[4]	-1	—	+1.0	LSB	Low/High power mode, supply power > 1.71V
DNL	8-bit DAC differential non-linearity	-1	—	+1.0	LSB	Low/High power mode, power > 1.71V

[1] Typical hysteresis is measured with input voltage range limited to 0.6 to VDD_ANA-0.6 V.

[2] Overdrive does not include input offset voltage or hysteresis. The propagation delay is defined as the time delay between the change of the voltage on input pin and the output change of the comparator analog part

[3] Comparator initialization delay is defined as the time between software writes to change control inputs (Writes to CMP_DACCR[DACEN], CMP_DACCR[VRSEL], CMP_DACCR[VOSEL], CMP_MUXCR[PSEL], and CMP_MUXCR[MSEL]) and the comparator output settling to a stable level.

[4] 1 LSB = Vreference/256

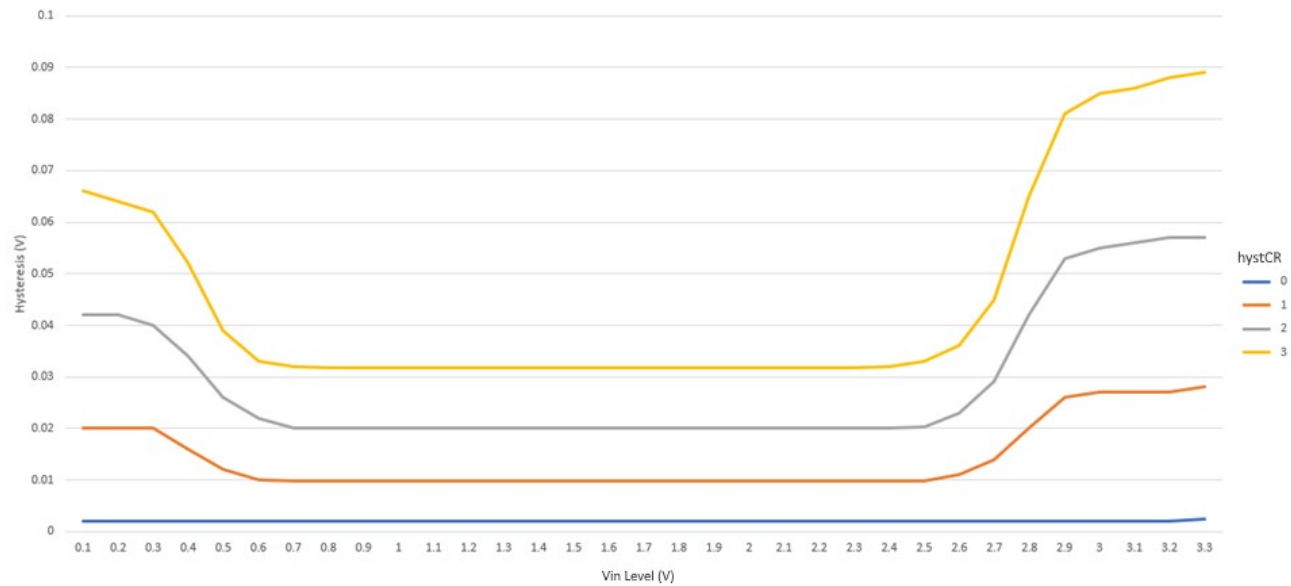


Figure 15. Typical hysteresis vs. Vin level (VDD = 3.3 V, HPMD = 1)

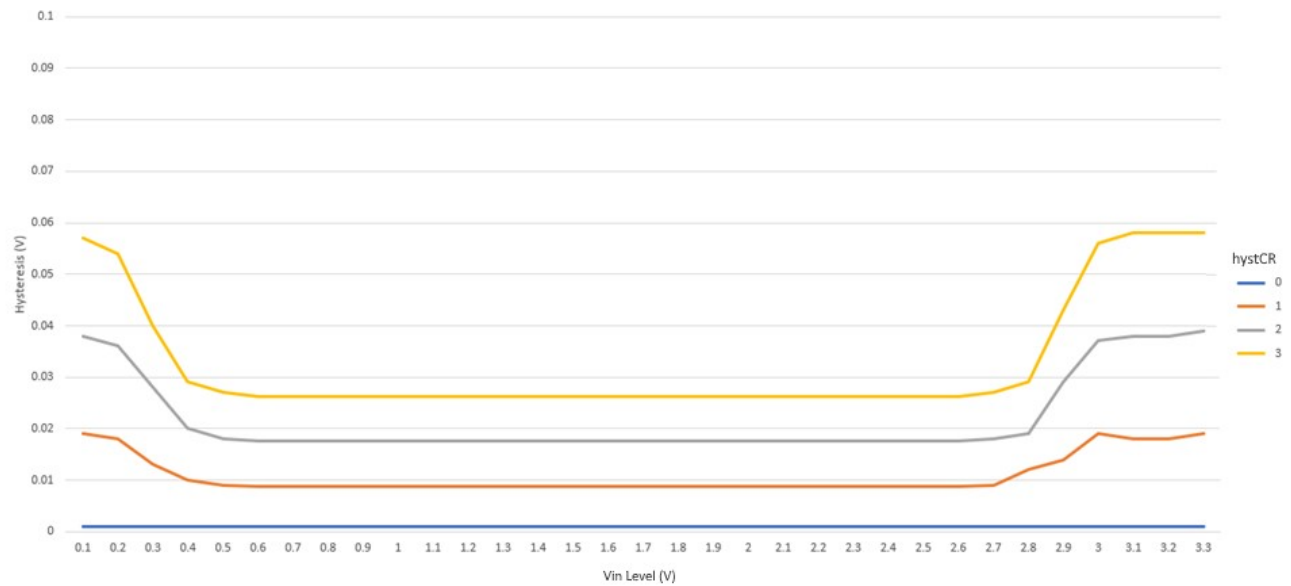


Figure 16. Typical hysteresis vs. Vin level (VDD = 3.3 V, HPMD = 0, NPMD = 0)

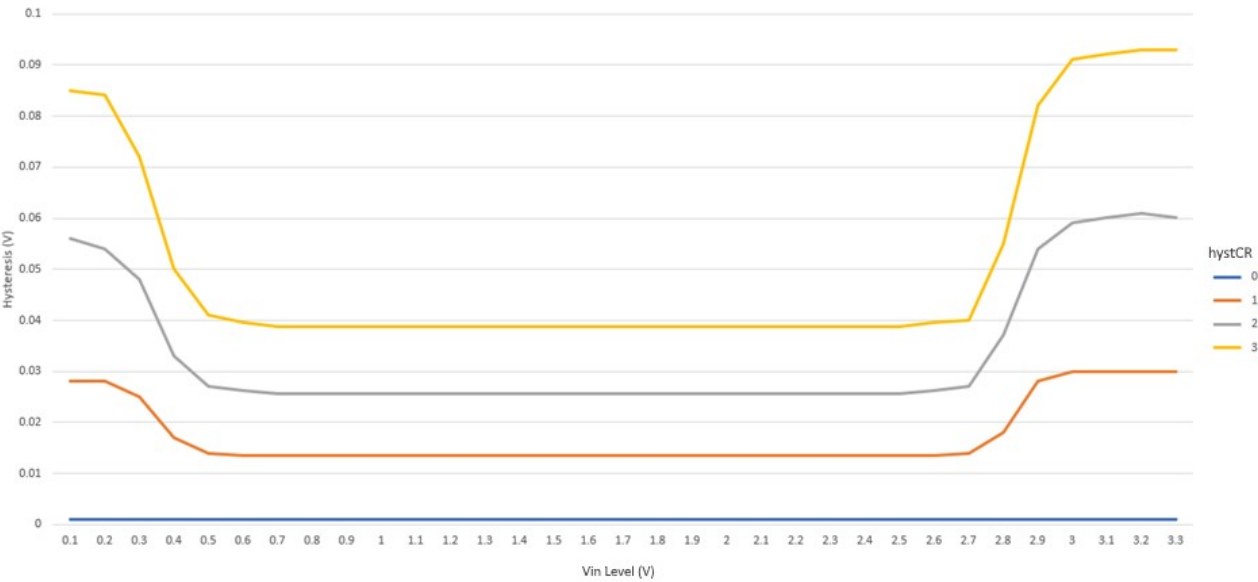


Figure 17. Typical hysteresis vs Vin level (VDD =3.3 V, HPMD = 0, NPMD = 1)

4.4.4 OpAmp electrical specifications

Table 37. OpAmp electrical specifications

Symbol	Description	Min	Typ	Max	Unit	Condition
TJ	Operation temperature	-40	25	125	°C	—
Vvdda	Analog supply voltage	1.71	3	3.6	V	—
Vvdd	Digital supply voltage	0.9	1.1	1.21	V	—

General

Table 38. OpAmp electrical specifications

Symbol	Description	Min	Typ	Max	Unit	Condition
Ivdda	Analog supply current	—	500	—	μA	—
Cin	Input capacitance	—	—	5	pF	—
Cload	Load capacitance	—	—	20	pF	—
Rload	Load resistance	3	—	20	KΩ	—
Vcm	Input common mode voltage range	0	—	Vvdda-1	V	—
Vout	Output voltage range	0.15	—	Vvdda - 0.15	V	—

Table continues on the next page...

Table 38. OpAmp electrical specifications...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
Ishutdown_3v	Leakage current for vdda_3v pin	—	1	80	nA	When Vvdda = 3V
Vos	Input offset voltage	-7	0	7	mV	—
CMRR	Input common mode rejection ratio	—	80	—	dB	—
PSRR	Power supply rejection ratio	—	80	—	dB	—
UGB	Unity gain bandwidth	—	8	—	MHz	CC config=2'b00, gain=2
UGB	Unity gain bandwidth	—	16	—	MHz	CC config=2'b01, gain=4
UGB	Unity gain bandwidth	—	32	—	MHz	CC config=2'b10, gain=8
UGB	Unity gain bandwidth	—	64	—	MHz	CC config=2'b11, gain=16
Av	DC open loop voltage gain	-	95	-	dB	—
PM	Phase marge	-	60	-	deg	—
Tsettle	Settling time	-	450	-	ns	—
SR	Slew rate	-	10	-	V/us	—
Vn	Voltage noise density @1KHz	—	150	—	nV/ sqrtHz	Gain = 1
Zout	Closed-loop output impedance	—	1.703	—	Ohm	cc config=2'b00, f = 200KHz
Zout	Closed-loop output impedance	—	14.72	—	Ohm	cc config=2'b01, f = 200KHz
Zout	Closed-loop output impedance	—	8.514	—	Ohm	cc config=2'b00, f = 1MHz
Zout	Closed-loop output impedance	—	73.47	—	Ohm	cc config=2'b01, f = 1MHz

4.5 Timers

See [General switching specifications](#).

4.6 Communication Interfaces

4.6.1 LPUART

See [General switching specifications](#).

4.6.2 LPSPI switching specifications

The Low Power Serial Peripheral Interface (LPSPI) provides a synchronous serial bus with controller and peripheral operations. Many of the transfer attributes are programmable. The following tables provide timing characteristics for classic SPI timing modes.

4.6.2.1 LPSPI controller mode timing

Table 39. LPSPI controller mode timing

Symbol	Description	Min	Typ	Max	Unit	Condition
LP1	Frequency of operation ^[1]	—	—	—	MHz	—
LP1	LPSPi0 ~ LPSPi1 medium speed pad ^[2]	—	—	50	MHz	Controller in OD mode
LP1	LPSPi0 ~ LPSPi1 slow speed pad ^[2]	—	—	25	MHz	Controller in OD mode
LP1	LPSPi0 ~ LPSPi1 medium speed pad ^[2]	—	—	25	MHz	Controller in MD mode
LP1	LPSPi0 ~ LPSPi1 slow speed pad ^[2]	—	—	25	MHz	Controller in MD mode
LP2	SPSCK period	1000/LP1	—	—	ns	—
LP3	Enable lead time ^[3]	1/2	—	—	tperiph	—
LP4	Enable lag time ^[3]	1/2	—	—	tperiph	—
LP5	Clock (SPSCK) high or low time	tSCK/2-3	—	tSCK/2	ns	—
LP6	Data setup time (inputs)	—	—	—	ns	—
LP6	LPSPi0 ~ LPSPi1 medium speed pad ^[2]	—	—	4.2	ns	Controller in OD mode
LP6	LPSPi0 ~ LPSPi1 slow speed pad ^[2]	—	—	4.4	ns	Controller in OD mode
LP6	LPSPi0 ~ LPSPi1 medium speed pad ^[2]	—	—	5.4	ns	Controller in MD mode
LP6	LPSPi0 ~ LPSPi1 slow speed pad ^[2]	—	—	5.4	ns	Controller in MD mode
LP7	Data hold time (inputs)	—	—	—	ns	—
LP7	LPSPi0 ~ LPSPi1 medium speed pad ^[2]	0	—	—	ns	Controller in OD mode
LP7	LPSPi0 ~ LPSPi1 slow speed pad ^[2]	0	—	—	ns	Controller in OD mode
LP7	LPSPi0 ~ LPSPi1 medium speed pad ^[2]	0	—	—	ns	Controller in MD mode
LP7	LPSPi0 ~ LPSPi1 slow speed pad ^[2]	0	—	—	ns	Controller in MD mode
LP8	Data valid (after SPSCK edge)	—	—	—	ns	—
LP8	LPSPi0 ~ LPSPi1 medium speed pad ^[2]	—	—	6.4	ns	Controller in OD mode
LP8	LPSPi0 ~ LPSPi1 slow speed pad ^[2]	—	—	12.8	ns	Controller in OD mode

Table continues on the next page...

Table 39. LPSPI controller mode timing...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
LP8	LPSPi0 ~ LPSPi1 medium speed pad ^[2]	—	—	13.6	ns	Controller in MD mode
LP8	LPSPi0 ~ LPSPi1 slow speed pad ^[2]	—	—	13.6	ns	Controller in MD mode
LP9	Data hold time (outputs)	—	—	—	ns	—
LP9	LPSPi0 ~ LPSPi1 medium speed pad ^[2]	-1	—	—	ns	Controller in OD mode
LP9	LPSPi0 ~ LPSPi1 slow speed pad ^[2]	-1	—	—	ns	Controller in OD mode
LP9	LPSPi0 ~ LPSPi1 medium speed pad ^[2]	-1	—	—	ns	Controller in MD mode
LP9	LPSPi0 ~ LPSPi1 slow speed pad ^[2]	-1	—	—	ns	Controller in MD mode

[1] The frequency of operation is also limited to a minimum of $f_{periph}/2048$ and a max of $f_{periph}/2$, where f_{periph} is the LPSPI peripheral functional clock.

[2] OD mode is MCU at Over drive mode, MD mode is MCU at Middle drive mode.

[3] $t_{periph} = 1/f_{periph}$

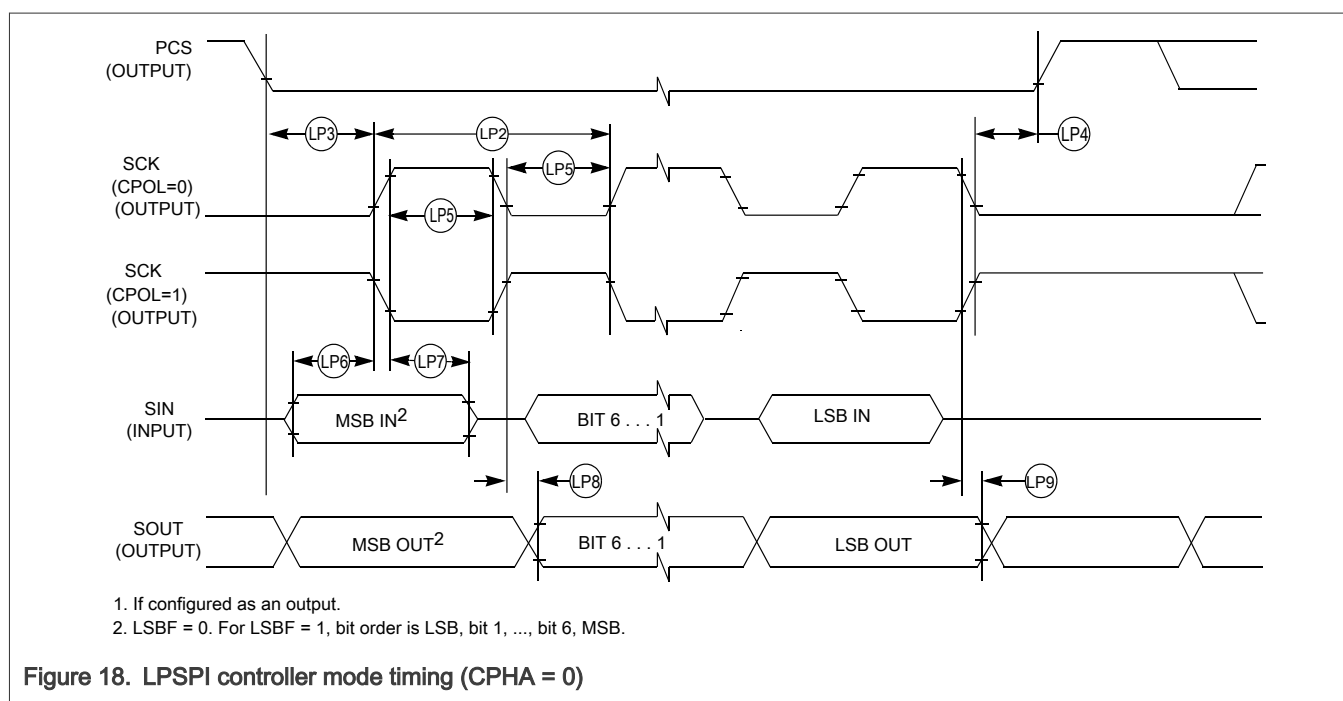


Figure 18. LPSPI controller mode timing (CPHA = 0)

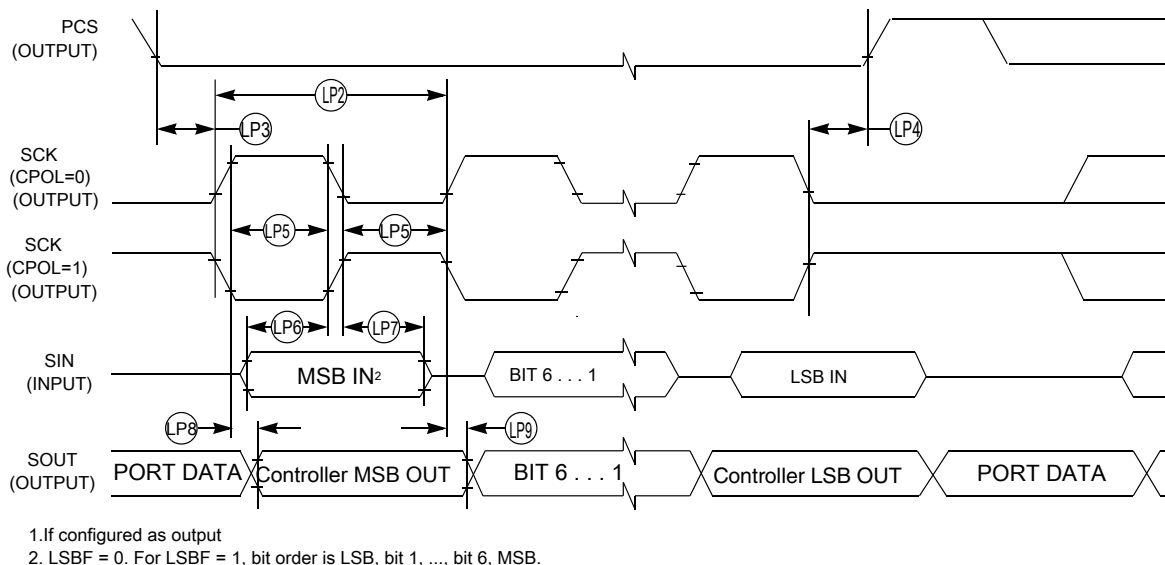


Figure 19. LPSPi controller mode timing (CPHA = 1)

4.6.2.2 LPSPi peripheral mode timing

Table 40. LPSPi peripheral mode timing

Symbol	Description	Min	Typ	Max	Unit	Condition
LP1	Frequency of operation in OD mode ^[1]	—	—	—	—	—
LP1	lpspi0~lpspi1 medium speed pad ^[1]	—	—	25	MHz	Peripheral Tx in OD mode
LP1	lpspi0~lpspi1 slow speed pad ^[1]	—	—	12.5	MHz	Peripheral Tx in OD mode
LP1	lpspi0~lpspi1 medium speed pad	—	—	50	MHz	Peripheral Rx in OD mode
LP1	lpspi0~lpspi1 slow speed pad	—	—	25	MHz	Peripheral Rx in OD mode
LP1	lpspi0~lpspi1 medium speed pad	—	—	12	MHz	Peripheral Tx in MD mode
LP1	lpspi0~lpspi1 slow speed pad	—	—	12	MHz	Peripheral Tx in MD mode
LP1	lpspi0~lpspi1 medium speed pad	—	—	12	MHz	Peripheral Rx in MD mode
LP1	lpspi0~lpspi1 slow speed pad	—	—	12	MHz	Peripheral Rx in MD mode
LP2	SPSCK period	4 x tperiph	—	2048 x tperiph	ns	—
LP3	Enable lead time ^[2]	1	—	—	tperiph	—

Table continues on the next page...

Table 40. LPSPi peripheral mode timing...continued

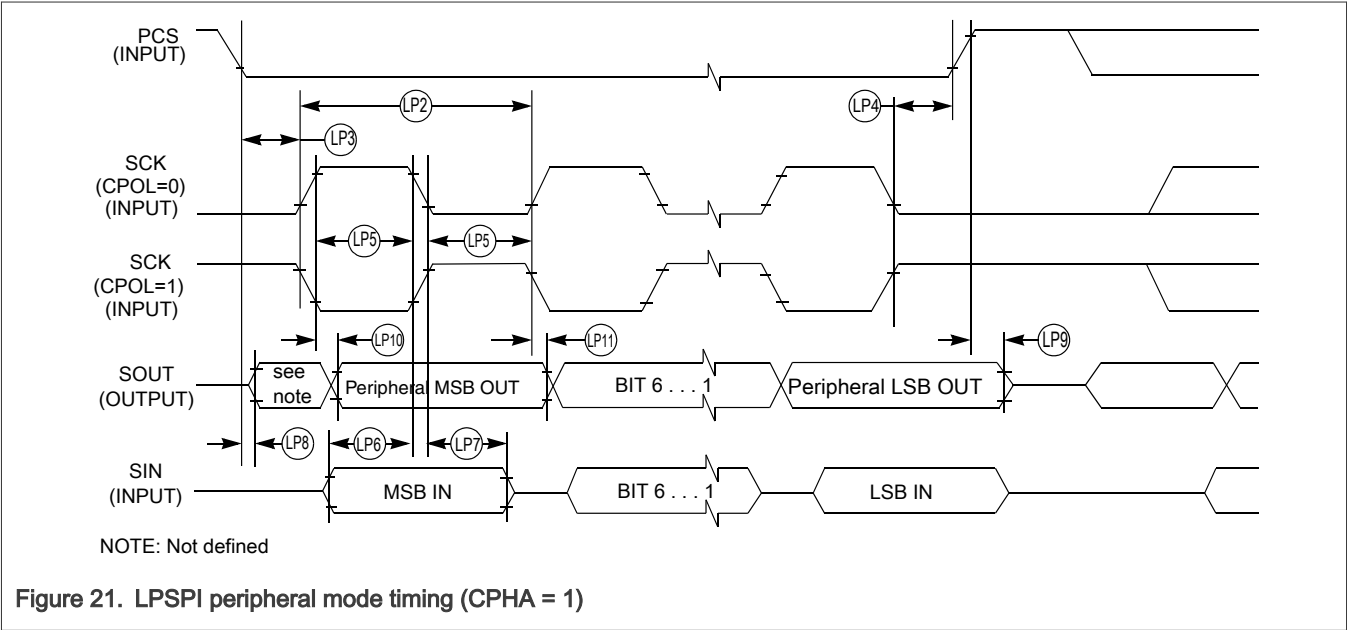
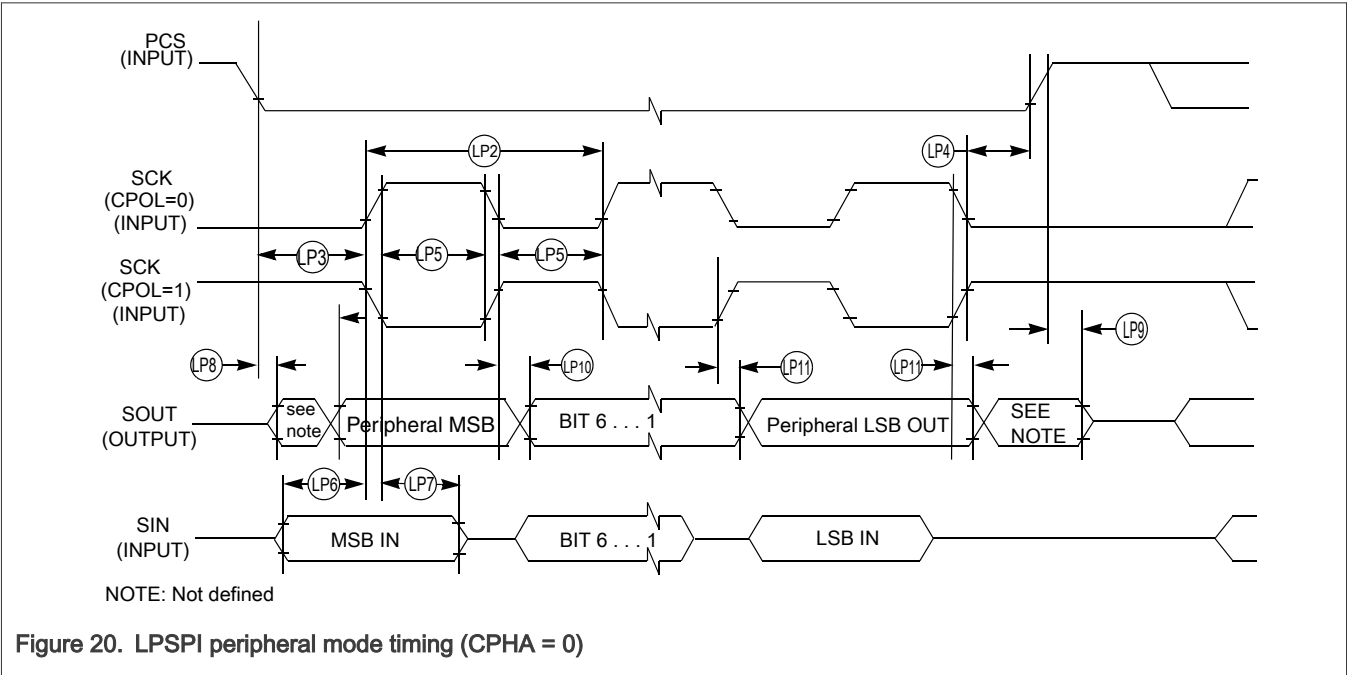
Symbol	Description	Min	Typ	Max	Unit	Condition
LP4	Enable lag time ^[2]	1	—	—	t _{periph}	—
LP5	Clock (SPSCK) high or low time	t _{SPSCK/2 - 5}	—	t _{SPSCK/2}	ns	—
LP6	Data setup time (inputs)	—	—	—	ns	—
LP6	lpspi0~lpspi1 medium speed pad	—	—	3.6	ns	Peripheral Rx in OD mode
LP6	lpspi0~lpspi1 slow speed pad	—	—	7.2	ns	Peripheral Rx in OD mode
LP6	lpspi0~lpspi1 medium speed pad	—	—	12.8	ns	Peripheral Rx in MD mode
LP6	lpspi0~lpspi1 slow speed pad	—	—	12.8	ns	Peripheral Rx in MD mode
LP7	Data hold time (inputs)	—	—	—	ns	—
LP7	lpspi0~lpspi1 medium speed pad	0	—	—	ns	Peripheral Rx in OD mode
LP7	lpspi0~lpspi1 slow speed pad	0	—	—	ns	Peripheral Rx in OD mode
LP7	lpspi0~lpspi1 medium speed pad	0	—	—	ns	Peripheral Rx in MD mode
LP7	lpspi0~lpspi1 slow speed pad	0	—	—	ns	Peripheral Rx in MD mode
LP8	Peripheral access time ^{[2][3]}	—	—	t _{periph}	ns	—
LP9	Peripheral MISO disable time ^[2] ^[4]	—	—	t _{periph}	ns	—
LP10	Data valid (after SPSCK edge)	—	—	—	ns	—
LP10	lpspi0~lpspi1 medium speed pad	—	—	15.6	ns	Peripheral Tx in OD mode
LP10	lpspi0~lpspi1 slow speed pad	—	—	31.2	—	Peripheral Tx in OD mode
LP10	lpspi0~lpspi1 medium speed pad	—	—	29.2	ns	Peripheral Tx in MD mode
LP10	lpspi0~lpspi1 slow speed pad	—	—	29.2	ns	Peripheral Tx in MD mode
LP11	Data hold time (outputs)	—	—	—	ns	—
LP11	lpspi0~lpspi1 medium speed pad	2	—	—	ns	Peripheral Tx in OD mode
LP11	lpspi0~lpspi1 slow speed pad	2	—	—	ns	Peripheral Tx in OD mode

Table continues on the next page...

Table 40. LPSPi peripheral mode timing...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
LP11	lpspi0~lpspi1 medium speed pad	2	—	—	ns	Peripheral Tx in MD mode
LP11	lpspi0~lpspi1 slow speed pad	2	—	—	ns	Peripheral Tx in MD mode

- [1] The frequency of operation is also limited to a minimum of fperiph/2048 and a max of fperiph/4, where fperiph is the LPSPi peripheral functional clock.
[2] tperiph = 1/fperiph
[3] Time to data active from high-impedance state
[4] Hold time to high-impedance state



4.6.3 I2C timing

Table 41. I2C timing

Symbol	Description	Min	Typ	Max	Unit	Condition
fSCL	SCL Clock Frequency in standard mode	0	—	100	kHz	—
fSCL	SCL Clock Frequency in fast mode	0	—	400	kHz	—
tHD; STA	Hold time (repeated) START condition. After this period, the first clock pulse is generated in standard mode	4	—	—	μs	—
tHD; STA	Hold time (repeated) START condition. After this period, the first clock pulse is generated in fast mode	0.6	—	—	μs	—
tLOW	LOW period of the SCL clock in standard mode	4.7	—	—	μs	—
tLOW	LOW period of the SCL clock in fast mode	1.25	—	—	μs	—
tHIGH	HIGH period of the SCL clock in standard mode	4	—	—	μs	—
tHIGH	HIGH period of the SCL clock in fast mode	0.6	—	—	μs	—
tSU; STA	Set-up time for a repeated START condition in standard mode	4.7	—	—	μs	—
tSU; STA	Set-up time for a repeated START condition in fast mode	0.6	—	—	μs	—
tHD; DAT	Data hold time for I2C bus devices in standard mode ^{[1][2]}	0	—	3.45	μs	—
tHD; DAT	Data hold time for I2C bus devices in fast mode ^{[1][3]}	0	—	0.9	μs	—
tSU; DAT	Data set-up time in standard mode ^[4]	250	—	—	ns	—
tSU; DAT	Data set-up time in fast mode ^{[2][5]}	100A	—	—	ns	—
tr	Rise time of SDA and SCL signals in standard mode ^[6]	—	—	1000	ns	—
tr	Rise time of SDA and SCL signals in fast mode ^[6]	20 + 0.1Cb	—	300	ns	—
tf	Fall time of SDA and SCL signals in standard mode ^[5]	—	—	300	ns	—

Table continues on the next page...

Table 41. LPI2C timing...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
t _f	Fall time of SDA and SCL signal s in fast mode ^[5]	20 +0.1Cb	—	300	ns	—
t _{SU} ; STO	Set-up time for STOP condition in standard mode	4	—	—	μs	—
t _{SU} ; STO	Set-up time for STOP condition in fast mode	0.6	—	—	μs	—
t _{BUF}	Bus free time between STOP and START condition in standard mode	4.7	—	—	μs	—
t _{BUF}	Bus free time between STOP and START condition in fast mode	1.3	—	—	μs	—
t _{SP}	Pulse width of spikes that must be suppressed by the input filter in standard mode	N/A	—	N/A	ns	—
t _{SP}	Pulse width of spikes that must be suppressed by the input filter in fast mode	0	—	50	ns	—

- [1] The controller mode I2C deasserts ACK of an address byte simultaneously with the falling edge of SCL. If no targets acknowledge this address byte, then a negative hold time can result, depending on the edge rates of the SDA and SCL lines.
- [2] The maximum t_{HD}; DAT must be met only if the device does not stretch the LOW period (t_{LOW}) of the SCL signal
- [3] Input signal Slew = 10 ns and Output Load = 50 pF
- [4] Set-up time in slave-transmitter mode is 1 IPBus clock period, if the TX FIFO is empty.
- [5] A Fast mode I2C bus device can be used in a Standard mode I2C bus system, but the requirement t_{SU}; DAT ≥ 250 ns must then be met. This is automatically the case if the device does not stretch the LOW period of the SCL signal. If such a device does stretch the LOW period of the SCL signal, then it must output the next data bit to the SDA line t_{max} + t_{SU}; DAT = 1000 + 250 = 1250 ns (according to the Standard mode I2C bus specification) before the SCL line is released.
- [6] Cb = total capacitance of the one bus line in pF.

4.6.4 I2C 1 Mbps timing

Table 42. I2C 1 Mbps timing

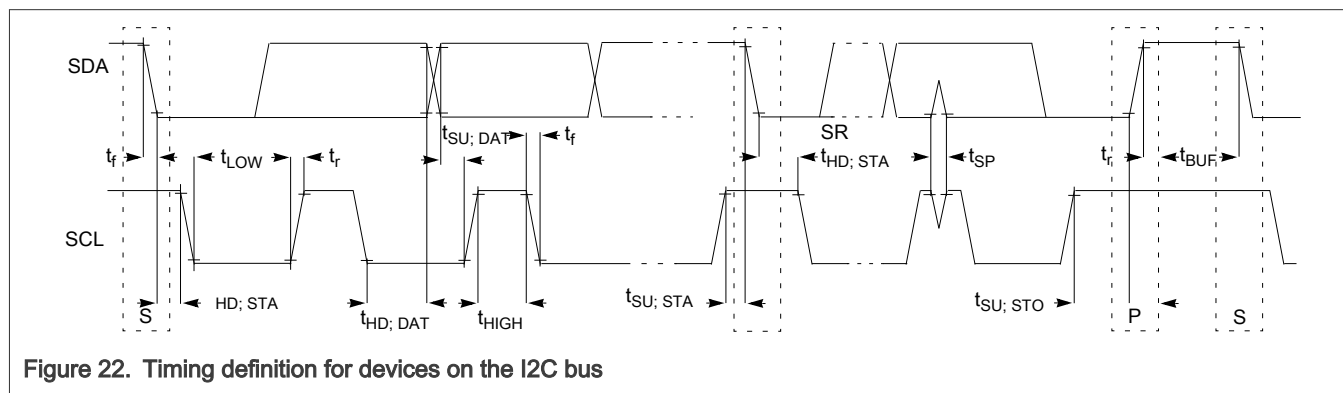
Symbol	Description	Min	Typ	Max	Unit	Condition
f _{SCL}	SCL Clock Frequency	0	—	1	MHz	—
t _{HD} ; STA	Hold time (repeated) START condition. After this period, the first clock pulse is generated.	0.26	—	—	μs	—
t _{LOW}	LOW period of the SCL clock	0.5	—	—	μs	—
t _{HIGH}	HIGH period of the SCL clock	0.26	—	—	μs	—
t _{SU} ; STA	Set-up time for a repeated START condition	0.26	—	—	μs	—
t _{HD} ; DAT	Data hold time for I2C bus devices	0	—	—	μs	—
t _{SU} ; DAT	Data set-up time	50	—	—	ns	—

Table continues on the next page...

Table 42. I2C 1 Mbps timing...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
t_r	Rise time of SDA and SCL signals ^[1]	20 +0.1Cb	—	120	ns	—
t_f	Fall time of SDA and SCL signals ^[1]	20 +0.1Cb	—	120	ns	—
$t_{SU; STO}$	Set-up time for STOP condition	0.26	—	—	μs	—
t_{BUF}	Bus free time between STOP and START condition	0.5	—	—	μs	—
t_{SP}	Pulse width of spikes that must be suppressed by the input filter	0	—	50	ns	—

[1] Cb = total capacitance of the one bus line in pF for maximum value



4.6.5 I2C HS mode timing

Table 43. I2C HS mode timing

Symbol	Description	Min	Typ	Max	Unit	Condition
fSCL	SCL Clock Frequency	0	—	3.4	MHz	—
$t_{HD; STA}$	Hold time (repeated) START condition. After this period, the first clock pulse is generated.	0.26	—	—	μs	—
t_{LOW}	LOW period of the SCL clock	0.5	—	—	μs	—
t_{HIGH}	High period of the SCL clock	0.26	—	—	μs	—
$t_{SU; STA}$	Set-up time for a repeated START condition	0.26	—	—	μs	—
$t_{HD; DAT}$	Data hold time for I2C bus devices ^[1]	0	—	—	μs	—
$t_{SU; DAT}$	Data setup time	34	—	—	ns	—
t_r	Rise time of SDA and SCL signals ^[2]	20 +0.1Cb	—	120	ns	—

Table continues on the next page...

Table 43. I2C HS mode timing...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
t _f	Fall time of SDA and SCL signals ^[2]	20 +0.1Cb	—	120	ns	—
t _{SU; STO}	Setup time for STOP condition	0.26	—	—	μs	—
t _{BUF}	Bus free time between STOP and START condition	0.5	—	—	μs	—
t _{SP}	Pulse width of spikes that must be suppressed by the input filter	0	—	50	ns	—

[1] A device must internally provide a data hold time to bridge the undefined part between VIH and VIL of the falling edge of the SCLH signal. An input circuit with a threshold as low as possible for the falling edge of the SCLH signal minimizes this hold time in maximum value.

[2] Cb = total capacitance of the one bus line in pF. The typical Cb value is 20 pF

4.6.6 I3C Push-Pull Timing Parameters for SDR Mode

Table 44. I3C Push-Pull Timing Parameters for SDR Mode

Symbol	Description	Min	Typ	Max	Measurement Timing	Unit	Condition
fSCL	SCL Clock Frequency	0.01	12.5	12.9	—	MHz	$F_{SCL} = 1 / (t_{DIG_L} + t_{DIG_H})$
t _{DIG_L}	SCL Clock Low Period ^[1]	32	—	—	—	ns	—
t _{DIG_H}	SCL Clock High Period ^[2]	32	—	—	—	ns	—
t _{SCO}	Clock in to Data Out for Target ^{[3][4]}	—	—	12	21.51 ^[5]	ns	in MD mode
					18.09 ^[5]	ns	in OD mode
t _{CR}	SCL Clock Rise Time ^[6]	—	—	150e06 * 1 / fSCL (capped at 60)	—	ns	—
t _{CF}	SCL Clock Fall Time	—	—	—	—	—	—
t _{HD_PP}	SDA Signal Data Hold in Push-Pull Mode, Target ^[7]	0	—	—	—	—	Applicable for target and controller loopback modes
t _{SU_PP}	SDA Signal Data Setup in Push-Pull Mode	3	—	—	—	ns	Applicable for target and controller loopback modes

[1] As both edges are used, the hold time needs to be satisfied for the respective edges; i.e., t_{CF} + 3 for falling edge clocks, and t_{CR} + 3 for rising edge clocks.

[2] t_{DIG_L} and t_{DIG_H} are the clock Low and High periods as seen at the receiver end of the I3C Bus using VIL and VIH (see Figure 30)

[3] Devices with more than 12ns of t_{SCO} delay shall set the limitation bit in the BCR, and shall support the GETMXDS CCC to allow the Controller to read this value and adjust computations accordingly. For purposes of system design and test conformance, this parameter should be considered together with pad delay, bus capacitance, propagation delay, and clock triggering points.

[4] Pad delay based on 90 Ω / 4 mA driver and 50 pF load. Note that Controller may be a Target in a multi-Controller system, and thus shall also adhere to this requirement

[5] Guaranteed by design

[6] The clock maximum rise/fall time is capped at 60 ns. For lower frequency rise and fall the maximum value is limited at 60 ns, and is not dependent upon the clock frequency.

[7] t_{HD_PP} is a Hold time parameter for Push-Pull Mode that has a different value for Controller mode vs. Target mode. In SDR Mode the Hold time parameter is referred to as t_{HD_SDR}.

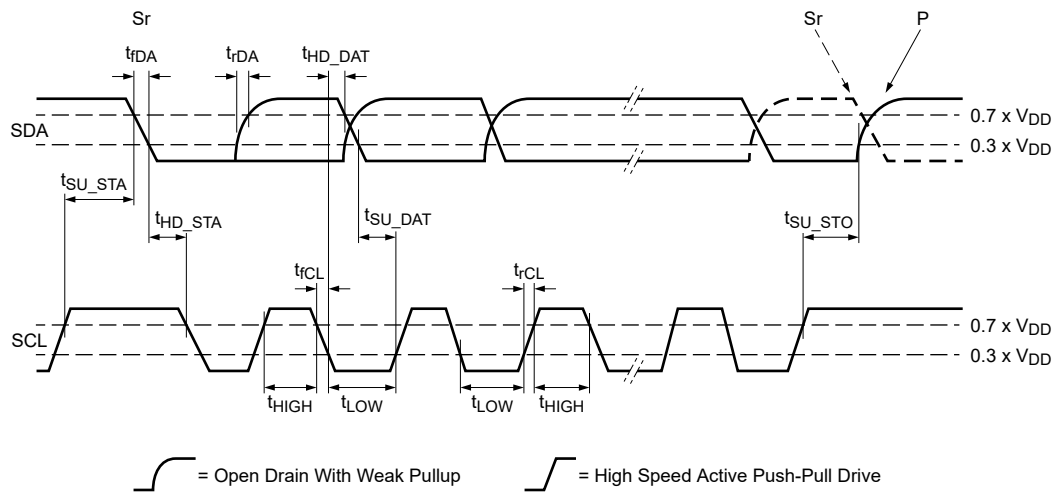


Figure 23. Legacy mode timing

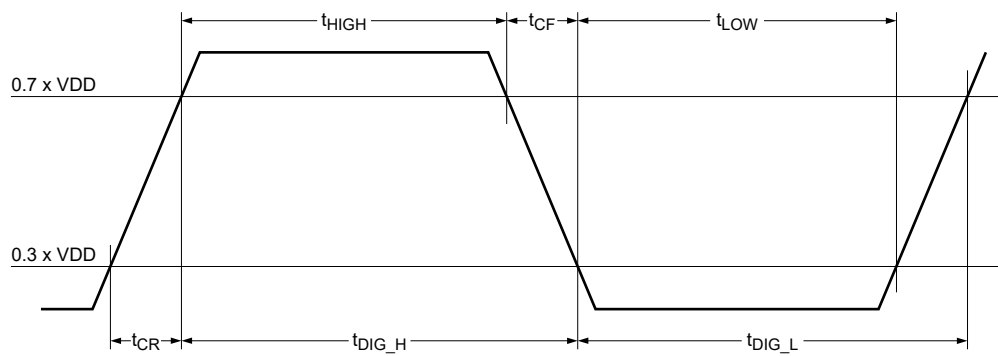


Figure 24. tDIG_H and tDIG_L

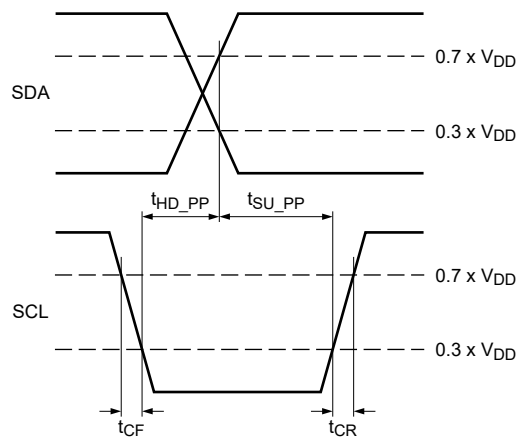


Figure 25. Controller out timing

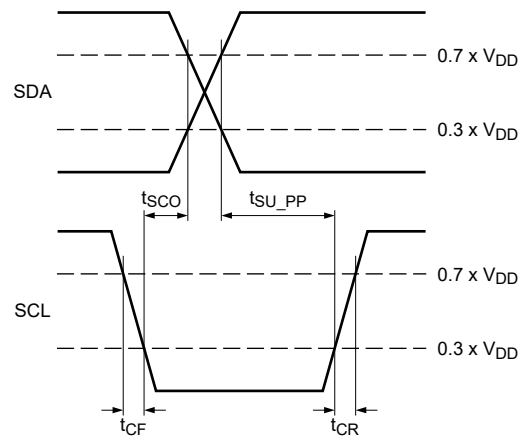


Figure 26. Target out timing

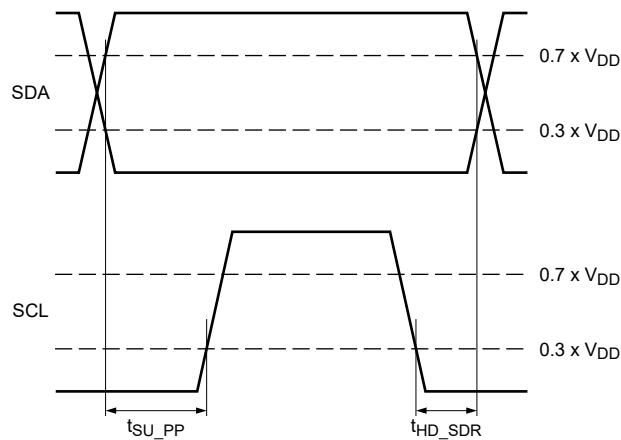


Figure 27. Controller SDR timing

4.6.7 USB Full-speed device electrical specifications

This section describes the USB0 port Full Speed/Low Speed transceiver. The USB0 (FS/LS Transceiver) meets the electrical compliance requirements defined in the Universal Serial Bus Revision 2.0 Specification with the amendments below.

- USB ENGINEERING CHANGE NOTICE
 - Title: 5 V Short Circuit Withstand Requirement Change
 - Applies to: Universal Serial Bus Specification, Revision 2.0
- Errata for USB Revision 2.0 April 27, 2000 as of 12/7/2000
- USB ENGINEERING CHANGE NOTICE
 - Title: Pull-up/Pull-down resistors
 - Applies to: Universal Serial Bus Specification, Revision 2.0
- USB ENGINEERING CHANGE NOTICE
 - Title: Suspend Current Limit Changes
 - Applies to: Universal Serial Bus Specification, Revision 2.0

This SoC does not have a dedicated pin to monitor the state of the USB VBUS signal. Please refer to the USBFS chapter in the Reference Manual for methods which can be used for VBUS Session_Valid detection with either a P4-12/ALT1 pin using an external resistive divider.

4.6.8 Flexible I/O controller (FLEXIO) electrical specifications

The following table shows FlexIO timing specifications.

Table 45. Flexible I/O controller (FLEXIO) electrical specifications

Symbol	Description	Min	Typ	Max	Unit	Condition
tODS	Output delay skew between any two FlexIO_Dx pins configured as outputs that toggle on same internal clock cycle	0	—	8	ns	—
tIDS	Input delay skew between any two FlexIO_Dx pins configured as inputs that are sampled on the same internal clock cycle	0	—	8	ns	—

4.6.9 FlexCAN

See [General switching specifications](#).

4.7 Human Machine Interface (HMI) modules

4.7.1 General Purpose Input/Output (GPIO)

See [General switching specifications](#).

4.7.2 Segment LCD electrical specification

Table 46. Segment LCD electrical specification

Symbol	Description	Min	Typ	Max	Unit	Condition
TJ	Operation temperature	-40	27	115	°C	—
Vvdd_3v	Analog supply voltage	2.7	3	3.3	V	—
Vvdd_lv	Digital supply voltage	0.81	1.1	1.21	V	—
Cbypass	Bypass capacitor for Vlcd_vll2_3v and Vlcd_vll1_3v	80	100	120	nF	—
Rser	Resistance in series with bypass capacitor	—	—	100	Ω	—
Cglass	LCD glass capacitor	—	—	8	nF	—
Fclk	Clock signal	—	16	—	kHz	—
Ivdd_3v	Current consumption at room temp	—	6	—	μA	normal mode
Ivdd_3v	Current consumption at room temp	—	1	—	μA	S&H mode

Table continues on the next page...

Table 46. Segment LCD electrical specification...continued

Symbol	Description	Min	Typ	Max	Unit	Condition
Ishutdown_3v	Leakage current for vdd_3v pin	—	1	—	nA	Disabled
Vlcd_vll3_3v	LCD bias voltage level 3	—	1	—	Vvdd_3v	—
Vlcd_vll2_3v	LCD bias voltage level 2	—	0.67	—	Vvdd_3v	—
Vlcd_vll1_3v	LCD bias voltage level 1	—	0.34	—	Vvdd_3v	—
Vlcd_vll0_3v	LCD bias voltage level 0	—	0	—	Vvdd_3v	—
Vlcd_error	LCD bias voltage error	-50	0	50	mV	—
Vlcd_config_step	LCD bias voltage config step for Vlcd_vll2_3v and Vlcd_vll1_3v	—	1.67%	—	Vvdd_3v	—
Tstart	Startup time	—	—	10	ms	—
Fframe	LCD frame frequency	28	30	58	Hz	—

5 Package dimensions

5.1 Obtaining package dimensions

Package dimensions are provided in package drawings.

To find a package drawing, go to nxp.com and perform a keyword search for the drawing's document number:

If you want the drawing for this package	Then use this document number
WFBGA169	98ASA02230D
LQFP144	98ASS23177W
LQFP100	98ASS23308W
LQFP64	98ASS23234W

6 Pinout

6.1 MCX A345, A346, A355, A356, A365 and A366 Signal Multiplexing and Pin Assignments

The signal multiplexing and pin assignments are provided in an Excel file attached to this document:

1. Click the paperclip symbol on the left side of the PDF window.
2. Double-click on the Excel file to open it.
3. Select the "Pinout" tab.

The Port Control Module is responsible for selecting which ALT functionality is available on each pin.

However, the pinout table is as given below

Table 47. pinmux

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
P1_8	1	B2	1	1	2	2	ALT0 - P1_8 ALT1 - FREQME_CLK_IN0 ALT2 - LPUART1_RXD ALT3 - LPI2C2_SDA ALT4 - CT_INP8 ALT5 - CT0_MAT2 ALT6 - FLEXIO0_D16 ALT7 - SmartDMA_PIO4 ALT9 - LCD_P6 ALT10 - I3C0_SDA	IO Supply - VDD Pad type - HD+I3C Default - DIS	ANALOG - LCD_P6 VDD SYS - WUU0_IN10
P1_9	2	B1	2	2	3	3	ALT0 - P1_9 ALT1 - FREQME_CLK_IN1 ALT2 - LPUART1_TXD ALT3 - LPI2C2_SCL ALT4 - CT_INP9 ALT5 - CT0_MAT3 ALT6 - FLEXIO0_D17 ALT7 - SmartDMA_PIO5 ALT9 - LCD_P7 ALT10 - I3C0_SCL	IO Supply - VDD Pad type - HD Default - DIS	ANALOG - LCD_P7
P1_10	3	C2	3	3	4	4	ALT0 - P1_10 ALT2 - LPUART1_RTS_B ALT3 - LPI2C2_SDAS ALT4 - CT2_MAT0 ALT6 - FLEXIO0_D18 ALT7 - SmartDMA_PIO6 ALT8 - LPUART5_TXD ALT9 - LCD_P8 ALT11 - CAN0_TXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A8/LCD_P8
P1_11	4	C1	4	4	5	5	ALT0 - P1_11 ALT1 - TRIG_OUT2 ALT2 - LPUART1_CTS_B ALT3 - LPI2C2_SCLS	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A9/LCD_P9 VDD SYS - WUU0_IN11

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT4 - CT2_MAT1 ALT6 - FLEXIO0_D19 ALT7 - SmartDMA_PIO7 ALT8 - LPUART5_RXD ALT9 - LCD_P9 ALT10 - I3C0_PUR ALT11 - CAN0_RXD		
P1_12	5	D4	5	5	6	6	ALT0 - P1_12 ALT2 - LPI2C1_SDA ALT3 - LPUART2_RXD ALT4 - CT2_MAT2 ALT6 - FLEXIO0_D20 ALT7 - SmartDMA_PIO8 ALT8 - LPUART5_CTS_B ALT9 - LCD_P10 ALT11 - CAN1_RXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A10/LCD_P10 VDD SYS - WUU0_IN12
P1_13	6	D1	6	6	7	7	ALT0 - P1_13 ALT1 - TRIG_IN3 ALT2 - LPI2C1_SCL ALT3 - LPUART2_TXD ALT4 - CT2_MAT3 ALT6 - FLEXIO0_D21 ALT7 - SmartDMA_PIO9 ALT8 - LPUART5_RTS_B ALT9 - LCD_P11 ALT11 - CAN1_TXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A11/LCD_P11
P1_14	7	E2	7	7	--	--	ALT0 - P1_14 ALT2 - LPI2C1_SCLS ALT3 - LPUART2_RTS_B ALT5 - CT3_MAT0 ALT6 - FLEXIO0_D22 ALT7 - SmartDMA_PIO10 ALT9 - LCD_P12	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A12/LCD_P12

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
P1_15	8	E1	8	8	--	--	ALT0 - P1_15 ALT2 - LPI2C1_SDAS ALT3 - LPUART2_CTS_B ALT5 - CT3_MAT1 ALT6 - FLEXIO0_D23 ALT7 - SmartDMA_PIO11 ALT9 - LCD_P13	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A13/LCD_P13 VDD SYS - WUU0_IN13
P1_16	9	D2	--	--	--	--	ALT0 - P1_16 ALT4 - CT_INP12 ALT6 - FLEXIO0_D24 ALT7 - SmartDMA_PIO12 ALT8 - LPUART5_RXD ALT9 - LCD_P14 ALT11 - CAN1_RXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A14/LCD_P14 VDD SYS - WUU0_IN14
P1_17	10	D3	--	--	--	--	ALT0 - P1_17 ALT4 - CT_INP13 ALT6 - FLEXIO0_D25 ALT7 - SmartDMA_PIO13 ALT8 - LPUART5_TXD ALT9 - LCD_P15 ALT11 - CAN1_TXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A15/LCD_P15
P1_18	11	E4	--	--	--	--	ALT0 - P1_18 ALT1 - FREQME_CLK_IN0 ALT4 - CT3_MAT0 ALT6 - FLEXIO0_D26 ALT7 - SmartDMA_PIO14 ALT8 - LPUART5_RTS_B ALT11 - CAN0_TXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A16
P1_19	12	E3	--	--	--	--	ALT0 - P1_19 ALT1 - FREQME_CLK_IN1	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A17 VDD SYS - WUU0_IN15

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT4 - CT3_MAT1 ALT6 - FLEXIO0_D27 ALT7 - SmartDMA_PIO15 ALT8 - LPUART5_CTS_B ALT11 - CAN0_RXD		
P1_29	13	F2	9	9	8	8	ALT0 - P1_29 ALT1 - RESET_B ALT2 - SPC_LPREQ	IO Supply - VDD Pad type - RST Default - ALT1	VDD SYS - RESET_B
P1_30	14	F1	10	10	9	9	ALT0 - P1_30 ALT1 - TRIG_OUT3 ALT3 - LPI2C0_SDA ALT4 - CT_INP16 ALT6 - FLEXIO0_D30 ALT10 - I3C0_SDA	IO Supply - VDD Pad type - HD+I3C Default - DIS	ANALOG - XTAL48M
P1_31	15	G1	11	11	10	10	ALT0 - P1_31 ALT1 - TRIG_IN4 ALT3 - LPI2C0_SCL ALT4 - CT_INP17 ALT6 - FLEXIO0_D31 ALT10 - I3C0_SCL	IO Supply - VDD Pad type - HD Default - DIS	ANALOG - EXTAL48M
VSS	16	C3	12	12	11	11		IO Supply - VDD	
VREFL	17	H5	12	12	11	11		IO Supply - VDD	
VREFH	18	G5	13	13	12	12		IO Supply - VDD	
VDD_ANA	19	G6	14	14	12	12		IO Supply - VDD	
VDD	20	E5	15	15	13	13		IO Supply - VDD	
P4_0	21	H1	--	--	--	--	ALT0 - P4_0 ALT1 - TRIG_IN5 ALT5 - PWM0_A3 ALT6 - FLEXIO0_D8 ALT7 - SmartDMA_PIO20	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC2_A16
P4_1	22	H2	--	--	--	--	ALT0 - P4_1	IO Supply - VDD	ANALOG - ADC2_A17

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT5 - PWM0_B3 ALT6 - FLEXIO0_D9 ALT7 - SmartDMA_PIO21	Pad type - MED Default - DIS	
P4_2	23	J1	16	16	--	--	ALT0 - P4_2 ALT1 - CLKOUT ALT2 - LPI2C2_SDAS ALT3 - LPUART3_RXD ALT4 - CT4_MAT0 ALT5 - PWM0_A2 ALT6 - FLEXIO0_D10 ALT7 - SmartDMA_PIO22	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC2_A18 VDD SYS - WUU0_IN16
P4_3	24	J2	17	17	--	--	ALT0 - P4_3 ALT2 - LPI2C2_SCL ALT3 - LPUART4_TXD ALT4 - CT4_MAT1 ALT5 - PWM0_B2 ALT6 - FLEXIO0_D11 ALT7 - SmartDMA_PIO23	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC2_A19
P4_4	25	K1	18	18	--	--	ALT0 - P4_4 ALT2 - LPI2C2_SDA ALT3 - LPUART4_RXD ALT4 - CT4_MAT2 ALT5 - PWM0_A1 ALT6 - FLEXIO0_D12 ALT7 - SmartDMA_PIO24	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC2_A20 VDD SYS - WUU0_IN17
P4_5	26	K2	19	19	--	--	ALT0 - P4_5 ALT1 - TRIG_OUT3 ALT2 - LPI2C2_SCLS ALT3 - LPUART3_TXD ALT4 - CT4_MAT3 ALT5 - PWM0_B1	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC2_A21

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT6 - FLEXIO0_D13 ALT7 - SmartDMA_PIO25		
P4_6	27	L1	20	20	--	--	ALT0 - P4_6 ALT1 - TRIG_IN4 ALT2 - LPI2C2_HREQ ALT3 - LPUART3_CTS_B ALT4 - CT_INP6 ALT5 - PWM0_A0 ALT6 - FLEXIO0_D14 ALT7 - SmartDMA_PIO26	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC2_A22
P4_7	28	L2	21	21	--	--	ALT0 - P4_7 ALT1 - TRIG_IN5 ALT3 - LPUART3_RTS_B ALT4 - CT_INP7 ALT5 - PWM0_B0 ALT6 - FLEXIO0_D15 ALT7 - SmartDMA_PIO27	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC2_A23
NC	29	--	--	--	--	--			
NC	30	--	--	--	--	--			
NC	31	--	--	--	--	--			
NC	32	--	--	--	--	--			
P2_0	33	M1	22	22	14	14	ALT0 - P2_0 ALT1 - TRIG_IN6 ALT2 - LPUART0_RXD ALT3 - LPUART4_CTS_B ALT4 - CT_INP16 ALT5 - CT2_MAT0 ALT6 - FLEXIO0_D8 ALT7 - SmartDMA_PIO24 ALT11 - CAN1_RXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC0_A0/OPAMP2_INP VDD SYS - WUU0_IN18

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
P2_1	34	N1	23	23	15	15	ALT0 - P2_1 ALT1 - TRIG_IN7 ALT2 - LPUART0_TXD ALT3 - LPUART4_RTS_B ALT4 - CT_INP17 ALT5 - CT2_MAT1 ALT6 - FLEXIO0_D9 ALT7 - SmartDMA_PIO25 ALT11 - CAN1_TXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A0/OPAMP2_INN
P2_2	35	M2	24	24	16	16	ALT0 - P2_2 ALT1 - TRIG_IN6 ALT2 - LPUART0_RTS_B ALT3 - LPUART2_TXD ALT4 - CT_INP12 ALT5 - CT2_MAT2 ALT6 - FLEXIO0_D10 ALT7 - SmartDMA_PIO26	IO Supply - VDD Pad type - SLOW Default - DIS	ISP - UART_TXD ANALOG - ADC0_A4/ CMP0_IN0/DAC0_OUT/ CMP1_INN4/CMP2_INN4
P2_3	36	N2	25	25	17	17	ALT0 - P2_3 ALT1 - TRIG_IN7 ALT2 - LPUART0_CTS_B ALT3 - LPUART2_RXD ALT4 - CT_INP13 ALT5 - CT2_MAT3 ALT6 - FLEXIO0_D11 ALT7 - SmartDMA_PIO27	IO Supply - VDD Pad type - SLOW Default - DIS	ISP - UART_RXD ANALOG - ADC0_A3/ CMP1_IN0/ADC1_A4 VDD SYS - WUU0_IN19
P2_4	37	M3	26	26	18	18	ALT0 - P2_4 ALT3 - LPUART2_CTS_B ALT4 - CT_INP14 ALT5 - CT1_MAT0 ALT6 - FLEXIO0_D12 ALT7 - SmartDMA_PIO28	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC0_A1/ ADC2_A0/CMP2_IN0

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Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
P2_5	38	N3	27	27	19	19	ALT0 - P2_5 ALT3 - LPUART2_RTS_B ALT4 - CT_INP15 ALT5 - CT1_MAT1 ALT6 - FLEXIO0_D13 ALT7 - SmartDMA_PIO29	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A1/ADC3_A0
P2_6	39	M4	28	28	20	20	ALT0 - P2_6 ALT1 - TRIG_OUT4 ALT2 - LPSP11_PCS1 ALT3 - LPUART4_RXD ALT4 - CT_INP18 ALT5 - CT1_MAT2 ALT6 - FLEXIO0_D14 ALT7 - SmartDMA_PIO30	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A3/ ADC2_A2/ OPAMP2_OUT/ CMP2_INP4
P2_7	40	N4	29	29	21	21	ALT0 - P2_7 ALT1 - TRIG_IN5 ALT3 - LPUART4_TXD ALT4 - CT_INP19 ALT5 - CT1_MAT3 ALT6 - FLEXIO0_D15 ALT7 - SmartDMA_PIO31	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - VREFI/ ADC1_A7/ADC3_A7/ ADC0_A7/ADC2_A7
P2_8	41	L4	--	--	--	--	ALT0 - P2_8 ALT1 - TRIG_OUT3 ALT4 - CT3_MAT0 ALT6 - FLEXIO0_D16	IO Supply - VDD Pad type - SLOW Default - DIS	
P2_9	42	K5	--	--	--	--	ALT0 - P2_9 ALT1 - TRIG_IN4 ALT4 - CT3_MAT1 ALT6 - FLEXIO0_D17	IO Supply - VDD Pad type - SLOW Default - DIS	
P2_10	43	L5	30	30	--	--	ALT0 - P2_10 ALT1 - TRIG_OUT5 ALT3 - LPUART2_TXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC2_A1

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT4 - CT3_MAT2 ALT6 - FLEXIO0_D18 ALT7 - SmartDMA_PIO14		
P2_11	44	K6	31	31	--	--	ALT0 - P2_11 ALT1 - TRIG_IN4 ALT3 - LPUART2_RXD ALT4 - CT3_MAT3 ALT6 - FLEXIO0_D19 ALT7 - SmartDMA_PIO15	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A1
VSS	45	C11	32	32	--	--		IO Supply - VDD	
VDD	46	E6	33	33	--	--		IO Supply - VDD	
P2_12	47	M5	34	34	22	22	ALT0 - P2_12 ALT1 - USB0_VBUS_DET ALT2 - LPSP11_SCK ALT3 - LPUART1_RXD ALT4 - CT4_MAT0 ALT5 - CT0_MAT0 ALT6 - FLEXIO0_D20 ALT7 - SmartDMA_PIO16 ALT11 - CAN0_RXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC0_A5/ ADC2_A5/OPAMP0_INP VDD SYS - WUU0_IN20
P2_13	48	N5	35	35	23	23	ALT0 - P2_13 ALT1 - TRIG_IN8 ALT2 - LPSP11_SDO ALT3 - LPUART1_TXD ALT4 - CT4_MAT1 ALT5 - CT0_MAT1 ALT6 - FLEXIO0_D21 ALT7 - SmartDMA_PIO17 ALT11 - CAN0_TXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A5/ ADC3_A5/OPAMP0_INN
P2_14	49	L6	--	--	--	--	ALT0 - P2_14	IO Supply - VDD	

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT4 - CT4_MAT2 ALT6 - FLEXIO0_D22	Pad type - SLOW Default - DIS	
P2_15	50	M6	36	36	24	24	ALT0 - P2_15 ALT1 - TRIG_OUT4 ALT2 - LPSP11_SDI ALT3 - LPUART1_RTS_B ALT4 - CT4_MAT3 ALT5 - CT0_MAT2 ALT6 - FLEXIO0_D23 ALT7 - SmartDMA_PIO18 ALT11 - CAN1_RXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - OPAMP0_OUT/ ADC0_A2/CMP0_INP4 VDD SYS - WUU0_IN21
P2_16	51	N6	37	37	--	25	ALT0 - P2_16 ALT2 - LPSP11_SDI ALT3 - LPUART1_RTS_B ALT4 - CT3_MAT0 ALT5 - CT0_MAT2 ALT6 - FLEXIO0_D24 ALT7 - SmartDMA_PIO19 ALT11 - CAN1_TXD	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC0_A6/ ADC2_A4/OPAMP1_INP
P2_17	52	N7	38	38	--	26	ALT0 - P2_17 ALT1 - TRIG_IN9 ALT2 - LPSP11_PCS0 ALT3 - LPUART1_CTS_B ALT4 - CT3_MAT1 ALT5 - CT0_MAT3 ALT6 - FLEXIO0_D25 ALT7 - SmartDMA_PIO20	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A6/ ADC3_A4/OPAMP1_INN
P2_18	53	K8	--	--	--	--	ALT0 - P2_18 ALT4 - CT3_MAT2 ALT6 - FLEXIO0_D26	IO Supply - VDD Pad type - SLOW Default - DIS	

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
P2_19	54	M7	39	39	--	27	ALT0 - P2_19 ALT1 - TRIG_OUT5 ALT4 - CT3_MAT3 ALT6 - FLEXIO0_D27 ALT7 - SmartDMA_PIO21	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A2/ OPAMP1_OUT/ CMP1_INP4
P2_20	55	N8	40	40	--	--	ALT0 - P2_20 ALT1 - TRIG_IN8 ALT2 - LPSP11_PCS2 ALT4 - CT2_MAT0 ALT6 - FLEXIO0_D28 ALT7 - SmartDMA_PIO22	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC2_A6/OPAMP3_INP
P2_21	56	M8	41	41	--	--	ALT0 - P2_21 ALT1 - TRIG_IN9 ALT2 - LPSP11_PCS3 ALT4 - CT2_MAT1 ALT6 - FLEXIO0_D29 ALT7 - SmartDMA_PIO23	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A6/OPAMP3_INN
P2_22	57	L8	--	--	--	--	ALT0 - P2_22 ALT4 - CT2_MAT2 ALT6 - FLEXIO0_D30	IO Supply - VDD Pad type - SLOW Default - DIS	
P2_23	58	N9	42	42	--	--	ALT0 - P2_23 ALT1 - TRIG_OUT5 ALT4 - CT2_MAT3 ALT6 - FLEXIO0_D31	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A2/ OPAMP3_OUT/ CMP0_INN4
P2_24	59	M9	--	43	--	--	ALT0 - P2_24 ALT1 - TRIG_OUT6 ALT4 - CT_INP8	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC2_A3
P2_25	60	K9	--	44	--	--	ALT0 - P2_25 ALT1 - TRIG_OUT7 ALT4 - CT_INP9	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A3
P2_26	61	L9	--	45	--	--	ALT0 - P2_26	IO Supply - VDD	

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT1 - TRIG_IN5 ALT4 - CT_INP10	Pad type - SLOW Default - DIS	
NC	62	--	--	--	--	--			
VSS	63	L3	--	--	--	--		IO Supply - VDD	
VDD	64	E8	--	--	--	--		IO Supply - VDD	
VDD_USB	65	N11	43	--	25	--		IO Supply - VDD_USB	
USB0_DM	66	N10	44	--	26	--		IO Supply - VDD_USB Pad type - ANA	ANALOG - USB0_DM VDD SYS - WUU0_IN28
USB0_DP	67	M10	45	--	27	--		IO Supply - VDD_USB Pad type - ANA	ANALOG - USB0_DP VDD SYS - WUU0_IN29
VSS	68	L11	46	46	28	28		IO Supply - VDD	
VDD	69	E9	47	47	29	29		IO Supply - VDD	
P3_31	70	M12	48	48	30	30	ALT0 - P3_31 ALT1 - TRIG_IN10 ALT2 - LPI2C3_SDAS ALT3 - LPUART4_CTS_B ALT4 - CT0_MAT3 ALT6 - FLEXIO0_D31 ALT7 - PWM1_B0 ALT10 - SmartDMA_PIO31	IO Supply - VDD Pad type - SLOW+TAM Default - DIS	ANALOG - ADC1_A20 VDD SYS - LPTMR0_ALT2/ TAMPER0
P3_30	71	N12	49	49	31	31	ALT0 - P3_30 ALT1 - TRIG_OUT6 ALT2 - LPI2C3_SCLS ALT3 - LPUART4_RTS_B ALT4 - CT0_MAT2 ALT6 - FLEXIO0_D30 ALT7 - PWM1_A0 ALT10 - SmartDMA_PIO30	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC1_A21
P3_29	72	N13	50	50	32	32	ALT0 - P3_29 ALT1 - ISPMODE_N ALT2 - LPI2C3_HREQ	IO Supply - VDD Pad type - SLOW+TAM Default - DIS	ANALOG - ADC1_A22 VDD SYS - WUU0_IN27/TAMPER1

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Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT4 - CT_INP3 ALT5 - CT3_MAT3 ALT6 - FLEXIO0_D29 ALT10 - SmartDMA_PIO29		
P3_28	73	M13	51	51	33	33	ALT0 - P3_28 ALT1 - TRIG_IN11 ALT2 - LPI2C3_SDA ALT3 - LPUART4_RXD ALT4 - CT_INP12 ALT5 - CT3_MAT2 ALT6 - FLEXIO0_D28 ALT7 - PWM1_B3 ALT10 - SmartDMA_PIO28	IO Supply - VDD Pad type - 5VTOL Default - DIS	VDD SYS - WUU0_IN26
P3_27	74	L12	52	52	34	34	ALT0 - P3_27 ALT1 - TRIG_OUT7 ALT2 - LPI2C3_SCL ALT3 - LPUART4_TXD ALT4 - CT_INP13 ALT5 - CT3_MAT1 ALT6 - FLEXIO0_D27 ALT7 - PWM1_A3 ALT10 - SmartDMA_PIO27	IO Supply - VDD Pad type - 5VTOL Default - DIS	VDD SYS - WUU0_IN30
P3_26	75	L13	--	--	--	--	ALT0 - P3_26 ALT1 - TRIG_IN10 ALT4 - CT_INP14 ALT6 - FLEXIO0_D26 ALT10 - SmartDMA_PIO26	IO Supply - VDD Pad type - SLOW+TAM Default - DIS	VDD SYS - TAMPER2
P3_25	76	K12	--	--	--	--	ALT0 - P3_25 ALT1 - TRIG_OUT6 ALT4 - CT_INP15 ALT6 - FLEXIO0_D25	IO Supply - VDD Pad type - SLOW+TAM Default - DIS	ANALOG - ADC3_A23 VDD SYS - TAMPER3

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Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT10 - SmartDMA_PIO25		
P3_24	77	K13	--	--	--	--	ALT0 - P3_24 ALT1 - TRIG_IN11 ALT4 - CT_INP16 ALT6 - FLEXIO0_D24 ALT10 - SmartDMA_PIO24	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A22
NC	78	--	--	--	--	--			
NC	79	--	--	--	--	--			
P3_23	80	J12	--	--	--	--	ALT0 - P3_23 ALT3 - LPUART1_CTS_B ALT4 - CT_INP11 ALT6 - FLEXIO0_D31 ALT7 - PWM1_X3 ALT10 - SmartDMA_PIO23	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A21
P3_22	81	J13	53	53	--	--	ALT0 - P3_22 ALT3 - LPUART1_RTS_B ALT4 - CT_INP10 ALT6 - FLEXIO0_D30 ALT7 - PWM1_X2 ALT10 - SmartDMA_PIO22	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A20
P3_21	82	H12	54	54	--	--	ALT0 - P3_21 ALT1 - TRIG_OUT1 ALT2 - LPI2C3_SCL ALT3 - LPUART1_TXD ALT4 - CT2_MAT3 ALT5 - PWM0_X3 ALT6 - FLEXIO0_D29 ALT7 - PWM1_B3 ALT10 - SmartDMA_PIO21	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A19
P3_20	83	H13	55	55	--	--	ALT0 - P3_20	IO Supply - VDD	ANALOG - ADC3_A18

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Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT1 - TRIG_OUT0 ALT2 - LPI2C3_SDA ALT3 - LPUART1_RXD ALT4 - CT2_MAT2 ALT5 - PWM0_X2 ALT6 - FLEXIO0_D28 ALT7 - PWM1_A3 ALT10 - SmartDMA_PIO20	Pad type - SLOW Default - DIS	
NC	84	--	--	--	--	--			
P3_19	85	J11	56	56	--	--	ALT0 - P3_19 ALT2 - LPUART4_TXD ALT4 - CT2_MAT1 ALT5 - PWM0_X1 ALT6 - FLEXIO0_D27 ALT7 - PWM1_X1 ALT9 - LCD_P47 ALT10 - SmartDMA_PIO19	IO Supply - VDD Pad type - SLOW+TAM Default - DIS	ANALOG - LCD_P47 VDD SYS - TAMPER4
P3_18	86	J10	57	57	--	--	ALT0 - P3_18 ALT2 - LPUART4_RXD ALT4 - CT2_MAT0 ALT5 - PWM0_X0 ALT6 - FLEXIO0_D26 ALT7 - PWM1_X0 ALT9 - LCD_P46 ALT10 - SmartDMA_PIO18	IO Supply - VDD Pad type - SLOW+TAM Default - DIS	ANALOG - LCD_P46 VDD SYS - TAMPERS5
P3_17	87	H11	58	58	--	--	ALT0 - P3_17 ALT2 - LPUART4_CTS_B ALT4 - CT_INP9 ALT6 - FLEXIO0_D25 ALT7 - PWM1_B0 ALT9 - LCD_P45	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - LCD_P45

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Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT10 - SmartDMA_PIO17		
P3_16	88	H10	59	59	--	--	ALT0 - P3_16 ALT2 - LPUART4_RTS_B ALT4 - CT_INP8 ALT6 - FLEXIO0_D24 ALT7 - PWM1_A0 ALT9 - LCD_P44 ALT10 - SmartDMA_PIO16	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - LCD_P44
P3_15	89	G13	60	60	35	35	ALT0 - P3_15 ALT2 - LPUART2_TXD ALT3 - LPUART3_RTS_B ALT4 - CT_INP7 ALT5 - PWM0_X3 ALT6 - FLEXIO0_D23 ALT7 - PWM1_B1 ALT9 - LCD_P43 ALT10 - SmartDMA_PIO15	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A17/LCD_P43
P3_14	90	F12	61	61	36	36	ALT0 - P3_14 ALT2 - LPUART2_RXD ALT3 - LPUART3_CTS_B ALT4 - CT_INP6 ALT5 - PWM0_X2 ALT6 - FLEXIO0_D22 ALT7 - PWM1_A1 ALT9 - LCD_P42 ALT10 - SmartDMA_PIO14	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A16/LCD_P42 VDD SYS - WUU0_IN25
P3_13	91	F13	62	62	37	37	ALT0 - P3_13 ALT2 - LPUART2_CTS_B ALT3 - LPUART3_RXD ALT4 - CT1_MAT3 ALT5 - PWM0_X1	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A15/LCD_P41

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Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT6 - FLEXIO0_D21 ALT7 - PWM1_B2 ALT9 - LCD_P41 ALT10 - SmartDMA_PIO13		
P3_12	92	E12	63	63	38	38	ALT0 - P3_12 ALT2 - LPUART2_RTS_B ALT3 - LPUART3_TXD ALT4 - CT1_MAT2 ALT5 - PWM0_X0 ALT6 - FLEXIO0_D20 ALT7 - PWM1_A2 ALT9 - LCD_P40 ALT10 - SmartDMA_PIO12	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A14/LCD_P40
VSS	93	C7	64	64	--	--		IO Supply - VDD	
VDD	94	J5	65	65	--	--		IO Supply - VDD	
P3_11	95	E13	66	66	39	39	ALT0 - P3_11 ALT1 - TRIG_IN6 ALT2 - LPSPI1_PCS0 ALT3 - LPUART1_CTS_B ALT4 - CT1_MAT1 ALT5 - PWM0_B2 ALT6 - FLEXIO0_D19 ALT8 - LPUART5_RXD ALT9 - LCD_P39 ALT10 - SmartDMA_PIO11	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - LCD_P39 VDD SYS - WUU0_IN24
P3_10	96	D13	67	67	40	40	ALT0 - P3_10 ALT1 - TRIG_IN5 ALT2 - LPSPI1_SCK ALT3 - LPUART1_RTS_B ALT4 - CT1_MAT0 ALT5 - PWM0_A2 ALT6 - FLEXIO0_D18	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - LCD_P38

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Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT8 - LPUART5_TXD ALT9 - LCD_P38 ALT10 - SmartDMA_PIO10		
P3_9	97	D12	68	68	41	41	ALT0 - P3_9 ALT1 - TRIG_IN4 ALT2 - LPSP11_SDI ALT3 - LPUART1_TXD ALT4 - CT_INP5 ALT5 - PWM0_B1 ALT6 - FLEXIO0_D17 ALT8 - LPUART5_RTS_B ALT9 - LCD_P37 ALT10 - SmartDMA_PIO9	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - LCD_P37
P3_8	98	C13	69	69	42	42	ALT0 - P3_8 ALT1 - TRIG_IN3 ALT2 - LPSP11_SDO ALT3 - LPUART1_RXD ALT4 - CT_INP4 ALT5 - PWM0_A1 ALT6 - FLEXIO0_D16 ALT8 - LPUART5_CTS_B ALT9 - LCD_P36 ALT10 - SmartDMA_PIO8 ALT12 - CLKOUT	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - LCD_P36 VDD SYS - WUU0_IN23
P3_7	99	C12	70	70	43	43	ALT0 - P3_7 ALT1 - TRIG_IN2 ALT2 - LPSP11_PCS2 ALT3 - LPUART3_CTS_B ALT4 - CT4_MAT3 ALT5 - PWM0_B3 ALT6 - FLEXIO0_D15 ALT7 - PWM1_B0	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC3_A13/LCD_P35

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Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT9 - LCD_P35 ALT10 - SmartDMA_PIO7		
P3_6	100	B13	71	71	44	44	ALT0 - P3_6 ALT1 - CLKOUT ALT2 - LPSP11_PCS3 ALT3 - LPUART3_RTS_B ALT4 - CT4_MAT2 ALT5 - PWM0_A3 ALT6 - FLEXIO0_D14 ALT7 - PWM1_A0 ALT9 - LCD_P34 ALT10 - SmartDMA_PIO6 ALT12 - FREQME_CLK_OUT1	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC3_A12/LCD_P34
P3_5	101	F11	--	--	--	--	ALT0 - P3_5 ALT4 - CT_INP19 ALT5 - PWM0_X3 ALT6 - FLEXIO0_D13 ALT10 - SmartDMA_PIO5	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A11
P3_4	102	F10	--	--	--	--	ALT0 - P3_4 ALT4 - CT_INP18 ALT5 - PWM0_X2 ALT6 - FLEXIO0_D12 ALT10 - SmartDMA_PIO4	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A10
P3_3	103	E11	--	--	--	--	ALT0 - P3_3 ALT4 - CT4_MAT1 ALT5 - PWM0_X1 ALT6 - FLEXIO0_D11 ALT7 - PWM1_X3 ALT10 - SmartDMA_PIO3	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A9

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Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
P3_2	104	E10	--	--	--	--	ALT0 - P3_2 ALT2 - LPSPI1_PCS1 ALT4 - CT4_MAT0 ALT5 - PWM0_X0 ALT6 - FLEXIO0_D10 ALT7 - PWM1_X2 ALT10 - SmartDMA_PIO2	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC3_A8
P3_1	105	B12	72	72	45	45	ALT0 - P3_1 ALT1 - TRIG_IN1 ALT3 - LPUART3_TXD ALT4 - CT_INP17 ALT5 - PWM0_B0 ALT6 - FLEXIO0_D9 ALT7 - PWM1_X1 ALT9 - LCD_P33 ALT10 - SmartDMA_PIO1 ALT12 - FREQME_CLK_OUT0	IO Supply - VDD Pad type - HD Default - DIS	ANALOG - LCD_P33
P3_0	106	A13	73	73	46	46	ALT0 - P3_0 ALT1 - TRIG_IN0 ALT3 - LPUART3_RXD ALT4 - CT_INP16 ALT5 - PWM0_A0 ALT6 - FLEXIO0_D8 ALT7 - PWM1_X0 ALT9 - LCD_P32 ALT10 - SmartDMA_PIO0	IO Supply - VDD Pad type - HD Default - DIS	ANALOG - LCD_P32 VDD SYS - WUU0_IN22
VSS	107	D7	74	74	47	47		IO Supply - VDD	
VDD	108	J6	75	75	48	48		IO Supply - VDD	
P0_0	109	A12	76	76	49	49	ALT0 - P0_0 ALT1 - TMS/SWDIO ALT2 - LPUART0_RTS_B	IO Supply - VDD Pad type - SLOW Default - ALT1	

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA169	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT3 - LPSPI0_PCS0 ALT4 - CT_INP0 ALT6 - FLEXIO0_D0		
P0_1	110	B11	77	77	50	50	ALT0 - P0_1 ALT1 - TCLK/SWCLK ALT2 - LPUART0_CTS_B ALT3 - LPSPI0_SDI ALT4 - CT_INP1 ALT6 - FLEXIO0_D1	IO Supply - VDD Pad type - SLOW Default - ALT1	
P0_2	111	A11	78	78	51	51	ALT0 - P0_2 ALT1 - TDO/SWO ALT2 - LPUART0_RXD ALT3 - LPSPI0_SCK ALT4 - CT0_MAT0 ALT5 - UTICK_CAP0 ALT6 - FLEXIO0_D2 ALT10 - I3C0_PUR	IO Supply - VDD Pad type - SLOW Default - ALT1	ANALOG - ADC2_A8
P0_3	112	D10	79	79	52	52	ALT0 - P0_3 ALT1 - TDI ALT2 - LPUART0_TXD ALT3 - LPSPI0_SDO ALT4 - CT0_MAT1 ALT5 - UTICK_CAP1 ALT6 - FLEXIO0_D3 ALT8 - CMP0_OUT	IO Supply - VDD Pad type - SLOW Default - ALT1	ANALOG - CMP1_IN1/ADC0_A14
P0_4	113	A10	--	--	--	--	ALT0 - P0_4 ALT4 - CT0_MAT2 ALT5 - UTICK_CAP2 ALT6 - FLEXIO0_D4 ALT7 - SmartDMA_PIO0 ALT8 - CMP1_OUT	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC2_A9 VDD SYS - WU0_IN0
P0_5	114	B9	--	--	--	--	ALT0 - P0_5 ALT4 - CT0_MAT3 ALT5 - UTICK_CAP3	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC2_A10

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT6 - FLEXIO0_D5 ALT7 - SmartDMA_PIO1 ALT8 - CMP2_OUT		
P0_6	115	A9	80	80	53	53	ALT0 - P0_6 ALT1 - ISPMODE_N ALT2 - LPI2C0_HREQ ALT3 - LPSPi0_PCS1 ALT4 - CT_INP2 ALT6 - FLEXIO0_D6 ALT7 - SmartDMA_PIO2 ALT8 - CMP1_OUT ALT12 - CLKOUT	IO Supply - VDD Pad type - SLOW Default - ALT1	ISP - ISPMODE_N ANALOG - ADC0_A15
P0_7	116	D11	--	--	--	--	ALT0 - P0_7 ALT4 - CT_INP3 ALT6 - FLEXIO0_D7 ALT7 - SmartDMA_PIO3	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC2_A11/CMP2_IN1 VDD SYS - WUU0_IN1
NC	117	--	--	--	--	--		IO Supply - NC	
VSS	118	E7	--	--	--	--		IO Supply - VDD	
P0_12	119	C10	--	--	--	--	ALT0 - P0_12 ALT4 - CT0_MAT2 ALT6 - FLEXIO0_D4 ALT9 - LCD_P16	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC2_A12/LCD_P16
P0_13	120	B10	--	--	--	--	ALT0 - P0_13 ALT4 - CT0_MAT3 ALT6 - FLEXIO0_D5 ALT9 - LCD_P17	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC2_A13/LCD_P17
P0_14	121	C9	81	81	--	--	ALT0 - P0_14 ALT4 - CT_INP2 ALT5 - UTICK_CAP0 ALT6 - FLEXIO0_D6 ALT7 - SmartDMA_PIO4 ALT9 - LCD_P18	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC2_A14/LCD_P18

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
P0_15	122	D9	82	82	--	--	ALT0 - P0_15 ALT4 - CT_INP3 ALT5 - UTICK_CAP1 ALT6 - FLEXIO0_D7 ALT7 - SmartDMA_PIO5 ALT9 - LCD_P19	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC2_A15/LCD_P19
P0_16	123	B8	83	83	54	54	ALT0 - P0_16 ALT2 - LPI2C0_SDA ALT3 - LPSPi0_PCS2 ALT4 - CT0_MAT0 ALT5 - UTICK_CAP2 ALT6 - FLEXIO0_D0 ALT7 - SmartDMA_PIO6 ALT9 - LCD_P20 ALT10 - I3C0_SDA	IO Supply - VDD Pad type - HD+I3C Default - DIS	ANALOG - LCD_P20 VDD SYS - WUU0_IN2
P0_17	124	A8	84	84	55	55	ALT0 - P0_17 ALT2 - LPI2C0_SCL ALT3 - LPSPi0_PCS3 ALT4 - CT0_MAT1 ALT5 - UTICK_CAP3 ALT6 - FLEXIO0_D1 ALT7 - SmartDMA_PIO7 ALT9 - LCD_P21 ALT10 - I3C0_SCL	IO Supply - VDD Pad type - HD Default - DIS	ANALOG - LCD_P21
P0_18	125	A7	85	85	--	--	ALT0 - P0_18 ALT2 - LPI2C0_SCLS ALT4 - CT0_MAT2 ALT6 - FLEXIO0_D2 ALT7 - SmartDMA_PIO8 ALT8 - CMP0_OUT ALT9 - LCD_P22	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC0_A8/LCD_P22
P0_19	126	B7	86	86	--	--	ALT0 - P0_19 ALT2 - LPI2C0_SDAS ALT4 - CT0_MAT3	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC0_A9/LCD_P23 VDD SYS - WUU0_IN3

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT6 - FLEXIO0_D3 ALT7 - SmartDMA_PIO9 ALT8 - CMP1_OUT ALT9 - LCD_P23		
P0_20	127	A6	87	87	--	--	ALT0 - P0_20 ALT3 - LPUART0_RXD ALT4 - CT_INP0 ALT6 - FLEXIO0_D4 ALT7 - SmartDMA_PIO10 ALT8 - CMP2_OUT ALT9 - LCD_P24	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC0_A10/LCD_P24 VDD SYS - WUU0_IN4
P0_21	128	B6	88	88	--	--	ALT0 - P0_21 ALT3 - LPUART0_TXD ALT4 - CT_INP1 ALT6 - FLEXIO0_D5 ALT7 - SmartDMA_PIO11 ALT9 - LCD_P25	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC0_A11/LCD_P25
P0_22	129	C8	89	89	--	--	ALT0 - P0_22 ALT3 - LPUART0_RTS_B ALT4 - CT_INP2 ALT5 - CT0_MAT0 ALT6 - FLEXIO0_D6 ALT7 - SmartDMA_PIO12 ALT9 - LCD_P26	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC0_A12/LCD_P26
P0_23	130	D8	90	90	--	--	ALT0 - P0_23 ALT3 - LPUART0_CTS_B ALT4 - CT_INP3 ALT5 - CT0_MAT1 ALT6 - FLEXIO0_D7 ALT7 - SmartDMA_PIO13 ALT9 - LCD_P27	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - ADC0_A13/ CMP2_IN2/LCD_P27 VDD SYS - WUU0_IN5

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
P0_24	131	C6	--	--	--	--	ALT0 - P0_24 ALT4 - CT0_MAT0 ALT8 - LPUART5_RXD ALT9 - LCD_P28	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - LCD_P28
P0_25	132	D6	--	--	--	--	ALT0 - P0_25 ALT4 - CT0_MAT1 ALT8 - LPUART5_TXD ALT9 - LCD_P29	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - LCD_P29
P0_26	133	C5	--	--	--	--	ALT0 - P0_26 ALT4 - CT0_MAT2 ALT8 - LPUART5_RTS_B ALT9 - LCD_P30	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - LCD_P30
P0_27	134	D5	--	--	--	--	ALT0 - P0_27 ALT4 - CT0_MAT3 ALT8 - LPUART5_CTS_B ALT9 - LCD_P31	IO Supply - VDD Pad type - SLOW Default - DIS	ANALOG - LCD_P31
P1_0	135	A5	91	91	56	56	ALT0 - P1_0 ALT1 - TRIG_IN0 ALT2 - LPSPI0_SDO ALT3 - LPI2C1_SDA ALT4 - CT_INP4 ALT5 - CT0_MAT2 ALT6 - FLEXIO0_D8 ALT9 - LCD_P0 ALT11 - CAN1_RXD	IO Supply - VDD Pad type - MED+I2C_FILT Default - DIS	ANALOG - ADC0_A16/ CMP0_IN3/LCD_P0 VDD SYS - WUU0_IN6/ LPTMR0_ALT3
P1_1	136	B5	92	92	57	57	ALT0 - P1_1 ALT1 - TRIG_IN1 ALT2 - LPSPI0_SCK ALT3 - LPI2C1_SCL ALT4 - CT_INP5 ALT5 - CT0_MAT3 ALT6 - FLEXIO0_D9 ALT9 - LCD_P1 ALT11 - CAN1_TXD	IO Supply - VDD Pad type - MED+I2C_FILT Default - DIS	ANALOG - ADC0_A17/ CMP1_IN3/LCD_P1

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
P1_2	137	A4	93	93	58	58	ALT0 - P1_2 ALT1 - TRIG_OUT0 ALT2 - LPSPi0_SD1 ALT3 - LPI2C1_SDAS ALT4 - CT1_MAT0 ALT5 - CT_INP0 ALT6 - FLEXIO0_D10 ALT9 - LCD_P2 ALT11 - CAN0_TXD	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC0_A18/ CMP2_IN3/LCD_P2
P1_3	138	B4	94	94	59	59	ALT0 - P1_3 ALT1 - TRIG_OUT1 ALT2 - LPSPi0_PCS0 ALT3 - LPI2C1_SCLS ALT4 - CT1_MAT1 ALT5 - CT_INP1 ALT6 - FLEXIO0_D11 ALT9 - LCD_P3 ALT11 - CAN0_RXD	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC0_A19/ CMP0_IN1/LCD_P3 VDD SYS - WUU0_IN7
VDD	139	J8	95	95	60	60		IO Supply - VDD	
VSS	140	F7	96	96	61	61		IO Supply - VDD	
P1_4	141	A3	97	97	62	62	ALT0 - P1_4 ALT1 - FREQME_CLK_IN0 ALT2 - LPSPi0_PCS3 ALT3 - LPUART2_RXD ALT4 - CT1_MAT2 ALT6 - FLEXIO0_D12 ALT7 - SmartDMA_PiO0	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC0_A20/ CMP0_IN2/LCD_VLL2 VDD SYS - WUU0_IN8
P1_5	142	B3	98	98	63	63	ALT0 - P1_5 ALT1 - FREQME_CLK_IN1 ALT2 - LPSPi0_PCS2 ALT3 - LPUART2_TXD ALT4 - CT1_MAT3 ALT6 - FLEXIO0_D13	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC0_A21/ CMP1_IN2/LCD_VLL1

Table continues on the next page...

Table 47. pinmux...continued

Pin Name	MCXA36x A35xA34x LQFP144	MCXA36x A35xA34x WFBGA16 9	MCXA36x LQFP100	MCXA34x A35x LQFP100	MCXA36x LQFP64	MCXA34x A35x LQFP64	Pinmux Assignment	Pad Settings	Alternate Functions
							ALT7 - SmartDMA_PIO1		
P1_6	143	A2	99	99	64	64	ALT0 - P1_6 ALT1 - TRIG_IN2 ALT2 - LPSPi0_PCS1 ALT3 - LPUART2_RTS_B ALT4 - CT_INP6 ALT5 - CT4_MAT0 ALT6 - FLEXIO0_D14 ALT7 - SmartDMA_PIO2 ALT9 - LCD_P4 ALT11 - CAN1_TXD	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC0_A22/LCD_P4
P1_7	144	A1	100	100	1	1	ALT0 - P1_7 ALT1 - TRIG_OUT2 ALT3 - LPUART2_CTS_B ALT4 - CT_INP7 ALT5 - CT4_MAT1 ALT6 - FLEXIO0_D15 ALT7 - SmartDMA_PIO3 ALT9 - LCD_P5 ALT11 - CAN1_RXD	IO Supply - VDD Pad type - MED Default - DIS	ANALOG - ADC0_A23/LCD_P5 VDD SYS - WUU0_IN9
VSS	--	G7,H7,J7, K7,L7,G2, G3,G4,G10 ,G11,G12, F5,F6,F8,F 9,H6,H8,H 9,M11	--	--	--	--			
VDD	--	J9	--	--	--	--			
NC	--	C4, F3, F4, G8, G9, H3, H4, J3, J4, K3, K4, K10, K11, L10	--	--	--	--			

Note:

- +I3C in Pad Type represents that strong pull up resistor is implemented on the pin. PV bit is implemented in Pin Control register of the pin.

- +I2C_FILT in Pad Type represents that I2C filter is implemented on the pin. PFE bit is implemented in Pin Control register of the pin.
- HD in Pad Type represents that the pin can support up to 20mA drive strength. I2C filter is implemented on the pin. PFE bit is implemented in Pin Control register of the pin.
- 5VTOL in Pad Type represents that the pin is 5V tolerant.
- DIS in default column represents that the pin's input buffer is disabled by default
- RST pads support passive filter and 1M ohm pull resistor. PFE and PV bits are implemented in Pin Control register of the pin.
- PE, PS, SRE, ODE and DSE are supported in Pin Control register of all types of IO.
- 5VTol and HD pads support two DSE bits in Pin Control register of the pin.
- SLOW in Pad Type represents the IO supports 25MHz. MED in Pad Type represents the IO supports 50MHz.
- +TAM in Pad Type represents the IO supports 1M ohm pull resistor.
- USB Pins in LQFP144 and WFBGA169 of MCXA34x/A35x are NC pins.
- CAN1, I3C, FlexIO and SLCD are not available in MCXA34x/A35x.
- USB Pins are NC pins in MCXA34x/A35x

6.2 >MCX A345, A346, A355, A356, A365 and A366 Pinouts

The pinout diagrams are provided in an Excel file attached to this document:

1. Click the paperclip symbol on the left side of the PDF window.
2. Double-click on the Excel file to open it.
3. Select the respective package tab.

Many signals may be multiplexed onto a single pin. To determine what signals can be used on which pin, refer to the "Pinout" tab in the Excel file.

6.3 Recommended connection for unused analog and digital pins

Table 48 shows the recommended connections for pins if those pins are not used in the customer's application

Table 48. Recommended connection for unused analog and digital pins

Pin Type	Pin Function	Recommendation	Comments
Power	VDD	Must be powered	VDD is the IO supply of P0,P1,P2 and P4, and supplies internal modules including Flash, CMP, and etc.. It must be on
Power	VDD_ANA	Must be powered	VDD_ANA must be same level with VDD, and ramps up together with VDD
Power	VDD_USB	Tie to ground through a 10 kΩ resistor if VDD_USB is an independent pin in the package version used	
Power	VREFH	Always connect to VDD_ANA potential	Always connect to VDD_ANA potential
Power	VREFL	Always connect to VSS potential	Always connect to VSS potential

Table continues on the next page...

Table 48. Recommended connection for unused analog and digital pins...continued

Pin Type	Pin Function	Recommendation	Comments
Power	VSS_ANA	Always connect to VSS potential	Always connect to VSS potential
Power	VSS_USB	Always connect to VSS potential	Always connect to VSS potential
Analog/non-GPIO	ADC n_x	Float	
Analog/non-GPIO	ADC n_x /DAC n_{OUT}	Float	
Analog/non-GPIO	EXTAL	Float	
Analog/non-GPIO	XTAL	Float	Analog output - Float
Analog/non-GPIO	USB0_DP	Float	Float
Analog/non-GPIO	USB0_DM	Float	Float
GPIO/Analog	Px/ADC n_x	Float	Float (default is analog input)
GPIO/Analog	Px/CMP n_{INx}	Float	Float (default is analog input)
GPIO/Digital	JTAG_TCLK	Float	Float (default is JTAG with pulldown)
GPIO/Digital	JTAG_TDI	Float	Float (default is JTAG with pullup)
GPIO/Digital	JTAG_TDO	Float	Float (default is JTAG with pullup)
GPIO/Digital	JTAG_TMS	Float	Float (default is JTAG with pullup)
GPIO/Digital	Px	Float	Float (default is disabled)

7 Ordering parts

7.1 Determining valid orderable parts

Valid orderable part numbers are provided on the web. To determine the orderable part numbers for this device, go to [nxp.com](https://www.nxp.com) and perform a part number search for the following device numbers: MCXA346

Note: For complete list of Orderable part numbers, please refer [Table 1](#)

8 Part identification

Part numbers for the device have fields that identify the specific part. Use the values of these fields to determine the specific part.

8.1 Description

Part numbers for the chip have fields that identify the specific part. You can use the values of these fields to determine the specific part you have received.

8.2 Part number format

Part numbers for this device have the following format:

B PS F C D FS T PG SR PT

Table 49. Part number fields descriptions

Field	Description	Values
B	Brand	• MCX
PS	Product series name	• A
F	Family	• 3 = Mixed-signal
C	Core Features	• 4 = 180 MHz, MAU, 4x ADC, 2x Motor PWM, 6x UART, 1x CAN • 5 = 240 MHz, MAU, 4x ADC, 2x Motor PWM, 6x UART, 1x CAN • 6 = 240 MHz, MAU, 4x ADC, 2x Motor PWM, 6x UART, 2x CAN, I3C, USB, FlexIO, SLCD, Security
FS	Flash Size	• 1 = 32 KB • 2 = 64 KB • 3 = 128 KB • 4 = 256 KB • 5 = 512 KB • 6 = 1024 KB • 7 = 2 M
T	Junction Temperature range (°C)	• V = -40 to 125 °C
PG	Package	• LH = LQFP64 • LL = LQFP100 • LQ = LQFP144 • PN = WFBGA169
SR	Silicon Revision	• A = Initial Mask set • B = 1st Major spin • C = 2nd Major spin
PT	Package Type	• R = Tape and Reel • T = Tray

8.3 Example

This is an example part number:

MCXA346VLH

8.4 Small package marking

8.4.1 Package marking information

Table 50. Package Marking

Line	LQFP144	LQFP100	LQFP64	WFBGA169
First Line	AAAAAAAAAA	AAAAAAAAAA	AAAAAAA	AAAAA
Second Line	MMMMM	MMMMM	AAA MMMMM	MMMMM
Third Line	XXXXYYWWXX	XXXXYYWWXX	XXXXYYWWXX	XXXYWXX

Table 51. Package marking

Identifier	Description
A	Part number code, refer to Ordering Information
M	Mask set
Y	Year
W	Work week
X	NXP internal use

9 Terminology and guidelines

9.1 Definitions

Key terms are defined in the following table:

Table 52. Definitions

Term	Definition
Rating	A minimum or maximum value of a technical characteristic that, if exceeded, may cause permanent chip failure: • <i>Operating ratings</i> apply during operation of the chip. • <i>Handling ratings</i> apply when the chip is not powered. Note: The likelihood of permanent chip failure increases rapidly as soon as a characteristic begins to exceed one of its operating ratings.
Operating requirement	A specified value or range of values for a technical characteristic that you must guarantee during operation to avoid incorrect operation and possibly decreasing the useful life of the chip
Operating behavior	A specified value or range of values for a technical characteristic that are guaranteed during operation if you meet the operating requirements and any other specified conditions
Typical value	A specified value for a technical characteristic that: • Lies within the range of values specified by the operating behavior • Is representative of that characteristic during operation when you meet the typical-value conditions or other specified conditions Note: Typical values are provided as design guidelines and are neither tested nor guaranteed.

9.2 Examples

Operating rating:

Symbol	Description	Min.	Max.	Unit
V _{DD}	1.0 V core supply voltage	-0.3	1.2	V

Operating requirement:

Symbol	Description	Min.	Max.	Unit
V _{DD}	1.0 V core supply voltage	0.9	1.1	V

Operating behavior that includes a typical value:

Symbol	Description	Min.	Typ.	Max.	Unit
I _{WP}	Digital I/O weak pullup/pulldown current	10	70	130	μA

Figure 28. Examples

9.3 Typical-value conditions

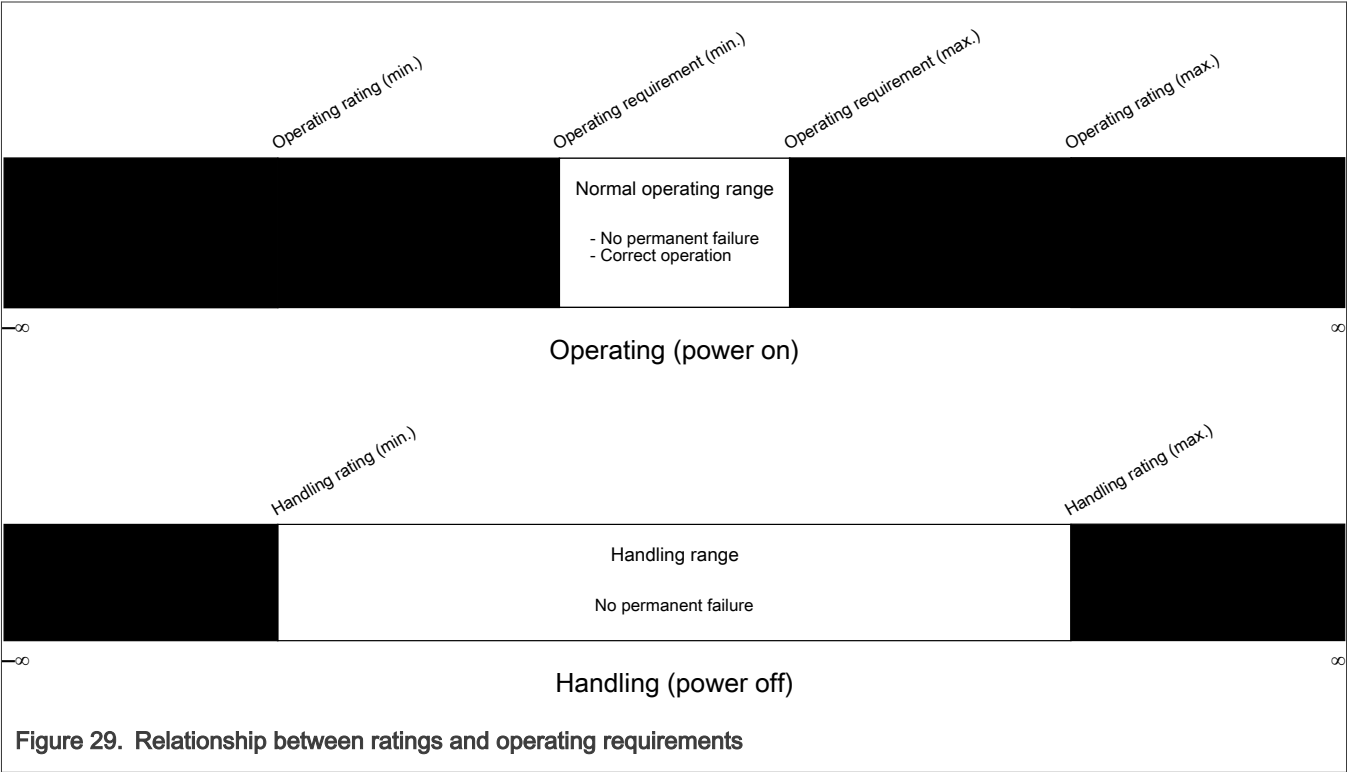
Typical values assume you meet the following conditions (or other conditions as specified):

Table 53. Typical-value conditions

Symbol	Description	Value	Unit
T _A	Ambient temperature	25	°C
V _{DD}	Supply voltage	3.3	V

Note: Typical values are based on characterization but not covered by test limits in production.

9.4 Relationship between ratings and operating requirements



9.5 Guidelines for ratings and operating requirements

Follow these guidelines for ratings and operating requirements:

- Never exceed any of the chip’s ratings.
- During normal operation, don’t exceed any of the chip’s operating requirements.
- If you must exceed an operating requirement at times other than during normal operation (for example, during power sequencing), limit the duration as much as possible.

9.6 Specification Test Methods

Each specification is tested using one of these methods.

Table 54. Specification test methods

Code	Method	Description
P	Production direct	On every chip during production, testing the specification
I	Production indirect	On every chip during production, testing parts of a module that affect whether the chip meets the specification but not testing the specification itself
C	Characterization on a production tester	Measuring a statistically significant number of sample chips across process (matrix lot), voltage, and temperature
L	Characterization on lab equipment or a nonproduction tester	

Table continues on the next page...

Table 54. Specification test methods...continued

Code	Method	Description
		Note: Typical values are not necessarily characterized across process.
D	Guaranteed by design	Specification based on scientific and engineering principles
O	Other	Using methods such as: • Performing silicon simulations • Performing package thermal simulations • Calculating specifications using reliability data

10 Revision History

The following table provides a revision history for this document.

Table 55. Revision History

Document ID	Release Date	Description
MCXAP144M240F60 v.5	10 February 2026	• Added two notes for the Block diagram • Updated descriptions about FlexPWM in Front matter • Updated the footnote of Table. Voltage and current operating behaviors • Removed Fclkout_1T and updated Δf_{clkout} in Table. FRO180M specifications • Updated ffro16k and Δf_{fro16k} in Table. FRO16K specifications
MCXAP144M240F60 v.4	14 November 2025	• Updated descriptions of FRO180M, Code Watchdog and CTimer in Section Features • Updated the Block diagram and bus matrix • Updated the front matter and feature comparison • Updated Related resources table and Ordering Information table • Added VDD_USB and VUSB0_Dx in Table Voltage and current maximum ratings • Updated the power consumption operating behaviours • Added I3C, FlexIO, USB and Segment LCD sections • Updated the part number field description table • Updated Device clock specifications • Added units in JTAG debug interface timing • Updated System Oscillator Crystal Specifications table • Updated Table. FRO180M specifications

Table continues on the next page...

Table 55. Revision History...continued

Document ID	Release Date	Description
		- Updated INL and DNL parameters of ADC electrical characteristics - Updated second reference of LP9 from slow speed to medium speed in LPSPI controller mode timing - Updated the condition of third instance of LP1 from Peripheral Rx to Peripheral Tx in OD mode in LPSPI peripheral mode timing - Updated the pinout table
MCXAP144M240F60 v.3	11 June 2025	- Updated the Block diagram - Updated the Bus Matrix figure - Added "K" to 500 of Nnvmcyc256k in Flash reliability specifications - Updated OpAmp electrical specifications - Removed leakage current for all pins in Voltage and current operating behaviours - Added Note in package diagram in front page "All information on the package WFBGA169 is preliminary and pending qualification."
MCXAP144M240F60 v.2	12 May 2025	- Updated MCXA165 and MCXA166 by MCXA345 and MCXA346 all over the document - Removed the part number list box in front matter - Updated TBDs in front matter - Updated Ordering Information - Removed the Note after block diagram - Updated Power Consumption operating behaviours table - Added I/O mux resistance table - Removed CT parameter from 12-bit DAC operating behaviors - Removed INL and DNL parameters for the power supply below 1.71V from Comparator and 8-bit DAC electrical specifications - Added figures of Comparator and 8-bit DAC electrical specifications - Updated I2C HS mode timing ES - Updated the maximum value of Tstart in System oscillator crystal electrical specifications - Added space between MCX and A to unify the device name and family in data sheet - Updated master to controller and slave to peripheral in LPSPI module to align with inclusive language - Removed ROM size from block diagram and bus architecture - Updated the values in Power mode transition operating behaviours table - Updated the values in Power consumption operating behaviours table

Table continues on the next page...

Table 55. Revision History...continued

Document ID	Release Date	Description
		• Updated Thermal attributes section • Removed Debug trace operating behaviours table • Updated the values of JTAG Debug Interface Timing • Added S4 and updated the other values in Serial Wire Debug (SWD) Timing specifications • Updated the operator in description of tpgmpg_lifetime for 128 B and tpgmphi_initial for 16 B in Flash command time specifications • Updated TBDs of Flash reliability specifications • Updated Op-amp to Opamp • Updated the values in LPSPI controller mode timing and LPSPI peripheral mode timing • Added FlexCAN description • Updated the pinout table • Removed I3C electrical specs • Updated comments in VDD_ANA in Recommended connection for unused analog and digital pins
MCXAP144M240F60 v.1.0	November 2024	• Initial version

Legal information

Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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Contents

1	Feature Comparison	8	4.4.1	ADC electrical specifications.....	35
2	Ratings.....	10	4.4.1.1	ADC operating conditions.....	35
2.1	Thermal handling ratings.....	11	4.4.1.2	I/O mux resistance table.....	35
2.2	Moisture handling ratings.....	11	4.4.1.3	ADC electrical characteristics.....	36
2.3	ESD handling ratings.....	11	4.4.2	12-bit DAC electrical characteristics.....	40
2.4	Voltage and current maximum ratings.....	11	4.4.2.1	12-bit DAC operating requirements.....	40
2.5	Required Power-On-Reset (POR) Sequencing	12	4.4.2.2	12-bit DAC operating behaviors.....	40
3	General.....	12	4.4.3	Comparator and 8-bit DAC electrical specifications.....	43
3.1	AC electrical characteristics.....	12	4.4.4	OpAmp electrical specifications.....	46
3.2	Nonswitching electrical specifications.....	12	4.5	Timers.....	47
3.2.1	Voltage and current operating requirement.....	13	4.6	Communication Interfaces	47
3.2.2	HVD, LVD, and POR operating requirements..	13	4.6.1	LPUART.....	47
3.2.2.1	VDD supply HVD, LVD, and POR Operating Requirements.....	14	4.6.2	LPSPi switching specifications	47
3.2.3	Voltage and current operating behaviors.....	14	4.6.2.1	LPSPi controller mode timing.....	48
3.2.4	On-chip regulator electrical specifications.....	15	4.6.2.2	LPSPi peripheral mode timing.....	50
3.2.4.1	LDO_CORE electrical specifications.....	15	4.6.3	I2C timing.....	53
3.2.5	Power mode transition operating behaviours...	16	4.6.4	I2C 1 Mbps timing.....	54
3.2.5.1	Power mode transition operating behaviors.....	16	4.6.5	I2C HS mode timing.....	55
3.2.6	Power consumption operating behaviors.....	16	4.6.6	I3C Push-Pull Timing Parameters for SDR Mode	56
3.2.6.1	Power consumption operating behaviors.....	16	4.6.7	USB Full-speed device electrical specifications	58
3.2.7	EMC radiated emissions operating behaviors..	20	4.6.8	Flexible I/O controller (FLEXIO) electrical specifications.....	59
3.2.8	Designing with radiated emissions in mind.....	20	4.6.9	FlexCAN.....	59
3.2.9	Capacitance attributes.....	21	4.7	Human Machine Interface (HMI) modules	59
3.3	Switching specifications.....	21	4.7.1	General Purpose Input/Output (GPIO).....	59
3.3.1	Device clock specs.....	21	4.7.2	Segment LCD electrical specification.....	59
3.3.2	General switching specifications.....	21	5	Package dimensions	60
3.3.2.1	General switching specifications.....	21	5.1	Obtaining package dimensions.....	60
3.4	Thermal specifications	23	6	Pinout	60
3.4.1	Thermal operating requirements.....	24	6.1	MCX A345, A346, A355, A356, A365 and A366 Signal Multiplexing and Pin Assignments.....	60
3.4.2	Thermal attributes.....	24	6.2	>MCX A345, A346, A355, A356, A365 and A366 Pinouts.....	88
4	Peripheral operating requirements and behaviors	24	6.3	Recommended connection for unused analog and digital pins.....	88
4.1	Core modules	24	7	Ordering parts.....	89
4.1.1	JTAG Debug Interface Timing.....	24	7.1	Determining valid orderable parts.....	89
4.1.2	Serial Wire Debug (SWD) Timing.....	26	8	Part identification.....	89
4.2	Clock modules	28	8.1	Description.....	89
4.2.1	Reference Oscillator Specification.....	28	8.2	Part number format.....	89
4.2.1.1	System Crystal Oscillator Specification.....	28	8.3	Example.....	90
4.2.1.2	System Oscillator Crystal Specifications.....	29	8.4	Small package marking.....	90
4.2.1.3	System Oscillator Crystal Specifications	29	8.4.1	Package marking information.....	91
4.2.2	FRO180M specifications.....	30	9	Terminology and guidelines.....	91
4.2.3	FRO12M specifications.....	31	9.1	Definitions.....	91
4.2.4	FRO16K specifications.....	32	9.2	Examples.....	92
4.3	Memories and memory interfaces	32	9.3	Typical-value conditions.....	92
4.3.1	Flash electrical specifications	32			
4.3.1.1	Timing specifications	32			
4.3.1.2	Flash high voltage current behavior.....	34			
4.3.1.3	Flash reliability specifications.....	34			
4.4	Analog	34			

9.4	Relationship between ratings and operating requirements.....	93	9.6	Specification Test Methods.....	93
9.5	Guidelines for ratings and operating requirements.....	93	10	Revision History.....	94
				Legal information.....	97

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